

# 56F8014

Data Sheet *Technical Data* 

**56F8000 16-bit Digital Signal Controllers** 

MC56F8014 Rev. 11 05/2008





## **Document Revision History**

Version History	Description of Change
Rev 0	Initial release
Rev 1	Updates to Part 10, Specifications, Table 10-1, added maximum clamp current, per pin Table 10-11, clarified variation over temperature table and graph Table 10-15, added LIN slave timing
Rev 2	Added alternate pins to Figure 11-1 and Table 11-1.
Rev 3	Corrected bit selects in Timer Channel 3 Input (TC3_INP) bit 9, Section 6.3.1.7, clarified Section 1.4.1, and simplified notes in Table 10-9,
Rev 4	Added clarification on sync inputs in <b>Section 1.4.1</b> , added voltage difference specification to <b>Table 10-1</b> and <b>Table 10-4</b> , deleted formula for Ambient Operating Temperature in <b>Table 10-4</b> , and a note for pin group 3, corrected <b>Table 8-1</b> , error in Port C peripheral function configuration, updated notes in <b>Table 10-9</b> . Added RoHs and "pb-free" language to back cover.
Rev 5	Updates to Section 10  Table 10-5, corrected max values for ADC Input Current High and Low; corrected typ value for pull-up disabled Digital Input Current Low (a)  Table 10-6, corrected typ and added max values for Standby > Stop and Powerdown modes  Table 10-7, corrected min value for Low-Voltage Interrupt for 3.3V  Table 10-11, corrected typ and max values and units for PLL lock time  Table 10-12, corrected typ values for Relaxation Oscillator output frequency and variation over temperature (also increased temp range to 150 degreesC) and added variation over temperature from 0—105 degreesC  Updated Figure 10-5  Table 10-19, updated max values for Integral Non-Linearity full input signal range, Negative Differential Non-Linearity, ADC internal clock, Offset Voltage Internal Ref, Gain Error and Offset Voltage External Ref; updated typ values for Negative Differential Non-Linearity, Offset Voltage Internal Ref, Gain Error and Offset Voltage External Ref; added new min values and corrected typ values for Signal-to-noise ratio, Total Harmonic Distortion, Spurious Free Dynamic Range, Signal-to-noise plus distortion, Effective Number of Bits
Rev 6	Added details to Section 1. Clarified language in State During Reset column in <b>Table 2-3</b> ; corrected flash data retention temperature in <b>Table 10-4</b> ; moved input current high/low to <b>Table 10-19</b> and location of footnotes in <b>Table 10-5</b> ; reorganized <b>Table 10-19</b> ; clarified title of <b>Figure 10-1</b> .
Rev. 7	<ul> <li>In Table 10-4, added an entry for flash data retention with less than 100 program/erase cycles (minimum 20 years).</li> <li>In Table 10-6, changed the device clock speed in STOP mode from 8MHz to 4MHz.</li> <li>In Table 10-12, changed the typical relaxation oscillator output frequency in Standby mode from 400kHz to 200kHz.</li> </ul>
Rev. 8	In Table 10-19, changed the maximum ADC internal clock frequency from 8MHz to 5.33MHz.



#### **Document Revision History (Continued)**

Version History	Description of Change
Rev. 9	Added the following note to the description of the TMS signal in <b>Table 2-3</b> : <b>Note:</b> Always tie the TMS pin to V <sub>DD</sub> through a 2.2K resistor.
Rev. 10	<ul> <li>In Table 2-3, changed V<sub>CAP</sub> value from 4.7 μF to 2.2 μF.</li> <li>In Table 2-3, changed the input type for FAULT3 (was "Output", is "Input").</li> <li>In Table 2-3, changed the input type for FAULT2 (was "Input/Output", is "Input").</li> <li>Revised Section 7, Security Features.</li> <li>Added MC56F8014MFAE to Section 13, Ordering Information.</li> <li>Fixed miscellaneous errors.</li> </ul>
Rev.11	Updated temperature information in Table 10-1 and Table 10-4.

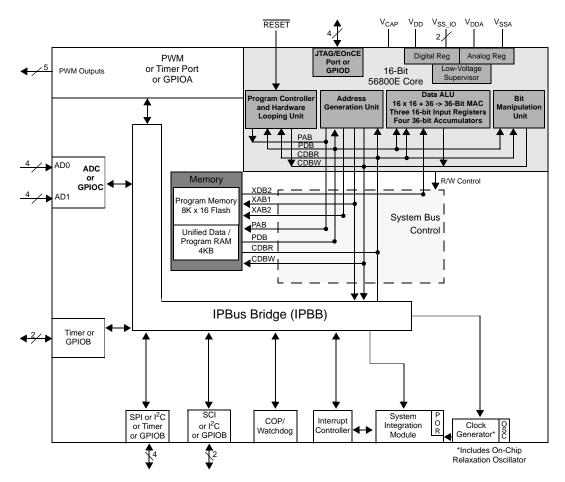
Please see http://www.freescale.com for the most current data sheet revision.



## 56F8014 General Description

- Up to 32 MIPS at 32MHz core frequency
- DSP and MCU functionality in a unified, C-efficient architecture
- 16KB Program Flash
- 4KB Unified Data/Program RAM
- One 5-channel PWM module
- Two 4-channel 12-bit ADCs
- One Serial Communication Interface (SCI) with LIN slave functionality
- One Serial Peripheral Interface (SPI)
- One 16-bit Quad Timer

- One Inter-Integrated Circuit (I<sup>2</sup>C) Port
- Computer Operating Properly (COP)/Watchdog
- On-Chip Relaxation Oscillator
- Integrated Power-On Reset and Low-Voltage Interrupt Module
- JTAG/Enhanced On-Chip Emulation (OnCE<sup>TM</sup>) for unobtrusive, real-time debugging
- Up to 26 GPIO lines
- 32-pin LQFP Package



56F8014 Block Diagram



## **56F8014 Data Sheet Table of Contents**

Part 1: Overview	Part 7: Security Features82
1.1. 56F8014 Features 6	7.1. Operation with Security Enabled 82
1.2. 56F8014 Description 8	7.2. Flash Access Lock and Unlock Mechanisms 83
1.3. Award-Winning Development Environment . 8	7.3. Product Analysis
1.4. Architecture Block Diagram 9	·
1.5. Synchronize ADC with PWM 9	Part 8: General Purpose Input/Output (GPIO)
1.6. Multiple Frequency PWM Output 9	
1.7. Product Documentation	8.1. Introduction
1.8. Data Sheet Conventions	8.2. Configuration
	8.3. Reset Values
Part 2: Signal/Connection Descriptions 14	o.o. Neset values
2.1. Introduction	Part 9: Joint Test Action Group (JTAG)91
2.2. 56F8014 Signal Pins	9.1. 56F8014 Information
Part 3: OCCS	Part 10: Specifications91
3.1. Overview	10.1. General Characteristics 91
3.2. Features	10.2. DC Electrical Characteristics
3.3. Operating Modes	10.3. AC Electrical Characteristics
3.4. Block Diagram	10.4. Flash Memory Characteristics
3.5. Pin Descriptions	10.5. External Clock Operation Timing
olor in Bosonphono IIII III 20	10.6. Phase Locked Loop Timing
Part 4: Memory Map29	10.7. Relaxation Oscillator Timing
4.1. Introduction	10.8. Reset, Stop, Wait, Mode Select, and
4.2. Interrupt Vector Table	
4.3. Program Map	Interrupt Timing
4.4. Data Map	10.9. Serial Peripheral Interface (SPI) Timing 102
4.5. EOnCE Memory Map	10.10. Quad Timer Timing
4.6. Peripheral Memory Mapped Registers 33	10.11. Serial Communication Interface (SCI)
4.0. I elipiteral Memory Mapped Registers 33	Timing
Part 5: Interrupt Controller (ITCN) 43	10.12. Inter-Integrated Circuit Interface (I2C)
5.1. Introduction	Timing
5.2. Features	10.13. JTAG Timing
5.3. Functional Description	10.14. Analog-to-Digital Converter (ADC)
5.4. Block Diagram	Parameters
5.5. Register Descriptions	10.15. Equivalent Circuit for ADC Inputs 112
5.6. Resets	10.16. Power Consumption
5.0. Resets	Dort 44: Dockovina
Part 6: System Integration Module (SIM)62	Part 11: Packaging115
6.1. Introduction	11.1. 56F8014 Package and Pin-Out
	Information
6.2. Features	Port 42: Penian Considerations 440
6.3. Register Descriptions	Part 12: Design Considerations
6.4. Clock Generation Overview	12.1. Thermal Design Considerations
6.5. Power-Down Modes	12.2. Electrical Design Considerations 119
6.6. Resets	Dent 40. On denium information 404
6.7. Clocks	Part 13: Ordering Information121
	Part 14: Annendix 122



#### Part 1 Overview

#### 1.1 56F8014 Features

#### 1.1.1 Digital Signal Controller Core

- Efficient 16-bit 56800E family Digital Signal Controller (DSC) engine with dual Harvard architecture
- As many as 32 Million Instructions Per Second (MIPS) at 32MHz core frequency
- Single-cycle 16 × 16-bit parallel Multiplier-Accumulator (MAC)
- Four 36-bit accumulators, including extension bits
- 32-bit arithmetic and logic multi-bit shifter
- Parallel instruction set with unique DSP addressing modes
- Hardware DO and REP loops
- Three internal address buses
- Four internal data buses
- Instruction set supports both DSP and controller functions
- Controller-style addressing modes and instructions for compact code
- Efficient C compiler and local variable support
- Software subroutine and interrupt stack with depth limited only by memory
- JTAG/Enhanced On-Chip Emulation (OnCE) for unobtrusive, processor speed-independent, real-time debugging

#### **1.1.2 Memory**

- Dual Harvard architecture permits as many as three simultaneous accesses to program and data memory
- Flash security and protection that prevent unauthorized users from gaining access to the internal Flash
- On-chip memory
  - 16KB of Program Flash
  - 4KB of Unified Data/Program RAM
- EEPROM emulation capability using Flash

#### 1.1.3 Peripheral Circuits for 56F8014

- One multi-function five-output Pulse Width Modulator (PWM) module
  - Up to 96MHz PWM operating clock
  - 15 bits of resolution
  - Center-aligned and Edge-aligned PWM signal mode
  - Three programmable fault inputs with programmable digital filter
  - Double-buffered PWM registers



- Each complementary PWM signal pair can output a different switching frequency by selecting PWM generation sources from:
  - PWM generator
  - External GPIO
  - Internal timers
  - ADC conversion result of over/under limits:
     When conversion result is greater than high limit, deactivate PWM signal
     When conversion result is less than low limit, activate PWM signal
- Two independent 12-bit Analog-to-Digital Converters (ADCs)
  - 2 x 4 channel inputs
  - Supports both simultaneous and sequential conversions
  - ADC conversions can be synchronized by both PWM and timer modules
  - Sampling rate up to 2.67MSPS
  - 8-word result buffer registers
  - ADC Smart Power Management (Auto-standby, auto-powerdown)
- One 16-bit multi-purpose Quad Timer module (TMR)
  - Up to 96MHz operating clock
  - Four independent 16-bit counter/timers with cascading capability
  - Each timer has capture and compare capability
  - Up to 12 operating modes
- One Serial Communication Interface (SCI) with LIN slave functionality
  - Full-duplex or single-wire operation
  - Two receiver wake-up methods:
    - Idle line
    - Address mark
- One Serial Peripheral Interface (SPI)
  - Full-duplex operation
  - Master and slave modes
  - Programmable length transactions (two to sixteen bits)
- One Inter-Integrated Circuit (I<sup>2</sup>C) port
  - Operates up to 400 kbps
  - Supports both master and slave operation
- Computer Operating Properly (COP)/Watchdog timer capable of selecting different clock sources
- Up to 26 General-Purpose I/O (GPIO) pins with 5V tolerance
- Integrated Power-On Reset and Low-Voltage Interrupt Module
- Phase Lock Loop (PLL) provides a high-speed clock to the core and peripherals
- Clock Sources:
  - On-chip relaxation oscillator



- External clock source
- On-chip regulators for digital and analog circuitry to lower cost and reduce noise
- JTAG/EOnCE debug programming interface for real-time debugging

#### 1.1.4 Energy Information

- Fabricated in high-density CMOS with 5V-tolerant, TTL-compatible digital inputs
- On-chip regulators for digital and analog circuitry to lower cost and reduce noise
- Wait and Stop modes available
- ADC smart power management
- Each peripheral can be individually disabled to save power

#### 1.2 56F8014 Description

The 56F8014 is a member of the 56800E core-based family of Digital Signal Controllers (DSCs). It combines, on a single chip, the processing power of a DSP and the functionality of a microcontroller with a flexible set of peripherals to create an extremely cost-effective solution. Because of its low cost, configuration flexibility, and compact program code, the 56F8014 is well-suited for many applications. The 56F8014 includes many peripherals that are especially useful for industrial control, motion control, home appliances, general purpose inverters, smart sensors, fire and security systems, switched-mode power supplies, power management, and medical monitoring applications.

The 56800E core is based on a dual Harvard-style architecture consisting of three execution units operating in parallel, allowing as many as six operations per instruction cycle. The MCU-style programming model and optimized instruction set allow straightforward generation of efficient, compact DSP and control code. The instruction set is also highly efficient for C compilers to enable rapid development of optimized control applications.

The 56F8014 supports program execution from internal memories. Two data operands can be accessed from the on-chip data RAM per instruction cycle. The 56F8014 also offers up to 26 General Purpose Input/Output (GPIO) lines, depending on peripheral configuration.

The 56F8014 Digital Signal Controller includes 16KB of Program Flash and 4KB of Unified Data/Program RAM. Program Flash memory can be independently bulk erased or erased in pages. Program Flash page erase size is 512 Bytes/256 Words.

A full set of programmable peripherals—PWM, ADCs, SCI, SPI, I<sup>2</sup>C, Quad Timer—support various applications. Each peripheral can be independently shut down to save power. Any pin in these peripherals can also be used as a General Purpose Input/Outputs (GPIO).

#### 1.3 Award-Winning Development Environment

Processor Expert<sup>TM</sup> (PE) provides a Rapid Application Design (RAD) tool that combines easy-to-use component-based software application creation with an expert knowledge system.

The CodeWarrior Integrated Development Environment is a sophisticated tool for code navigation, compiling, and debugging. A complete set of evaluation modules (EVMs), demonstration board kit and development system cards will support concurrent engineering. Together, PE, CodeWarrior and EVMs



create a complete, scalable tools solution for easy, fast, and efficient development.

#### 1.4 Architecture Block Diagram

The 56F8014's architecture is shown in **Figure 1-1**, **Figure 1-2**, and **Figure 1-3**. **Figure 1-1** illustrates how the 56800E system buses communicate with internal memories and the IPBus Bridge, as well as showing the internal connections between each unit of the 56800E core. **Figure 1-2** shows the peripherals and control blocks connected to the IPBus Bridge. **Figure 1-3** details how the device's I/O pins are muxed. The figures do not show the on-board regulator and power and ground signals. They also do not show the multiplexing between peripherals or the dedicated GPIOs. Please see **Part 2 Signal/Connection Descriptions** to see which signals are multiplexed with those of other peripherals.

#### 1.5 Synchronize ADC with PWM

ADC conversion can be synchronized with the PWM module via Quad Timer channel 2 and 3 if needed. Internally, the PWM synch signal — which is generated at every PWM reload —can be connected to the timer channel 3 input, and the timer channel 2 and channel 3 outputs are connected to the ADC sync inputs. Timer channel 3 output is connected to SYNC0 and timer channel 2 is connected to SYNC1. The setting is controlled by the TC3\_INP bit in the SIM Control Register; see Section 6.3.1.

SYNC0 is the master ADC sync input, used to trigger both ADCA and ADCB in sequence and parallel mode. SYNC1 is used to trigger ADCB in parallel independent mode, while SYNC0 is used to trigger ADCA. See *MC56F8000RM*, the 56F801X Peripheral Reference Manual, for additional information.

#### 1.6 Multiple Frequency PWM Output

When both PWM channels of a complementary pair in software control mode and software control bits are set to 1, each complementary PWM signal pair — PWM 0 and 1; PWM 2 and 3; and PWM 4 and 5 — can select a PWM source from one of the following sources. This will enable each PWM pair and PWM2 to output PWM signals at different frequencies.

- External GPIO input:
  - GPIOB2 input can be used to drive PWM 0 and 1
  - GPIOB3 input can be used to drive PWM 2
  - GPIOB4 input can be used to drive PWM 4 and 5
- Quad Timer output:
  - Timer0 output can be used to drive PWM 0 and 1
  - Timer2 output can be used to drive PWM 2
  - Timer3 output can be used to drive PWM 4 and 5
- ADC conversion result:
  - Signal of over/under limit of ADC sample 0 can be used to drive PWM 0 and 1
  - Signal of over/under limit of ADC sample 1 can be used to drive PWM 2



Signal of over/under limit of ADC sample 2 can be used to drive PWM 4 and 5

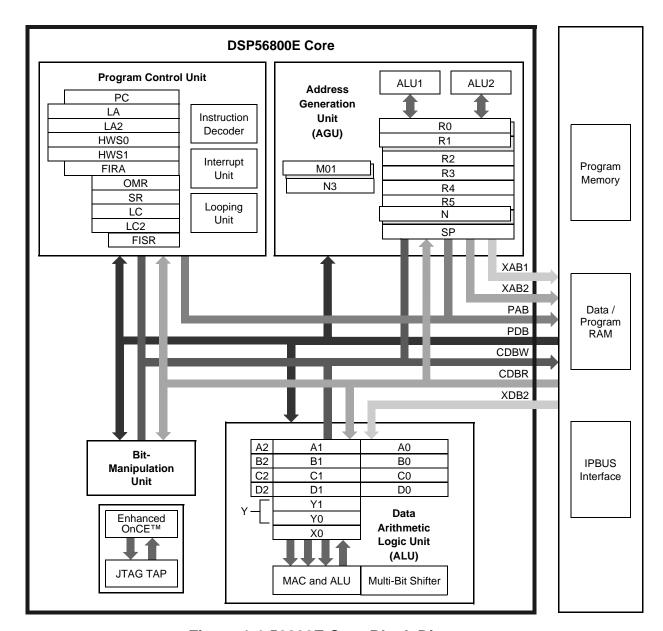


Figure 1-1 56800E Core Block Diagram



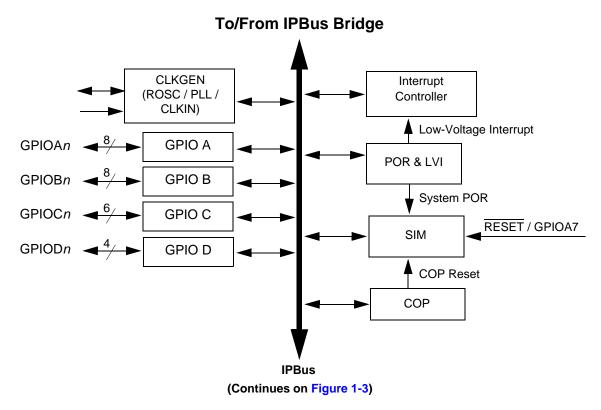


Figure 1-2 Peripheral Subsystem



#### (Continued from Figure 1-2)

#### To/From IPBus Bridge

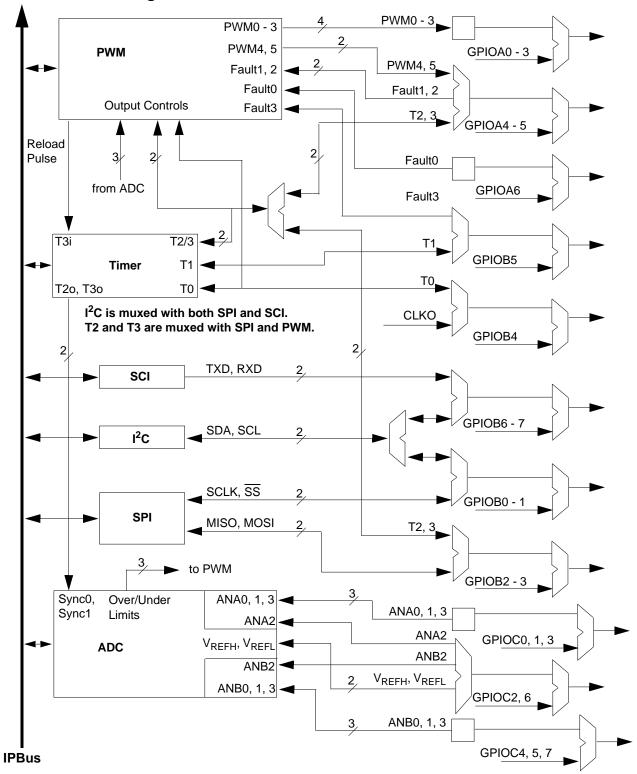


Figure 1-3 56F8014 Peripheral I/O Pin-Out

56F8014 Technical Data, Rev. 11



#### 1.7 Product Documentation

The documents listed in **Table 1-1** are required for a complete description and proper design with the 56F8014. Documentation is available from local Freescale distributors, Freescale Semiconductor sales offices, Freescale Literature Distribution Centers, or online at:

http://www.freescale.com

Table 1-1 56F8014 Chip Documentation

Topic	Description	Order Number
DSP56800E Reference Manual	Detailed description of the 56800E family architecture, 16-bit Digital Signal Controller core processor, and the instruction set	DSP56800ERM
56F801X Peripheral Reference Manual	Detailed description of peripherals of the 56F801X family of devices	MC56F8000RM
56F801x Serial Bootloader User Guide	Detailed description of the Serial Bootloader in the 56F801x family of devices	56F801xBLUG
56F8014 Technical Data Sheet	Electrical and timing specifications, pin descriptions, and package descriptions (this document)	MC56F8014
56F8014 Errata	Details any chip issues that might be present	MC56F8014E

#### 1.8 Data Sheet Conventions

This data sheet uses the following conventions:

OVERBAR

This is used to indicate a signal that is active when pulled low. For example, the RESET pin is

active when low.

"asserted" A high true (active high) signal is high or a low true (active low) signal is low.

"deasserted" A high true (active high) signal is low or a low true (active low) signal is high.

Examples:	Signal/Symbol	Logic State	Signal State	Voltage <sup>1</sup>
	PIN	True	Asserted	$V_{IL}/V_{OL}$
	PIN	False	Deasserted	$V_{IH}/V_{OH}$
	PIN	True	Asserted	$V_{IH}/V_{OH}$
	PIN	False	Deasserted	V <sub>II</sub> /V <sub>OI</sub>

<sup>1.</sup> Values for  $V_{IL}$ ,  $V_{OL}$ ,  $V_{IH}$ , and  $V_{OH}$  are defined by individual product specifications.



## Part 2 Signal/Connection Descriptions

#### 2.1 Introduction

The input and output signals of the 56F8014 are organized into functional groups, as detailed in **Table 2-1**. **Table 2-2** summarizes all device pins. In **Table 2-2**, each table row describes the signal or signals present on a pin, sorted by pin number.

**Table 2-1 Functional Group Pin Allocations** 

Functional Group	Number of Pins
Power (V <sub>DD</sub> or V <sub>DDA</sub> )	2
Ground (V <sub>SS</sub> or V <sub>SSA</sub> )	3
Supply Capacitors	1
Reset	1
Pulse Width Modulator (PWM) Ports <sup>1</sup>	5
Serial Peripheral Interface (SPI) Ports <sup>2</sup>	4
Analog-to-Digital Converter (ADC) Ports	8
Timer Module Ports <sup>3</sup>	2
Serial Communications Interface (SCI) Ports <sup>4</sup>	2
JTAG/Enhanced On-Chip Emulation (EOnCE)	4

<sup>1.</sup> Pins in this section can function as TMR and GPIO.

<sup>2.</sup> Pins in this section can function as TMR, I<sup>2</sup>C, and GPIO.

<sup>3.</sup> Pins can function as PWM and GPIO.

<sup>4.</sup> Pins in this section can function as I<sup>2</sup>C and GPIO.



#### **Table 2-2 56F8014 Pins**

			Peripherals:									
LQFP Pin#	Pin Name	Signal Name	GPIO	I2C	SCI	SPI	ADC	PWM	Quad Timer	Power & Ground	JTAG	Misc.
1	GPIOB1	GPIOB1, SS, SDA	B1	SDA		SS						
2	GPIOB7	GPIOB7, TXD, SCL	В7	SCL	TXD							
3	GPIOB5	GPIOB5, T1, FAULT3	B5					FAULT3	T1			
4	ANB0	ANB0, GPIOC4	C4				ANB0					
5	ANB1	ANB1, GPIOC5	C5				ANB1					
6	ANB2	ANB2, V <sub>REFL</sub> , GPIOC6	C6				ANB2, V <sub>REFL</sub>					
7	ANB3	ANB3, GPIOC7	C7				ANB3					
8	VDDA	$V_{DDA}$								V <sub>DDA</sub>		
9	VSSA	V <sub>SSA</sub>								V <sub>SSA</sub>		
10	ANA3	ANA3, GPIOC3	C3				ANA3					
11	ANA2	ANA2, V <sub>REFH</sub> , GPIOC2	C2				ANA2, V <sub>REFH</sub>					
12	ANA1	ANA1, GPIOC1	C1				ANA1					
13	ANA0	ANA0, GPIOC0	C0				ANA0					
14	VSS_IO	V <sub>SS_IO</sub>								V <sub>SS_IO</sub>		
15	тск	TCK, GPIOD2	D2								TCK	
16	RESET	RESET, GPIOA7	A7									RESET
17	GPIOB3	GPIOB3, MOSI, T3	В3			MOSI			Т3			
18	GPIOB2	GPIOB2, MISO, T2	B2			MISO			T2			
19	GPIOB4	GPIOB4, T0, CLKO	В4						T0			CLKO
20	GPIOA5	GPIOA5, PWM5, FAULT2, T3	A5					PWM5, FAULT2	Т3			
21	GPIOB0	GPIOB0, SCLK, SCL	В0	SCL		SCLK						
22	GPIOA4	GPIOA4, PWM4, FAULT1, T2	A4					PWM4, FAULT1	T2			
23	GPIOA2	GPIOA2, PWM2	A2					PWM2				
24	VCAP	V <sub>CAP</sub>								V <sub>CAP</sub>		



### Table 2-2 56F8014 Pins (Continued)

			Peripherals:									
LQFP Pin #	Pin Name	Signal Name	GPIO	I2C	SCI	SPI	ADC	PWM	Quad Timer	Power & Ground	JTAG	Misc.
25	VDD_IO	$V_{DD\_IO}$								$V_{DD\_IO}$		
26	VSS_IO	V <sub>SS_IO</sub>								V <sub>SS_IO</sub>		
27	GPIOA1	GPIOA1, PWM1	A1					PWM1				
28	GPIOA0	GPIOA0, PWM0	A0					PWM0				
29	TDI	TDI, GPIOD0	D0								TDI	
30	TMS	TMS, GPIOD3	D3								TMS	
31	TDO	TDO, GPIOD1	D1								TDO	
32	GPIOB6	GPIOB6, RXD, SDA, CLKIN	В6	SDA	RXD							CLKIN



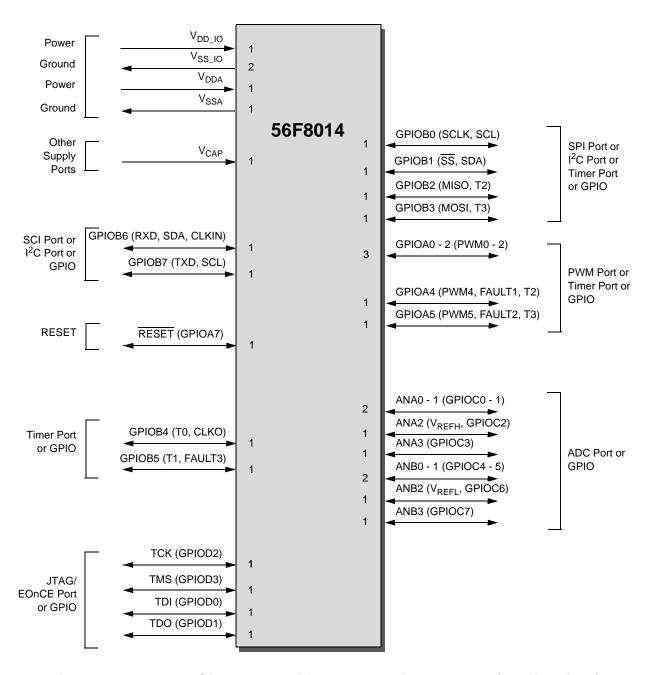


Figure 2-1 56F8014 Signals Identified by Functional Group (32-Pin LQFP)



## 2.2 56F8014 Signal Pins

After reset, each pin is configured for its primary function (listed first). Any alternate functionality must be programmed.

Table 2-3 56F8014 Signal and Package Information for the 32-Pin LQFP

Signal Name	LQFP Pin No.	Туре	State During Reset	Signal Description
V <sub>DD_IO</sub>	25	Supply	Supply	I/O Power — This pin supplies 3.3V power to the chip I/O interface.
V <sub>SS_IO</sub>	14	Supply	Supply	V <sub>SS</sub> — These pins provide ground for chip logic and I/O drivers.
V <sub>SS_IO</sub>	26			
V <sub>DDA</sub>	8	Supply	Supply	ADC Power — This pin supplies 3.3V power to the ADC modules. It must be connected to a clean analog power supply.
V <sub>SSA</sub>	9	Supply	Supply	ADC Analog Ground — This pin supplies an analog ground to the ADC modules.
V <sub>CAP</sub>	24	Supply	Supply	$V_{CAP}$ — Connect a 2.2 μF or greater bypass capacitor between this pin and VSS_IO, which is required by the internal voltage regulator for proper chip operation. See <b>Section 10.2.1</b> .
GPIOB6	32	Input/ Output	Input with internal pull-up	Port B GPIO — This GPIO pin can be individually programmed as an input or output pin.
(RXD)		Input	enabled	Receive Data — SCI receive data input.
(SDA <sup>1</sup> )		Input/ Output		<b>Serial Data</b> — This pin serves as the I <sup>2</sup> C serial data line.
(CLKIN)		Input		Clock Input — This pin serves as an optional external clock input.
				After reset, the default state is GPIOB6. The alternative peripheral functionality is controlled via the SIM (See Section 6.3.8) and the CLKMODE bit of the OCCS Oscillator Control Register.

<sup>1.</sup> This signal is also brought out on the GPIOB1 pin.

Return to Table 2-2



Table 2-3 56F8014 Signal and Package Information for the 32-Pin LQFP (Continued)

<u> </u>		<del></del>	
- 5	LQFP Type State During Reset S	IVNE	Signal Description
GPIOB7	2 Input/ Output Input with internal pull-up enabled Port B GPIO — This GPI an input or output pin.	Output internation	<b>Port B GPIO</b> — This GPIO pin can be individually programmed as an input or output pin.
(TXD)		Input/	<b>Transmit Data</b> — SCI transmit data output or transmit / receive in single wire opeation.
(SCL <sup>2</sup> )	Input/ Output  Serial Clock — This pin s		<b>Serial Clock</b> — This pin serves as the I <sup>2</sup> C serial clock.
			After reset, the default state is GPIOB7. The alternative peripheral functionality is controlled via the SIM. See <b>Section 6.3.8</b> .
This signal is	also brought out on the GPIOB0 pin.	ught out on the GPIOB	
RESET	internal When RESET is asserted pull-up reset state. A Schmitt trig enabled internal reset signal will be	interna pull-u	Reset — This input is a direct hardware reset on the processor. When RESET is asserted low, the chip is initialized and placed in the reset state. A Schmitt trigger input is used for noise immunity. The internal reset signal will be deasserted synchronous with the internal clocks after a fixed number of internal clocks.
(GPIOA7)	Drain Output an input or open drain our disabled in this mode and reset, or software reset.	Drain	<u></u>
	After reset, the default sta		After reset, the default state is RESET.
GPIOB4	Output internal an input or output pin. pull-up	Output internation	Port B GPIO — This GPIO pin can be individually programmed as an input or output pin.
(T0)	Input/ Output  T0 — Timer, Channel 0	Input/	T0 — Timer, Channel 0
(CLKO)	SIM_CLKO Select Regist programmed as any of the (system clock), IPBus clo  After reset, the default sta	Output	Clock Output — This is a buffered clock signal. Using the SIM_CLKO Select Register (SIM_CLKOSR), this pin can be programmed as any of the following: disabled (logic 0), CLK_MSTR (system clock), IPBus clock, or oscillator output. See Section 6.3.7.  After reset, the default state is GPIOB4. The alternative peripheral functionality is controlled via the SIM_See Section 6.3.8.
	Input/ Output  Output  Clock Output — This is a SIM_CLKO Select Regist programmed as any of the (system clock), IPBus clo  After reset, the default sta	Input/ Output	Clock Output — This is a buffered clock signal. Using SIM_CLKO Select Register (SIM_CLKOSR), this pin caprogrammed as any of the following: disabled (logic 0), (system clock), IPBus clock, or oscillator output. See S



Table 2-3 56F8014 Signal and Package Information for the 32-Pin LQFP (Continued)

Signal Name	LQFP Pin No.	Туре	State During Reset	Signal Description
GPIOB5	3	Input/ Output	Input with internal pull-up enabled	Port B GPIO — This GPIO pin can be individually programmed as an input or output pin.
(T1)		Input/ Output	enabled	<b>T1</b> — Timer, Channel 1
(FAULT3)		Input		<b>FAULT3</b> — This fault input pin is used for disabling selected PWM outputs in cases where fault conditions originate off-chip.
				After reset, the default state is GPIOB5. The alternative peripheral functionality is controlled via the SIM. See <b>Section 6.3.8</b> .
тск	15	Input	Input with internal pull-up enabled	<b>Test Clock Input</b> — This input pin provides a gated clock to synchronize the test logic and shift serial data to the JTAG/EOnCE port. The pin is connected internally to a pull-up resistor. A Schmitt trigger input is used for noise immunity.
(GPIOD2)		Input/ Output		<b>Port D GPIO</b> — This GPIO pin can be individually programmed as an input or output pin.
				After reset, the default state is TCK.
TMS	30	Input	Input with internal pull-up enabled	<b>Test Mode Select Input</b> — This input pin is used to sequence the JTAG TAP controller's state machine. It is sampled on the rising edge of TCK and has an on-chip pull-up resistor.
(GPIOD3)		Input/ Output	enabled	<b>Port D GPIO</b> — This GPIO pin can be individually programmed as an input or output pin.
				After reset, the default state is TMS.
				<b>Note:</b> Always tie the TMS pin to $V_{DD}$ through a 2.2K resistor if this pin is configured as TMS.
TDI	29	Input	Input with internal pull-up enabled	<b>Test Data Input</b> — This input pin provides a serial input data stream to the JTAG/EOnCE port. It is sampled on the rising edge of TCK and has an on-chip pull-up resistor.
(GPIOD0)		Input/ Output	enabled	<b>Port D GPIO</b> — This GPIO pin can be individually programmed as an input or output pin.
				After reset, the default state is TDI.



Table 2-3 56F8014 Signal and Package Information for the 32-Pin LQFP (Continued)

Signal Name	LQFP Pin No.	Туре	State During Reset	Signal Description
TDO	31	Output	Output	<b>Test Data Output</b> — This tri-stateable output pin provides a serial output data stream from the JTAG/EOnCE port. It is driven in the shift-IR and shift-DR controller states, and changes on the falling edge of TCK.
(GPIOD1)		Input/ Output		<b>Port D GPIO</b> — This GPIO pin can be individually programmed as an input or output pin.
				After reset, the default state is TDO.
GPIOB0	21	Input/ Output	Input with internal pull-up enabled	Port B GPIO — This GPIO pin can be individually programmed as an input or output pin.
(SCLK)		Input/ Output	enabled	SPI Serial Clock — In the master mode, this pin serves as an output, clocking slaved listeners. In slave mode, this pin serves as the data clock input. A Schmitt trigger input is used for noise immunity.
(SCL <sup>3</sup> )		Input/ Output		Serial Data — This pin serves as the I <sup>2</sup> C serial clock.
				After reset, the default state is GPIOB0. The alternative peripheral functionality is controlled via the SIM. See Section 6.3.8.
3. This signal	is also bro	ought out on	the GPIOB7 pin	l.
GPIOB1	1	Input/ Output	Input with internal pull-up enabled	Port B GPIO — This GPIO pin can be individually programmed as an input or output pin.
(SS)		Input	Chabica	SPI Slave Select — $\overline{\rm SS}$ is used in slave mode to indicate to the SPI module that the current transfer is to be received.
(SDA <sup>4</sup> )		Input/ Output		Serial Clock — This pin serves as the I <sup>2</sup> C serial data line.
		·		After reset, the default state is GPIOB1. The alternative peripheral functionality is controlled via the SIM. See Section 6.3.8.



Table 2-3 56F8014 Signal and Package Information for the 32-Pin LQFP (Continued)

Signal Name	LQFP Pin No.	Туре	State During Reset	Signal Description	
GPIOB2	18	Input/ Output	Input with internal pull-up enabled	Port B GPIO — This GPIO pin can be individually programmed as an input or output pin.	
(MISO)		Input/ Output	0.000	SPI Master In/Slave Out — This serial data pin is an input to a master device and an output from a slave device. The MISO line of a slave device is placed in the high-impedance state if the slave device is not selected. The slave device places data on the MISO line a half-cycle before the clock edge the master device uses to latch the data.	
(T2 <sup>5</sup> )		Input/ Output		<b>T2</b> — Timer, Channel 2	
				After reset, the default state is GPIOB2. The alternative peripheral functionality is controlled via the SIM. See <b>Section 6.3.8</b> .	
5. This signal	5. This signal is also brought out on the GPIOA4 pin.				
GPIOB3	17	Input/ Output	Input with internal pull-up enabled	<b>Port B GPIO</b> — This GPIO pin can be individually programmed as an input or output pin.	
(MOSI)		Input/ Output	enabled	SPI Master Out/Slave In— This serial data pin is an output from a master device and an input to a slave device. The master device places data on the MOSI line a half-cycle before the clock edge the slave device uses to latch the data.	
(T3 <sup>6</sup> )		Input/ Output		T3 — Timer, Channel 3	
		Output		After reset, the default state is GPIOB3. The alternative peripheral functionality is controlled via the SIM. See Section 6.3.8.	
6. This signal	is also bro	ought out on	the GPIOA5 pin		
GPIOA0	28	Input/ Output	Input with internal pull-up	Port A GPIO — This GPIO pin can be individually programmed as an input or output pin.	
(PWM0)		Output	enabled	<b>PWM0</b> — This is one of the six PWM output pins.	
				After reset, the default state is GPIOA0.	



Table 2-3 56F8014 Signal and Package Information for the 32-Pin LQFP (Continued)

Signal Name	LQFP Pin No.	Туре	State During Reset	Signal Description
GPIOA1	27	Input/ Output	Input with internal pull-up enabled	Port A GPIO — This GPIO pin can be individually programmed as an input or output pin.
(PWM1)		Output	enabled	PWM1 — This is one of the six PWM output pins.
				After reset, the default state is GPIOA1.
GPIOA2	23	Input/ Output	Input with internal pull-up enabled	Port A GPIO — This GPIO pin can be individually programmed as an input or output pin.
(PWM2)		Output	enabled	PWM2 — This is one of the six PWM output pins.
				After reset, the default state is GPIOA2.
GPIOA4	22	Input/ Output	Input with internal pull-up	Port A GPIO — This GPIO pin can be individually programmed as an input or output pin.
(PWM4)		Output	enabled	PWM4 — This is one of the six PWM output pins.
(FAULT1)		Input		Fault1 — This fault input pin is used for disabling selected PWM outputs in cases where fault conditions originate off-chip.
(T2 <sup>7</sup> )		Input/ Output		T2 — Timer, Channel 2
		Output		After reset, the default state is GPIOA4. The alternative peripheral functionality is controlled via the SIM. See Section 6.3.8.
7. This signal	is also bro	ought out on	the GPIOB2 pin	
GPIOA5	20	Input/ Output	Input with internal pull-up enabled	Port A GPIO — This GPIO pin can be individually programmed as an input or output pin.
(PWM5)		Output	Chablea	PWM5 — This is one of the six PWM output pins.
(FAULT2)		Input		Fault2 — This fault input pin is used for disabling selected PWM outputs in cases where fault conditions originate off-chip.
(T3 <sup>8</sup> )		Input/		T3 — Timer, Channel 3
		Output		After reset, the default state is GPIOA5. The alternative peripheral functionality is controlled via the SIM. See Section 6.3.8.



Table 2-3 56F8014 Signal and Package Information for the 32-Pin LQFP (Continued)

Signal Name	LQFP Pin No.	Туре	State During Reset	Signal Description	
ANA0	13	Input	Analog Input	ANA0 — Analog input to ADC A, channel 0	
(GPIOC0)		Input/ Output		Port C GPIO — This GPIO pin can be individually programmed as an input or output pin.	
				After reset, the default state is ANA0.	
ANA1	12	Input	Analog Input	ANA1 — Analog input to ADC A, channel 1	
(GPIOC1)		Input/ Output		Port C GPIO — This GPIO pin can be individually programmed as an input or output pin.	
				After reset, the default state is ANA1.	
ANA2	11	Input	Analog Input	ANA2 — Analog input to ADC A, channel 2	
(V <sub>REFH</sub> )		Input		V <sub>REFH</sub> — Analog reference voltage high	
(GPIOC2)		Input/ Output		Port C GPIO — This GPIO pin can be individually programmed as an input or output pin.	
				After reset, the default state is ANA2.	
ANA3	10	Input	Analog	ANA3 — Analog input to ADC A, channel 3	
(GPIOC3)		Input/ Output	Input	Port C GPIO — This GPIO pin can be individually programmed as an input or output pin.	
				After reset, the default state is ANA3.	
ANB0	4	Input	Analog Input	ANB0 — Analog input to ADC B, channel 0	
(GPIOC4)		Input/ Output		Port C GPIO — This GPIO pin can be individually programmed as an input or output pin.	
				After reset, the default state is ANB0.	



Table 2-3 56F8014 Signal and Package Information for the 32-Pin LQFP (Continued)

Signal Name	LQFP Pin No.	Туре	State During Reset	Signal Description
ANB1	5	Input	Analog Input	ANB1 — Analog input to ADC B, channel 1
(GPIOC5)		Input/ Output		Port C GPIO — This GPIO pin can be individually programmed as an input or output pin.
				After reset, the default state is ANB1.
ANB2	6	Input	Analog Input	ANB2 — Analog input to ADC B, channel 2
(V <sub>REFL</sub> )		Input		<b>V</b> <sub>REFL</sub> — Analog reference voltage low. This should normally be connected to a low-noise V <sub>SS</sub> .
(GPIOC6)		Input/ Output		Port C GPIO — This GPIO pin can be individually programmed as an input or output pin.
				After reset, the default state is ANB2.
ANB3	7	Input	Analog	ANB3 — Analog input to ADC B, channel 3
(GPIOC7)		Input/ Output	Input	Port C GPIO — This GPIO pin can be individually programmed as an input or output pin.
				After reset, the default state is ANB3.



#### Part 3 OCCS

#### 3.1 Overview

This module provides the system clock, which uses it to generate the various chip clocks. This module also produces the oscillator clock signals, plus the ADC clock and high-speed peripheral clock.

The on-chip clock synthesis module allows product design using an internal relaxation oscillator to run 56F801X family parts at user-selectable frequencies up to 32MHz.

#### 3.2 Features

The On-Chip Clock Synthesis (OCCS) module interfaces to the oscillator and PLL. The OCCS module features:

- Internal relaxation oscillator
- Ability to power down the internal relaxation oscillator
- Ability to put the internal relaxation oscillator into a standby mode
- 3-bit postscaler provides control for the PLL output
- Ability to power down the internal PLL
- Provides 2X system clock frequency, which operates at twice the system clock, to the System Integration Module (SIM) that is used to generate the various device clocks
- Provides 3X system clock, which operates at three times the system clock, to PWM and Timer
- Safety shutdown feature is available in the event that the PLL reference clock disappears
- Can be driven from an external clock source

The clock generation module provides the programming interface for both the PLL and internal relaxation oscillator.

#### 3.3 Operating Modes

In 56F801X family parts, either an internal oscillator or an external frequency source can be used to provide a reference clock to the SIM.

The 2X system clock source output from the OCCS can be described by one of the following equations:

```
2X system frequency = oscillator frequency
```

2X system frequency = (oscillator frequency X 8) / (postscaler)

where:

```
postscaler = 1, 2, 4, 8, 16, or 32 PLL output divider
```

The SIM is responsible for further dividing these frequencies by two, which will insure a 50% duty cycle in the system clock output.



The 56F801X family parts' on-chip clock synthesis module has the following registers:

- Control Register (OCCS\_CR)
- Divide-by Register (OCCS\_DB)
- Status Register (OCCS\_SR)
- Shutdown Register (OCCS\_SHUTDN)
- Oscillator Control Register (OCCS\_OCTRL)

For more information on these registers, please refer to the 56F801X Peripheral Reference Manual.

#### 3.3.1 External Clock Source

The recommended method of connecting an external clock is illustrated in **Figure 3-1.** The external clock source is connected to GPIOB6 / RXD / SDA / CLKIN.

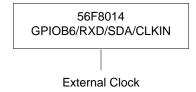


Figure 3-1 Connecting an External Clock Signal using GPIOB6 / RXD / SDA / CLKIN



### 3.4 Block Diagram

Figure 3-2 provides a block diagram which shows how the 56F8014 creates its internal clock, using the relaxation oscillator as an 8MHz clock reference for the PLL.

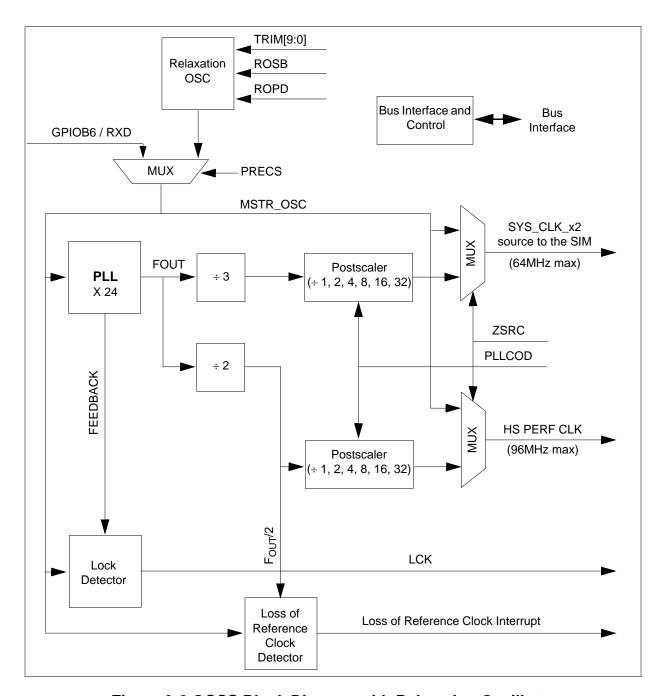


Figure 3-2 OCCS Block Diagram with Relaxation Oscillator



#### 3.5 Pin Descriptions

#### 3.5.1 External Reference (GPIOB6 / RXD / SDA / CLKIN)

After reset, the internal relaxation oscillator is selected as the clock source for the chip. The user then has the option of switching to an external clock reference by enabling the PRECS bit in the OCCS Oscillator Control register, if desired.

## Part 4 Memory Map

#### 4.1 Introduction

The 56F8014 device is a 16-bit motor-control chip based on the 56800E core. It uses a Harvard-style architecture with two independent memory spaces for Data and Program. On-chip RAM is used in both spaces and Flash memory is used only in Program space.

This section provides memory maps for:

- Program Address Space, including the Interrupt Vector Table
- Data Address Space, including the EOnCE Memory and Peripheral Memory Maps

On-chip memory sizes for the device are summarized in Table 4-1. Flash memories' restrictions are identified in the "Use Restrictions" column of Table 4-1.

On-Chip Memory	56F8014	Use Restrictions
Program Flash (PFLASH)	8k x 16	Erase / Program via Flash interface unit and word writes to CDBW
Unified RAM (ram)	2k x 16	Usable by both the Program and Data memory spaces

Table 4-1 Chip Memory Configurations

#### **Interrupt Vector Table** 4.2

Table 4-2 provides the 56F8014's reset and interrupt priority structure, including on-chip peripherals. The table is organized with higher-priority vectors at the top and lower-priority interrupts lower in the table. As indicated, the priority of an interrupt can be assigned to different levels, allowing some control over interrupt priorities. All level 3 interrupts will be serviced before level 2, and so on. For a selected priority level, the lowest vector number has the highest priority.

The location of the vector table is determined by the Vector Base Address (VBA). Please see Section 5.5.6 for the reset value of the VBA.

By default, the chip reset address and COP reset address will correspond to vector 0 and 1 of the interrupt vector table. In these instances, the first two locations in the vector table must contain branch or JMP instructions. All other entries must contain JSR instructions.

56F8014 Technical Data, Rev. 11 Freescale Semiconductor 29



## Table 4-2 Interrupt Vector Table Contents<sup>1</sup>

Peripheral	Vector Number	Priority Level	Vector Base Address +	Interrupt Function	
core			P:\$00	Reserved for Reset Overlay <sup>2</sup>	
core			P:\$02	Reserved for COP Reset Overlay	
core	2	3	P:\$04	Illegal Instruction	
core	3	3	P:\$06	SW Interrupt 3	
core	4	3	P:\$08	HW Stack Overflow	
core	5	3	P:\$0A	Misaligned Long Word Access	
core	6	1-3	P:\$0C	EOnCE Step Counter	
core	7	1-3	P:\$0E	EOnCE Breakpoint Unit 0	
core	8	1-3	P:\$10	EOnCE Trace Buffer	
core	9	1-3	P:\$12	EOnCE Transmit Register Empty	
core	10	1-3	P:\$14	EOnCE Receive Register Full	
core	11	2	P:\$16	SW Interrupt 2	
core	12	1	P:\$18	SW Interrupt 1	
core	13	0	P:\$1A	SW Interrupt 0	
	14			Reserved	
	15			Reserved	
PS	16	0-2	P:\$20	Power Sense	
occs	17	0-2	P:\$22	PLL Lock, Loss of Clock Reference Interrupt	
FM	18	0-2	P:\$24	FM Access Error Interrupt	
FM	19	0-2	P:\$26	FM Command Complete	
FM	20	0-2	P:\$28	FM Command, data and address Buffers Empty	
	21			Reserved	
GPIOD	22	0-2	P:\$2C	GPIOD	
GPIOC	23	0-2	P:\$2E	GPIOC	
GPIOB	24	0-2	P:\$30	GPIOB	
GPIOA	25	0-2	P:\$32	GPIOA	
SPI	26	0-2	P:\$34	SPI Receiver Full / Error	
SPI	27	0-2	P:\$36	SPI Transmitter Empty	
SCI	28	0-2	P:\$38	SCI Transmitter Empty	
SCI	29	0-2	P:\$3A	SCI Transmitter Idle	
SCI	30	0-2	P:\$3C	SCI Reserved	
SCI	31	0-2	P:\$3E	SCI Receiver Error	
SCI	32	0-2	P:\$40	SCI Receiver Full	
	33, 34			Reserved	
I <sup>2</sup> C	35	0-2	P:\$46	I <sup>2</sup> C	
Timer	36	0-2	P:\$48	Timer Channel 0	
Timer	37	0-2	P:\$4A	Timer Channel 1	
	ı	1	(Conti	nues next page)	



Table 4-2 Interrupt Vector Table	Contents <sup>1</sup>	(Continued)
----------------------------------	-----------------------	-------------

Peripheral	Vector Number	Priority Level	Vector Base Address +	Interrupt Function	
Timer	38	0-2	P:\$4C	Timer Channel 2	
Timer	39	0-2	P:\$4E	Timer Channel 3	
ADC	40	0-2	P:\$50	ADCA Conversion Complete	
ADC	41	0-2	P:\$52	ADCB Conversion Complete	
ADC	42	0-2	P:\$54	ADC Zero Crossing or Limit Error	
PWM	43	0-2	P:\$56	Reload PWM	
PWM	44	0-2	P:\$58	PWM Fault	
SWILP	45	-1	P:\$5A	SW Interrupt Low Priority	

<sup>1.</sup> Two words are allocated for each entry in the vector table. This does not allow the full address range to be referenced from the vector table, providing only 19 bits of address.

### 4.3 Program Map

The Program Memory map is shown in **Table 4-3**.

Table 4-3 Program Memory Map<sup>1</sup>

Begin/End Address	Memory Allocation
P: \$FF FFFF P: \$00 8800	RESERVED
P: \$00 87FF P: \$00 8000	On-Chip RAM <sup>2</sup> 4KB
P: \$00 7FFF P: \$00 2000	RESERVED
P: \$00 1FFF P: \$00 0000	Internal Program Flash 16KB Cop Reset Address = \$00 0002 Boot Location = \$00 0000

<sup>1.</sup> All addresses are 16-bit Word addresses.

<sup>2.</sup> If the VBA is set to the reset value, the first two locations of the vector table will overlay the chip reset addresses.

This RAM is shared with Data space starting at address X: \$00 0000; see Figure 4-1.



### 4.4 Data Map

Table 4-4 Data Memory Map<sup>1</sup>

Begin/End Address	Memory Allocation
X:\$FF FFFF X:\$FF FF00	EOnCE 256 locations allocated
X:\$FF FEFF X:\$01 0000	RESERVED
X:\$00 FFFF X:\$00 F000	On-Chip Peripherals 4096 locations allocated
X:\$00 EFFF X:\$00 8800	RESERVED
X:\$00 EFFF X:\$00 0800	Reserved
X:\$00 7FFF X:\$00 0040	RESERVED
X:\$00 07FF X:\$00 0000	On-Chip Data RAM <sup>2</sup> 4KB

<sup>1.</sup> All addresses are 16-bit Word addresses.

<sup>2.</sup> This RAM is shared with Program space starting at P: \$00 8000; see Figure 4-1.

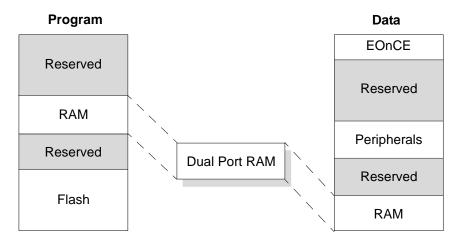


Figure 4-1 Dual Port RAM

56F8014 Technical Data, Rev. 11

## 4.5 EOnCE Memory Map

Figure 4-5 lists all EOnCE registers necessary to access or control the EOnCE.



**Table 4-5 EOnCE Memory Map** 

Address	Register Acronym	Register Name
X:\$FF FFFF	OTX1 / ORX1	Transmit Register Upper Word Receive Register Upper Word
X:\$FF FFFE	OTX / ORX (32 bits)	Transmit Register Receive Register
X:\$FF FFFD	OTXRXSR	Transmit and Receive Status and Control Register
X:\$FF FFFC	OCLSR	Core Lock / Unlock Status Register
X:\$FF FFFB - X:\$FF FFA1		Reserved
X:\$FF FFA0	OCR	Control Register
X:\$FF FF9F		Instruction Step Counter
X:\$FF FF9E	OSCNTR (24 bits)	Instruction Step Counter
X:\$FF FF9D	OSR	Status Register
X:\$FF FF9C	OBASE	Peripheral Base Address Register
X:\$FF FF9B	OTBCR	Trace Buffer Control Register
X:\$FF FF9A	OTBPR	Trace Buffer Pointer Register
X:\$FF FF99		Trace Buffer Register Stages
X:\$FF FF98	OTB (21 - 24 bits/stage)	Trace Buffer Register Stages
X:\$FF FF97		Breakpoint Unit Control Register
X:\$FF FF96	OBCR (24 bits)	Breakpoint Unit Control Register
X:\$FF FF95		Breakpoint Unit Address Register 1
X:\$FF FF94	OBAR1 (24 bits)	Breakpoint Unit Address Register 1
X:\$FF FF93		Breakpoint Unit Address Register 2
X:\$FF FF92	OBAR2 (32 bits)	Breakpoint Unit Address Register 2
X:\$FF FF91		Breakpoint Unit Mask Register 2
X:\$FF FF90	OBMSK (32 bits)	Breakpoint Unit Mask Register 2
X:\$FF FF8F		Reserved
X:\$FF FF8E	OBCNTR	EOnCE Breakpoint Unit Counter
X:\$FF FF8D		Reserved
X:\$FF FF8C		Reserved
X:\$FF FF8B		Reserved
X:\$FF FF8A	OESCR	External Signal Control Register
X:\$FF FF89 - X:\$FF FF00		Reserved

## 4.6 Peripheral Memory Mapped Registers

On-chip peripheral registers are part of the data memory map on the 56800E series. These locations may be accessed with the same addressing modes used for ordinary Data memory, except all peripheral registers should be read/written using word accesses only.

**Table 4-6** summarizes base addresses for the set of peripherals on the 56F8014 device. Peripherals are listed in order of the base address.

56F8014 Technical Data, Rev. 11



The following tables list all of the peripheral registers required to control or access the peripherals.

**Table 4-6 Data Memory Peripheral Base Address Map Summary** 

Peripheral	Prefix	Base Address	Table Number
Timer	TMR <i>n</i>	X:\$00 F000	4-7
PWM	PWM	X:\$00 F040	4-8
ITCN	ITCN	X:\$00 F060	4-9
ADC	ADC	X:\$00 F080	4-10
SCI	SCI	X:\$00 F0B0	4-11
SPI	SPI	X:\$00 F0C0	4-12
I <sup>2</sup> C	I2C	X:\$00 F0D0	4-13
COP	COP	X:\$00 F0E0	4-14
CLK, PLL, OSC, TEST	occs	X:\$00 F0F0	4-15
GPIO Port A	GPIOA	X:\$00 F100	4-16
GPIO Port B	GPIOB	X:\$00 F110	4-17
GPIO Port C	GPIOC	X:\$00 F120	4-18
GPIO Port D	GPIOD	X:\$00 F130	4-19
SIM	SIM	X:\$00 F140	4-20
Power Supervisor	PS	X:\$00 F160	4-21
FM	FM	X:\$00 F400	4-22

Table 4-7 Quad Timer Registers Address Map (TMR\_BASE = \$00 F000)

Register Acronym	Address Offset	Register Description
TMR0_COMP1	\$0	Compare Register 1
TMR0_COMP2	\$1	Compare Register 2
TMR0_CAPT	\$2	Capture Register
TMR0_LOAD	\$3	Load Register
TMR0_HOLD	\$4	Hold Register
TMR0_CNTR	\$5	Counter Register
TMR0_CTRL	\$6	Control Register
TMR0_SCTRL	\$7	Status and Control Register
TMR0_CMPLD1	\$8	Comparator Load Register 1
TMR0_CMPLD2	\$9	Comparator Load Register 2
TMR0_CSCTRL	\$A	Comparator Status and Control Register
		Reserved
TMR1_COMP1	\$10	Compare Register 1
TMR1_COMP2	\$11	Compare Register 2



Table 4-7 Quad Timer Registers Address Map (Continued) (TMR\_BASE = \$00 F000)

Register Acronym	Address Offset	Register Description
TMR1_CAPT	\$12	Capture Register
TMR1_LOAD	\$13	Load Register
TMR1_HOLD	\$14	Hold Register
TMR1_CNTR	\$15	Counter Register
TMR1_CTRL	\$16	Control Register
TMR1_SCTRL	\$17	Status and Control Register
TMR1_CMPLD1	\$18	Comparator Load Register 1
TMR1_CMPLD2	\$19	Comparator Load Register 2
TMR1_CSCTRL	\$1A	Comparator Status and Control Register
		Reserved
TMR2_COMP1	\$20	Compare Register 1
TMR2_COMP2	\$21	Compare Register 2
TMR2_CAPT	\$22	Capture Register
TMR2_LOAD	\$23	Load Register
TMR2_HOLD	\$24	Hold Register
TMR2_CNTR	\$25	Counter Register
TMR2_CTRL	\$26	Control Register
TMR2_SCTRL	\$27	Status and Control Register
TMR2_CMPLD1	\$28	Comparator Load Register 1
TMR2_CMPLD2	\$29	Comparator Load Register 2
TMR2_CSCTRL	\$2A	Comparator Status and Control Register
		Reserved
TMR3_COMP1	\$30	Compare Register 1
TMR3_COMP2	\$31	Compare Register 2
TMR3_CAPT	\$32	Capture Register
TMR3_LOAD	\$33	Load Register
TMR3_HOLD	\$34	Hold Register
TMR3_CNTR	\$35	Counter Register
TMR3_CTRL	\$36	Control Register
TMR3_SCTRL	\$37	Status and Control Register
TMR3_CMPLD1	\$38	Comparator Load Register 1
TMR3_CMPLD2	\$39	Comparator Load Register 2
TMR3_CSCTRL	\$3A	Comparator Status and Control Register



Table 4-8 Pulse Width Modulator Registers Address Map (PWM\_BASE = \$00 F040)

Register Acronym	Address Offset	Register Description
PWM_CTRL	\$0	Control Register
PWM_FCTRL	\$1	Fault Control Register
PWM_FLTACK	\$2	Fault Status Acknowledge Register
PWM_OUT	\$3	Output Control Register
PWM_CNTR	\$4	Counter Register
PWM_CMOD	\$5	Counter Modulo Register
PWM_VAL0	\$6	Value Register 0
PWM_VAL1	\$7	Value Register 1
PWM_VAL2	\$8	Value Register 2
PWM_VAL3	\$9	Value Register 3
PWM_VAL4	\$A	Value Register 4
PWM_VAL5	\$B	Value Register 5
PWM_DTIM0	\$C	Dead Time Register 0
PWM_DTIM1	\$D	Dead Time Register 1
PWM_DMAP1	\$E	Disable Mapping Register 1
PWM_DMAP2	\$F	Disable Mapping Register 2
PWM_CNFG	\$10	Configure Register
PWM_CCTRL	\$11	Channel Control Register
PWM_PORT	\$12	Port Register
PWM_ICCTRL	\$13	Internal Correction Control Register
PWM_SCTRL	\$14	Source Control Register

# Table 4-9 Interrupt Control Registers Address Map (ITCN\_BASE = \$00 F060)

Register Acronym	Address Offset	Register Description
ITCN_IPR0	\$0	Interrupt Priority Register 0
ITCN_IPR1	\$1	Interrupt Priority Register 1
ITCN_IPR2	\$2	Interrupt Priority Register 2
ITCN_IPR3	\$3	Interrupt Priority Register 3
ITCN_IPR4	\$4	Interrupt Priority Register 4
ITCN_VBA	\$5	Vector Base Address Register
ITCN_FIM0	\$6	Fast Interrupt Match 0 Register
ITCN_FIVAL0	\$7	Fast Interrupt Vector Address Low 0 Register
ITCN_FIVAH0	\$8	Fast Interrupt Vector Address High 0 Register



Table 4-9 Interrupt Control Registers Address Map (Continued) (ITCN\_BASE = \$00 F060)

Register Acronym	Address Offset	Register Description
ITCN_FIM1	\$9	Fast Interrupt Match 1 Register
ITCN_FIVAL1	\$A	Fast Interrupt Vector Address Low 1 Register
ITCN_FIVAH1	\$B	Fast Interrupt Vector Address High 1 Register
ITCN_IRQP 0	\$C	IRQ Pending Register 0
ITCN_IRQP 1	\$D	IRQ Pending Register 1
ITCN_IRQP 2	\$E	IRQ Pending Register 2
		Reserved
ITCN_ICTRL	\$12	Interrupt Control Register
		Reserved

Table 4-10 Analog-to-Digital Converter Registers Address Map (ADC\_BASE = \$00 F080)

Register Acronym	Address Offset	Register Description
ADC_CTRL1	\$0	Control Register 1
ADC_CTRL2	\$1	Control Register 2
ADC_ZXCTRL	\$2	Zero Crossing Control Register
ADC_CLIST 1	\$3	Channel List Register 1
ADC_CLIST 2	\$4	Channel List Register 2
ADC_SDIS	\$5	Sample Disable Register
ADC_STAT	\$6	Status Register
ADC_LIMSTAT	\$7	Limit Status Register
ADC_ZXSTAT	\$8	Zero Crossing Status Register
ADC_RSLT0	\$9	Result Register 0
ADC_RSLT1	\$A	Result Register 1
ADC_RSLT2	\$B	Result Register 2
ADC_RSLT3	\$C	Result Register 3
ADC_RSLT4	\$D	Result Register 4
ADC_RSLT5	\$E	Result Register 5
ADC_RSLT6	\$F	Result Register 6
ADC_RSLT7	\$10	Result Register 7
ADC_LOLIM0	\$11	Low Limit Register 0
ADC_LOLIM1	\$12	Low Limit Register 1
ADC_LOLIM2	\$13	Low Limit Register 2
ADC_LOLIM3	\$14	Low Limit Register 3
ADC_LOLIM4	\$15	Low Limit Register 4
ADC_LOLIM5	\$16	Low Limit Register 5



Table 4-10 Analog-to-Digital Converter Registers Address Map (Continued) (ADC\_BASE = \$00 F080)

Register Acronym	Address Offset	Register Description
ADC_LOLIM6	\$17	Low Limit Register 6
ADC_LOLIM7	\$18	Low Limit Register 7
ADC_HILIM0	\$19	High Limit Register 0
ADC_HILIM1	\$1A	High Limit Register 1
ADC_HILIM2	\$1B	High Limit Register 2
ADC_HILIM3	\$1C	High Limit Register 3
ADC_HILIM4	\$1D	High Limit Register 4
ADC_HILIM5	\$1E	High Limit Register 5
ADC_HILIM6	\$1F	High Limit Register 6
ADC_HILIM7	\$20	High Limit Register 7
ADC_OFFST0	\$21	Offset Register 0
ADC_OFFST1	\$22	Offset Register 1
ADC_OFFST2	\$23	Offset Register 2
ADC_OFFST3	\$24	Offset Register 3
ADC_OFFST4	\$25	Offset Register 4
ADC_OFFST5	\$26	Offset Register 5
ADC_OFFST6	\$27	Offset Register 6
ADC_OFFST7	\$28	Offset Register 7
ADC_PWR	\$29	Power Control Register
ADC_VREF	\$2A	Voltage Reference Register
		Reserved

Table 4-11 Serial Communication Interface Registers Address Map (SCI\_BASE = \$00 F0B0)

Register Acronym	Address Offset	Register Description
SCI_RATE	\$0	Baud Rate Register
SCI_CTRL1	\$1	Control Register 1
SCI_CTRL2	\$2	Control Register 2
SCI_STAT	\$3	Status Register
SCI_DATA	\$4	Data Register



Table 4-12 Serial Peripheral Interface Registers Address Map (SPI\_BASE = \$00 F0C0)

Register Acronym	Address Offset	Register Description
SPI_SCTRL	\$0	Status and Control Register
SPI_DSCTRL	\$1	Data Size and Control Register
SPI_DRCV	\$2	Data Receive Register
SPI_DXMIT	\$3	Data Transmit Register

## Table 4-13 I<sup>2</sup>C Registers Address Map (I2C\_BASE = \$00 F0D0)

Register Acronym	Address Offset	Register Description
I2C_ADDR	\$0	Address Register
I2C_FDIV	\$1	Frequency Divider Register
I2C_CTRL	\$2	Control Register
I2C_STAT	\$3	Status Register
I2C_DATA	\$4	Data Register
I2C_NFILT	\$5	Noise Filter Register

## Table 4-14 Computer Operating Properly Registers Address Map (COP\_BASE = \$00 F0E0)

Register Acronym	Address Offset	Register Description
COP_CTRL	\$0	Control Register
COP_TOUT	\$1	Time-Out Register
COP_CNTR	\$2	Counter Register

## Table 4-15 Clock Generation Module Registers Address Map (OCCS\_BASE = \$00 F0F0)

Register Acronym	Address Offset	Register Description
OCCS_CTRL	\$0	Control Register
OCCS_DIVBY	\$1	Divide-By Register
OCCS_STAT	\$2	Status Register
		Reserved
OCCS_SHUTDN	\$4	Shutdown Register
OCCS_OCTRL	\$5	Oscillator Control Register



## Table 4-16 GPIOA Registers Address Map (GPIOA\_BASE = \$00 F100)

Register Acronym	Address Offset	Register Description
GPIOA_PUPEN	\$0	Pull-up Enable Register
GPIOA_DATA	\$1	Data Register
GPIOA_DDIR	\$2	Data Direction Register
GPIOA_PEREN	\$3	Peripheral Enable Register
GPIOA_IASSRT	\$4	Interrupt Assert Register
GPIOA_IEN	\$5	Interrupt Enable Register
GPIOA_IEPOL	\$6	Interrupt Edge Polarity Register
GPIOA_IPEND	\$7	Interrupt Pending Register
GPIOA_IEDGE	\$8	Interrupt Edge-Sensitive Register
GPIOA_PPOUTM	\$9	Push-Pull Output Mode Control Register
GPIOA_RDATA	\$A	Raw Data Register
GPIOA_DRIVE	\$B	Drive Strength Control Register

# Table 4-17 GPIOB Registers Address Map (GPIOB\_BASE = \$00 F110)

Register Acronym	Address Offset	Register Description
GPIOB_PUPEN	\$0	Pull-up Enable Register
GPIOB_DATA	\$1	Data Register
GPIOB_DDIR	\$2	Data Direction Register
GPIOB_PEREN	\$3	Peripheral Enable Register
GPIOB_IASSRT	\$4	Interrupt Assert Register
GPIOB_IEN	\$5	Interrupt Enable Register
GPIOB_IEPOL	\$6	Interrupt Edge Polarity Register
GPIOB_IPEND	\$7	Interrupt Pending Register
GPIOB_IEDGE	\$8	Interrupt Edge-Sensitive Register
GPIOB_PPOUTM	\$9	Push-Pull Output Mode Control Register
GPIOB_RDATA	\$A	Raw Data Register
GPIOB_DRIVE	\$B	Drive Strength Control Register



## Table 4-18 GPIOC Registers Address Map (GPIOC\_BASE = \$00 F120)

Register Acronym	Address Offset	Register Description
GPIOC_PUPEN	\$0	Pull-up Enable Register
GPIOC_DATA	\$1	Data Register
GPIOC_DDIR	\$2	Data Direction Register
GPIOC_PEREN	\$3	Peripheral Enable Register
GPIOC_IASSRT	\$4	Interrupt Assert Register
GPIOC_IEN	\$5	Interrupt Enable Register
GPIOC_IEPOL	\$6	Interrupt Edge Polarity Register
GPIOC_IPEND	\$7	Interrupt Pending Register
GPIOC_IEDGE	\$8	Interrupt Edge-Sensitive Register
GPIOC_PPOUTM	\$9	Push-Pull Output Mode Control Register
GPIOC_RDATA	\$A	Raw Data Register
GPIOC_DRIVE	\$B	Drive Strength Control Register

## Table 4-19 GPIOD Registers Address Map (GPIOD\_BASE = \$00 F130)

Register Acronym	Address Offset	Register Description
GPIOD_PUPEN	\$0	Pull-up Enable Register
GPIOD_DATA	\$1	Data Register
GPIOD_DDIR	\$2	Data Direction Register
GPIOD_PEREN	\$3	Peripheral Enable Register
GPIOD_IASSRT	\$4	Interrupt Assert Register
GPIOD_IEN	\$5	Interrupt Enable Register
GPIOD_IEPOL	\$6	Interrupt Edge Polarity Register
GPIOD_IPEND	\$7	Interrupt Pending Register
GPIOD_IEDGE	\$8	Interrupt Edge-Sensitive Register
GPIOD_PPOUTM	\$9	Push-Pull Output Mode Control Register
GPIOD_RDATA	\$A	Raw Data Register
GPIOD_DRIVE	\$B	Drive Strength Control Register



Table 4-20 System Integration Module Registers Address Map (SIM\_BASE = \$00 F140)

Register Acronym	Address Offset	Register Description
SIM_CTRL	\$0	Control Register
SIM_RSTAT	\$1	Reset Status Register
SIM_SWC0	\$2	Software Control Register 0
SIM_SWC1	\$3	Software Control Register 1
SIM_SWC2	\$4	Software Control Register 2
SIM_SWC3	\$5	Software Control Register 3
SIM_MSHID	\$6	Most Significant Half JTAG ID
SIM_LSHID	\$7	Least Significant Half JTAG ID
SIM_PWR	\$8	Power Control Register
		Reserved
SIM_CLKOUT	\$A	Clock Out Select Register
SIM_GPS	\$B	GPIO Peripheral Select Register
SIM_PCE	\$C	Peripheral Clock Enable Register
SIM_IOSAHI	\$D	I/O Short Address Location High Register
SIM_IOSALO	\$E	I/O Short Address Location Low Register

## Table 4-21 Power Supervisor Registers Address Map (PS\_BASE = \$00 F160)

Register Acronym	Address Offset	Register Description
PS_CTRL	\$0	Control Register
PS_STAT	\$1	Status Register

#### Table 4-22 Flash Module Registers Address Map (FM\_BASE = \$00 F400)

Register Acronym	Address Offset	Register Description
FM_CLKDIV	\$0	Clock Divider Register
FM_CNFG	\$1	Configuration Register
	\$2	Reserved
FM_SECHI	\$3	Security High Half Register
FM_SECLO	\$4	Security Low Half Register
	\$5 - \$9	Reserved
FM_PROT	\$10	Protection Register
	\$11 - \$12	Reserved



Table 4-22 Flash Module Reg	isters Address Map (Continued)
	E = \$00 F400)

Register Acronym	Address Offset	Register Description
FM_USTAT	\$13	User Status Register
FM_CMD	\$14	Command Register
	\$15	Reserved
	\$16	Reserved
	\$17	Reserved
FM_DATA	\$18	Data Buffer Register
	\$19	Reserved
	\$1A	Reserved
FM_OPT1	\$1B	Optional Data 1 Register
		Reserved
FM_TSTSIG	\$1D	Test Array Signature Register

## Part 5 Interrupt Controller (ITCN)

#### 5.1 Introduction

The Interrupt Controller (ITCN) module is used to arbitrate between various interrupt requests (IRQs), to signal to the 56800E core when an interrupt of sufficient priority exists, and to what address to jump in order to service this interrupt.

#### 5.2 Features

The ITCN module design includes these distinctive features:

- Programmable priority levels for each IRQ
- Two programmable Fast Interrupts
- Notification to SIM module to restart clocks out of Wait and Stop modes
- Ability to drive initial address on the address bus after reset

For further information, see **Table 4-2**, Interrupt Vector Table Contents.

## 5.3 Functional Description

The Interrupt Controller contains registers that allow each of the 46 interrupt sources to be set to one of three priority levels (excluding certain interrupts that are of fixed priority). Next, all of the interrupt requests of a given level are priority encoded to determine the lowest numerical value of the active interrupt requests for that level. Within a given priority level, number 0 is the highest priority and number 45 is the lowest.

During wait and stop modes, the system clocks and the 56800E core are turned off. The ITCN can wake the core and restart system clocks by signaling a pending IRQ to the System Integration Module (SIM) to



restart the clocks and service the IRQ. An IRQ can only wake the core if the IRQ is enabled prior to entering wait or stop mode.

#### 5.3.1 Normal Interrupt Handling

Once the INTC has determined that an interrupt is to be serviced and which interrupt has the highest priority, an interrupt vector address is generated. Normal interrupt handling concatenates the Vector Base Address (VBA) and the vector number to determine the vector address, generating an offset into the vector table for each interrupt.

### 5.3.2 Interrupt Nesting

Interrupt exceptions may be nested to allow an IRQ of higher priority than the current exception to be serviced. The following table defines the nesting requirements for each priority level.

SR[9]	SR[8]	Exceptions Permitted	Exceptions Masked
0	0	Priorities 0, 1, 2, 3	None
0	1	Priorities 1, 2, 3	Priority 0
1	0	Priorities 2, 3	Priorities 0, 1
1	1	Priority 3	Priorities 0, 1, 2

Table 5-1 Interrupt Mask Bit Definition

## 5.3.3 Fast Interrupt Handling

Fast interrupts are described in the **DSP56800E Reference Manual**. The interrupt controller recognizes Fast Interrupts before the core does.

A Fast Interrupt is defined (to the ITCN) by:

44

- 1. Setting the priority of the interrupt as level 2, with the appropriate field in the IPR registers
- 2. Setting the FIMn register to the appropriate vector number
- 3. Setting the FIVALn and FIVAHn registers with the address of the code for the Fast Interrupt

When an interrupt occurs, its vector number is compared with the FIM0 and FIM1 register values. If a match occurs, and it is a level 2 interrupt, the ITCN handles it as a Fast Interrupt. The ITCN takes the vector address from the appropriate FIVALn and FIVAHn registers, instead of generating an address that is an offset from the VBA.

The core then fetches the instruction from the indicated vector adddress and if it is not a JSR, the core starts its Fast Interrupt handling.

56F8014 Technical Data, Rev. 11

45



## 5.4 Block Diagram

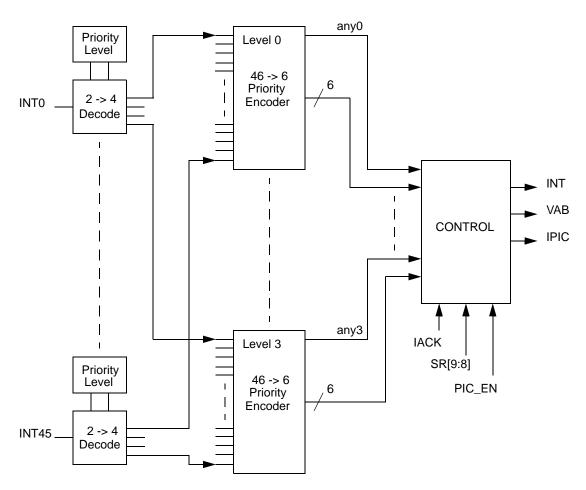


Figure 5-1 Interrupt Controller Block Diagram

## 5.5 Register Descriptions

A register address is the sum of a base address and an address offset. The base address is defined at the system level and the address offset is defined at the module level. The ITCN module has 16 registers.

Table 5-2 ITCN Register Summary (ITCN\_BASE = \$00 F060)

Register Acronym	Base Address +	Register Name	Section Location
IPR0	\$0	Interrupt Priority Register 0	5.5.1
IPR1	\$1	Interrupt Priority Register 1	5.5.2
IPR2	\$2	Interrupt Priority Register 2	5.5.3



# Table 5-2 ITCN Register Summary (Continued) (ITCN\_BASE = \$00 F060)

Register Acronym	Base Address +	Register Name	Section Location
IPR3	\$3	Interrupt Priority Register 3	5.5.4
IPR4	\$4	Interrupt Priority Register 4	5.5.5
VBA	\$5	Vector Base Address Register	5.5.6
FIM0	\$6	Fast Interrupt Match 0 Register	5.5.7
FIVAL0	\$7	Fast Interrupt 0 Vector Address Low Register	5.5.8
FIVAH0	\$8	Fast Interrupt 0 Vector Address High Register	5.5.9
FIM1	\$9	Fast Interrupt Match 1 Register	5.5.10
FIVAL1	\$A	Fast Interrupt 1 Vector Address Low Register	5.5.11
FIVAH1	\$B	Fast Interrupt 1 Vector Address High Register	5.5.12
IRQP0	\$C	IRQ Pending Register 0	5.5.13
IRQP1	\$D	IRQ Pending Register 1	5.5.14
IRQP2	\$E	IRQ Pending Register 2	5.5.15
		Reserved	
ICTRL	\$12	Interrupt Control Register	5.5.16
		Reserved	



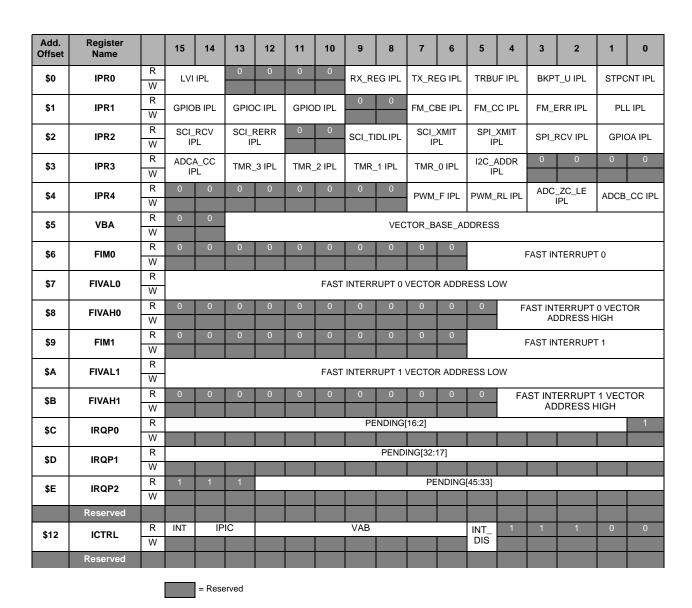


Figure 5-2 ITCN Register Map Summary

## 5.5.1 Interrupt Priority Register 0 (IPR0)

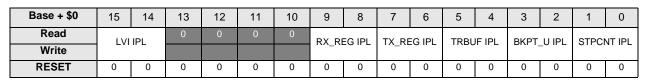


Figure 5-3 Interrupt Priority Register 0 (IPR0)



#### 5.5.1.1 LVI IPL—Bits 15–14

This field is used to set the interrupt priority levels for a peripheral IRQ. This IRQ is limited to priorities 0 through 2 and is disabled by default.

- 00 = IRQ disabled (default)
- 01 = IRQ is priority level 0
- 10 = IRQ is priority level 1
- 11 = IRQ is priority level 2

#### 5.5.1.2 Reserved—Bits 13–10

This bit field is reserved or not implemented. It is read as 0 and cannot be modified by writing.

## 5.5.1.3 EOnCE Receive Register Full Interrupt Priority Level (RX\_REG IPL)— Bits 9–8

This field is used to set the interrupt priority level for IRQs. This IRQ is limited to priorities 1 through 3. It is disabled by default.

- 00 = IRQ disabled (default)
- 01 = IRQ is priority level 1
- 10 = IRQ is priority level 2
- 11 = IRQ is priority level 3

# 5.5.1.4 EOnCE Transmit Register Empty Interrupt Priority Level (TX\_REG IPL)— Bits 7–6

This field is used to set the interrupt priority level for IRQs. This IRQ is limited to priorities 1 through 3. It is disabled by default.

- 00 = IRQ disabled (default)
- 01 = IRQ is priority level 1
- 10 = IRQ is priority level 2
- 11 = IRQ is priority level 3

## 5.5.1.5 EOnCE Trace Buffer Interrupt Priority Level (TRBUF IPL)— Bits 5–4

This field is used to set the interrupt priority level for IRQs. This IRQ is limited to priorities 1 through 3. It is disabled by default.

- 00 = IRQ disabled (default)
- 01 = IRQ is priority level 1
- 10 = IRQ is priority level 2
- 11 = IRQ is priority level 3



## 5.5.1.6 EOnCE Breakpoint Unit Interrupt Priority Level (BKPT\_U IPL)— Bits 3–2

This field is used to set the interrupt priority level for IRQs. This IRQ is limited to priorities 1 through 3. It is disabled by default.

- 00 = IRQ disabled (default)
- 01 = IRQ is priority level 1
- 10 = IRQ is priority level 2
- 11 = IRQ is priority level 3

# 5.5.1.7 EOnCE Step Counter Interrupt Priority Level (STPCNT IPL)— Bits 1–0

This field is used to set the interrupt priority level for IRQs. This IRQ is limited to priorities 1 through 3. It is disabled by default.

- 00 = IRQ disabled (default)
- 01 = IRQ is priority level 1
- 10 = IRQ is priority level 2
- 11 = IRQ is priority level 3

## 5.5.2 Interrupt Priority Register 1 (IPR1)

Base + \$1	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
Read	GPIO	B IPI	GPIOC IPL		GPIOD IPL		0	0	FM CBE IPL		FM CC IPL		FM ERR IPL		PLL IPL	
Write	GPIOB IPL		011001112		01 100 11 2				1 W_O	DL 11 L	1 101_0	011 L	1 IVI_EI			
RESET	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0

Figure 5-4 Interrupt Priority Register 1 (IPR1)

## 5.5.2.1 GPIOB Interrupt Priority Level (GPIOB IPL)—Bits 15–14

This field is used to set the interrupt priority level for IRQs. This IRQ is limited to priorities 0 through 2. It is disabled by default.

- 00 = IRQ disabled (default)
- 01 = IRQ is priority level 0
- 10 = IRQ is priority level 1
- 11 = IRQ is priority level 2

## 5.5.2.2 GPIOC Interrupt Priority Level (GPIOC IPL)—Bits 13–12

This field is used to set the interrupt priority level for IRQs. This IRQ is limited to priorities 0 through 2. It is disabled by default.

- 00 = IRQ disabled (default)
- 01 = IRQ is priority level 0
- 10 = IRQ is priority level 1
- 11 = IRQ is priority level 2



### 5.5.2.3 GPIOD Interrupt Priority Level (GPIOD IPL)—Bits 11–10

This field is used to set the interrupt priority level for IRQs. This IRQ is limited to priorities 0 through 2. It is disabled by default.

- 00 = IRQ disabled (default)
- 01 = IRQ is priority level 0
- 10 = IRQ is priority level 1
- 11 = IRQ is priority level 2

#### 5.5.2.4 Reserved—Bits 9–8

This bit field is reserved or not implemented. It is read as 0 and cannot be modified by writing.

## 5.5.2.5 FM Command, Data, Address Buffers Empty Interrupt Priority Level (FM\_CBE IPL)—Bits 7–6

This field is used to set the interrupt priority level for IRQs. This IRQ is limited to priorities 0 through 2. It is disabled by default.

- 00 = IRQ disabled (default)
- 01 = IRQ is priority level 0
- 10 = IRQ is priority level 1
- 11 = IRQ is priority level 2

#### 5.5.2.6 FM Command Complete Priority Level (FM\_CC IPL)—Bits 5-4

This field is used to set the interrupt priority level for IRQs. This IRQ is limited to priorities 0 through 2. It is disabled by default.

- 00 = IRQ disabled (default)
- 01 = IRQ is priority level 0
- 10 = IRQ is priority level 1
- 11 = IRQ is priority level 2

## 5.5.2.7 FM Error Interrupt Priority Level (FM\_ERR IPL)—Bits 3–2

This field is used to set the interrupt priority level for IRQs. This IRQ is limited to priorities 0 through 2. It is disabled by default.

- 00 = IRQ disabled (default)
- 01 = IRQ is priority level 0
- 10 = IRQ is priority level 1
- 11 = IRQ is priority level 2



# 5.5.2.8 PLL Loss of Reference or Change in Lock Status Interrupt Priority Level (PLL IPL)—Bits 1–0

This field is used to set the interrupt priority level for IRQs. This IRQ is limited to priorities 0 through 2. It is disabled by default.

- 00 = IRQ disabled (default)
- 01 = IRQ is priority level 0
- 10 = IRQ is priority level 1
- 11 = IRQ is priority level 2

## 5.5.3 Interrupt Priority Register 2 (IPR2)

Base + \$2	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
Read	SCLB	CV IDI		SCI_RERR		0	SCI TI	חו ופו	L SCI XMIT IPL		CDI VMIT IDI		SDL BCV/IDI		GPIOA IPL	
Write	SCI_RCV IPL		IPL				301_11	DEILE	COI_XIVIII II E		0.1_5		011_1(011112		01 10	A II L
RESET	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0

Figure 5-5 Interrupt Priority Register 2 (IPR2)

#### 5.5.3.1 SCI Receiver Full Interrupt Priority Level (SCI\_RCV IPL)— Bits 15–14

This field is used to set the interrupt priority level for IRQs. This IRQ is limited to priorities 0 through 2. It is disabled by default.

- 00 = IRQ disabled (default)
- 01 = IRQ is priority level 0
- 10 = IRQ is priority level 1
- 11 = IRQ is priority level 2

### 5.5.3.2 SCI Receiver Error Interrupt Priority Level (SCI\_RERR IPL)— Bits 13–12

This field is used to set the interrupt priority level for IRQs. This IRQ is limited to priorities 0 through 2. It is disabled by default.

- 00 = IRQ disabled (default)
- 01 = IRQ is priority level 0
- 10 = IRQ is priority level 1
- 11 = IRQ is priority level 2

#### 5.5.3.3 Reserved—Bits 11–10

This bit field is reserved or not implemented. It is read as 0 and cannot be modified by writing.



#### 5.5.3.4 SCI Transmitter Idle Interrupt Priority Level (SCI\_TIDL IPL)— Bits 9–8

This field is used to set the interrupt priority level for IRQs. This IRQ is limited to priorities 0 through 2. It is disabled by default.

- 00 = IRQ disabled (default)
- 01 = IRQ is priority level 0
- 10 = IRQ is priority level 1
- 11 = IRQ is priority level 2

### 5.5.3.5 SCI Transmitter Empty Interrupt Priority Level (SCI\_XMIT IPL)— Bits 7–6

This field is used to set the interrupt priority level for IRQs. This IRQ is limited to priorities 0 through 2. It is disabled by default.

- 00 = IRQ disabled (default)
- 01 = IRQ is priority level 0
- 10 = IRQ is priority level 1
- 11 = IRQ is priority level 2

### 5.5.3.6 SPI Transmitter Empty Interrupt Priority Level (SPI\_XMIT IPL)— Bits 5–4

This field is used to set the interrupt priority level for IRQs. This IRQ is limited to priorities 0 through 2. It is disabled by default.

- 00 = IRQ disabled (default)
- 01 = IRQ is priority level 0
- 10 = IRQ is priority level 1
- 11 = IRQ is priority level 2

### 5.5.3.7 SPI Receiver Full Interrupt Priority Level (SPI\_RCV IPL)— Bits 3–2

This field is used to set the interrupt priority level for IRQs. This IRQ is limited to priorities 0 through 2. It is disabled by default.

- 00 = IRQ disabled (default)
- 01 = IRQ is priority level 0
- 10 = IRQ is priority level 1
- 11 = IRQ is priority level 2



#### 5.5.3.8 GPIOA Interrupt Priority Level (GPIOA IPL)—Bits 1-0

This field is used to set the interrupt priority level for IRQs. This IRQ is limited to priorities 0 through 2. It is disabled by default.

- 00 = IRQ disabled (default)
- 01 = IRQ is priority level 0
- 10 = IRQ is priority level 1
- 11 = IRQ is priority level 2

## 5.5.4 Interrupt Priority Register 3 (IPR3)

Base + \$3	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
Read	ADCA	CC IPI	TMR	TMR 3 IPL		TMR 2 IPL		TMR_1 IPL		TMR 0 IPL		I2C_ADDR		0	0	0
Write	ADCA_CC IPL		11WIR_5 II E		1WII\_Z II E				0		IF	PL				
RESET	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0

Figure 5-6 Interrupt Priority Register 3 (IPR3)

# 5.5.4.1 ADCA Conversion Complete Interrupt Priority Level (ADCA\_CC IPL)—Bits 15–14

This field is used to set the interrupt priority level for IRQs. This IRQ is limited to priorities 0 through 2. They are disabled by default.

- 00 = IRQ disabled (default)
- 01 = IRQ is priority level 0
- 10 = IRQ is priority level 1
- 11 = IRQ is priority level 2

## 5.5.4.2 Timer Channel 3 Interrupt Priority Level (TMR\_3 IPL)—Bits 13–12

This field is used to set the interrupt priority level for IRQs. This IRQ is limited to priorities 0 through 2. They are disabled by default.

- 00 = IRQ disabled (default)
- 01 = IRQ is priority level 0
- 10 = IRQ is priority level 1
- 11 = IRQ is priority level 2

## 5.5.4.3 Timer Channel 2 Interrupt Priority Level (TMR\_2 IPL)—Bits 11–10

This field is used to set the interrupt priority level for IRQs. This IRQ is limited to priorities 0 through 2. They are disabled by default.

- 00 = IRQ disabled (default)
- 01 = IRQ is priority level 0
- 10 = IRQ is priority level 1
- 11 = IRQ is priority level 2



#### 5.5.4.4 Timer Channel 1 Interrupt Priority Level (TMR\_1 IPL)—Bits 9-8

This field is used to set the interrupt priority level for IRQs. This IRQ is limited to priorities 0 through 2. They are disabled by default.

- 00 = IRQ disabled (default)
- 01 = IRQ is priority level 0
- 10 = IRQ is priority level 1
- 11 = IRQ is priority level 2

### 5.5.4.5 Timer Channel 0 Interrupt Priority Level (TMR\_0 IPL)—Bits 7–6

This field is used to set the interrupt priority level for IRQs. This IRQ is limited to priorities 0 through 2. They are disabled by default.

- 00 = IRQ disabled (default)
- 01 = IRQ is priority level 0
- 10 = IRQ is priority level 1
- 11 = IRQ is priority level 2

## 5.5.4.6 I<sup>2</sup>C Address Detect Interrupt Priority Level (I2C\_ADDR IPL)—Bits 5–4

This field is used to set the interrupt priority level for IRQs. This IRQ is limited to priorities 0 through 2. They are disabled by default.

- 00 = IRQ disabled (default)
- 01 = IRQ is priority level 0
- 10 = IRQ is priority level 1
- 11 = IRQ is priority level 2

#### 5.5.4.7 Reserved—Bits 3–0

This bit field is reserved or not implemented. It is read as 0 and cannot be modified by writing.

## 5.5.5 Interrupt Priority Register 4 (IPR4)

Base + \$4	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
Read	0	0	0	0	0	0	0	0	PWM	PWM_F IPL		PWM_RL IPL		ADC_ZC_LE IPL		3_CC
Write									FVVIVI_I IFL		T WW_KE II E		IF			)L
RESET	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0

Figure 5-7 Interrupt Priority Register 4 (IPR4)

#### 5.5.5.1 Reserved—Bits 15-8

This bit field is reserved or not implemented. It is read as 0 and cannot be modified by writing.



## 5.5.5.2 PWM Fault Interrupt Priority Level (PWM\_F IPL)—Bits 7–6

This field is used to set the interrupt priority level for IRQs. This IRQ is limited to priorities 0 through 2. They are disabled by default.

- 00 = IRQ disabled (default)
- 01 = IRQ is priority level 0
- 10 = IRQ is priority level 1
- 11 = IRQ is priority level 2

### 5.5.5.3 Reload PWM Interrupt Priority Level (PWM\_RL IPL)— Bits 5–4

This field is used to set the interrupt priority level for IRQs. This IRQ is limited to priorities 0 through 2. They are disabled by default.

- 00 = IRQ disabled (default)
- 01 = IRQ is priority level 0
- 10 = IRQ is priority level 1
- 11 = IRQ is priority level 2

## 5.5.5.4 ADC Zero Crossing or Limit Error Interrupt Priority Level (ADC ZC LE IPL)— Bits 3–2

This field is used to set the interrupt priority level for IRQs. This IRQ is limited to priorities 0 through 2. They are disabled by default.

- 00 = IRQ disabled (default)
- 01 = IRQ is priority level 0
- 10 = IRQ is priority level 1
- 11 = IRQ is priority level 2

## 5.5.5.5 ADCB Conversion Complete Interrupt Priority Level (ADCB CC IPL)—Bits 1–0

This field is used to set the interrupt priority level for IRQs. This IRQ is limited to priorities 0 through 2. They are disabled by default.

- 00 = IRQ disabled (default)
- 01 = IRQ is priority level 0
- 10 = IRQ is priority level 1
- 11 = IRQ is priority level 2



### 5.5.6 Vector Base Address Register (VBA)

Base + \$5	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0	
Read	0	0		VECTOR_BASE_ADDRESS													
Write				VECTOR_BASE_ADDRESS													
RESET <sup>1</sup>	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	

<sup>1.</sup> The 56F8014 resets to a value of 0x0000. This corresponds to reset addresses of 0x00 0000.

Figure 5-8 Vector Base Address Register (VBA)

#### 5.5.6.1 Reserved—Bits15—14

This bit field is reserved or not implemented. It is read as 0 and cannot be modified by writing.

#### 5.5.6.2 Vector Address Bus (VAB)—Bits 13—0

The value in this register is used as the upper 14 bits of the interrupt vector VAB[20:0]. The lower 7 bits are determined based on the highest priority interrupt and are then appended onto VBA before presenting the full VAB to the Core.

### 5.5.7 Fast Interrupt Match 0 Register (FIM0)

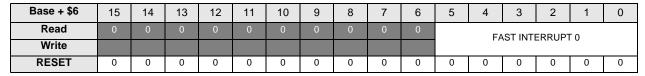


Figure 5-9 Fast Interrupt Match 0 Register (FIM0)

#### 5.5.7.1 Reserved—Bits 15–6

This bit field is reserved or not implemented. It is read as 0 and cannot be modified by writing.

## 5.5.7.2 Fast Interrupt 0 Vector Number (FAST INTERRUPT 0)—Bits 5–0

These values determine which IRQ will be Fast Interrupt 0. Fast Interrupts vector directly to a service routine based on values in the Fast Interrupt Vector Address registers without having to go to a jump table first. IRQs used as Fast Interrupts *must* be set to priority level 2. Unexpected results will occur if a Fast Interrupt vector is set to any other priority. A Fast Interrupt automatically becomes the highest-priority level 2 interrupt regardless of its location in the interrupt table prior to being declared as Fast Interrupt. Fast Interrupt 0 has priority over fast Interrupt 1. To determine the vector number of each IRQ, refer to the vector table.



## 5.5.8 Fast Interrupt 0 Vector Address Low Register (FIVAL0)

Base + \$7	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
Read		FAST INTERRUPT 0 VECTOR ADDRESS LOW														
Write		FAST INTERRUPT 0 VECTOR ADDRESS LOW														
RESET	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0

Figure 5-10 Fast Interrupt 0 Vector Address Low Register (FIVAL0)

#### 5.5.8.1 Fast Interrupt 0 Vector Address Low (FIVAL0)—Bits 15—0

The lower 16 bits of the vector address used for Fast Interrupt 0. This register is combined with FIVAH0 to form the 21-bit vector address for Fast Interrupt 0 defined in the FIM0 register.

### 5.5.9 Fast Interrupt 0 Vector Address High Register (FIVAH0)

Base + \$8	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
Read	0	0	0	0	0	0	0	0	0	0	0	FAS		RRUPT		OR
Write													ADD	RESS F	lIGH	
RESET	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0

Figure 5-11 Fast Interrupt 0 Vector Address High Register (FIVAH0)

#### 5.5.9.1 Reserved—Bits 15-5

This bit field is reserved or not implemented. It is read as 0 and cannot be modified by writing.

## 5.5.9.2 Fast Interrupt 0 Vector Address High (FIVAH0)—Bits 4–0

The upper five bits of the vector address used for Fast Interrupt 0. This register is combined with FIVAL0 to form the 21-bit vector address for Fast Interrupt 0 defined in the FIM0 register.

## 5.5.10 Fast Interrupt 1 Match Register (FIM1)

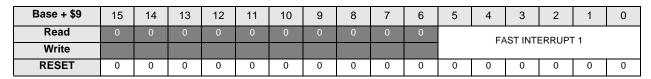


Figure 5-12 Fast Interrupt 1 Match Register (FIM1)

#### 5.5.10.1 Reserved—Bits 15-6

This bit field is reserved or not implemented. It is read as 0 and cannot be modified by writing.

## 5.5.10.2 Fast Interrupt 1 Vector Number (FAST INTERRUPT 1)—Bits 5–0

These values determine which IRQ will be Fast Interrupt 1. Fast Interrupts vector directly to a service routine based on values in the Fast Interrupt Vector Address registers without having to go to a jump table first. IRQs used as Fast Interrupts *must* be set to priority level 2. Unexpected results will occur if a Fast



Interrupt vector is set to any other priority. A Fast Interrupt automatically becomes the highest-priority level 2 interrupt regardless of its location in the interrupt table prior to being declared as Fast Interrupt. Fast Interrupt 0 has priority over Fast Interrupt 1. To determine the vector number of each IRQ, refer to the vector table.

## 5.5.11 Fast Interrupt 1 Vector Address Low Register (FIVAL1)

Base + \$A	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
Read						FASTIN	ITERRI	IDT 1 \/F	CTOR	ADDRES	SSIOW					
Write		FAST INTERRUPT 1 VECTOR ADDRESS LOW														
RESET	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0

Figure 5-13 Fast Interrupt 1 Vector Address Low Register (FIVAL1)

#### 5.5.11.1 Fast Interrupt 1 Vector Address Low (FIVAL1)—Bits 15–0

The lower 16 bits of the vector address used for Fast Interrupt 1. This register is combined with FIVAH1 to form the 21-bit vector address for Fast Interrupt 1 defined in the FIM1 register.

## 5.5.12 Fast Interrupt 1 Vector Address High Register (FIVAH1)

Base + \$B	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
Read	0	0	0	0	0	0	0	0	0	0	0	FA		RRUPT		OR
Write												ADDRESS HIGH				
RESET	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0

Figure 5-14 Fast Interrupt 1 Vector Address High Register (FIVAH1)

#### 5.5.12.1 Reserved—Bits 15-5

This bit field is reserved or not implemented. It is read as 0 and cannot be modified by writing.

## 5.5.12.2 Fast Interrupt 1 Vector Address High (FIVAH1)—Bits 4-0

The upper five bits of the vector address are used for Fast Interrupt 1. This register is combined with FIVAL1 to form the 21-bit vector address for Fast Interrupt 1 defined in the FIM1 register.

## 5.5.13 IRQ Pending Register 0 (IRQP0)

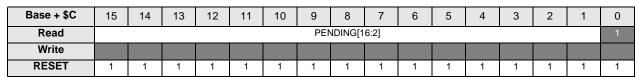


Figure 5-15 IRQ Pending Register 0 (IRQP0)

## 5.5.13.1 IRQ Pending (PENDING)—Bits 15–1

This register combines with IRQP1 and IRQP2 to represent the pending IRQs for interrupt vector numbers 2 through 45.

56F8014 Technical Data, Rev. 11



- 0 = IRQ pending for this vector number
- 1 = No IRQ pending for this vector number

#### 5.5.13.2 Reserved—Bit 0

This bit is reserved or not implemented. It is read as 1 and cannot be modified by writing.

#### 5.5.14 IRQ Pending Register 1 (IRQP1)

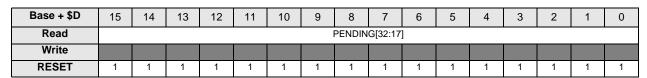


Figure 5-16 IRQ Pending Register 1 (IRQP1)

#### 5.5.14.1 IRQ Pending (PENDING)—Bits 32-17

This register combines with IRQP0 and IRQP2 to represent the pending IRQs for interrupt vector numbers 2 through 45.

- 0 = IRQ pending for this vector number
- 1 = No IRQ pending for this vector number

## 5.5.15 IRQ Pending Register 2 (IRQP2)

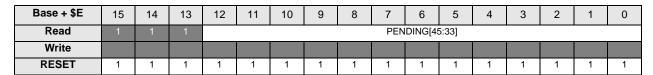


Figure 5-17 IRQ Pending Register 2 (IRQP2)

## 5.5.15.1 IRQ Pending (PENDING)—Bits 45-33

This register combines with IRQP0 and IRQP1 to represent the pending IRQs for interrupt vector numbers 2 through 45.

- 0 = IRQ pending for this vector number
- 1 = No IRQ pending for this vector number

## 5.5.16 Interrupt Control Register (ICTRL)

\$Base + \$12	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
Read	INT	IP	IC		VAB								1	1	0	0
Write											DIS					
RESET	0	0	0	0	0	0	0	0	0	0	0	1	1	1	0	0

Figure 5-18 Interrupt Control Register (ICTRL)

Freescale Semiconductor 59

56F8014 Technical Data, Rev. 11



#### 5.5.16.1 Interrupt (INT)—Bit 15

This *read-only* bit reflects the state of the interrupt to the 56800E core.

- 0 = No interrupt is being sent to the 56800E core
- 1 = An interrupt is being sent to the 56800E core

#### 5.5.16.2 Interrupt Priority Level (IPIC)—Bits 14–13

These *read-only* bits reflect the state of the new interrupt priority level bits being presented to the 56800E core. These bits indicate the priority level needed for a new IRQ to interrupt the current interrupt being sent to the 56800E core. This field is only updated when the 56800E core jumps to a new interrupt service routine.

**Note:** Nested interrupts may cause this field to be updated before the original interrupt service routine can read it.

- 00 =Required nested exception priority levels are 0, 1, 2, or 3
- 01 = Required nested exception priority levels are 1, 2, or 3
- 10 = Required nested exception priority levels are 2 or 3

10

11

• 11 = Required nested exception priority level is 3

IPIC_VALUE[1:0]	Current Interrupt Priority Level	Required Nested Exception Priority
00	No interrupt or SWILP	Priorities 0, 1, 2, 3
01	Priority 0	Priorities 1, 2, 3

Priorities 2, 3

Priority 3

**Table 5-3 Interrupt Priority Encoding** 

## 5.5.16.3 Vector Number - Vector Address Bus (VAB)—Bits 12-6

This *read-only* field shows the vector number (VAB[6:0]) used at the time the last IRQ was taken. In the case of a Fast Interrupt, it shows the lower address bits of the jump address. This field is only updated when the 56800E core jumps to a new interrupt service routine.

Priority 1

Priority 2 or 3

**Note:** Nested interrupts may cause this field to be updated before the original interrupt service routine can read it.

## 5.5.16.4 Interrupt Disable (INT\_DIS)—Bit 5

This bit allows all interrupts to be disabled.

- 0 = Normal operation (default)
- 1 = All interrupts disabled



#### 5.5.16.5 Reserved—Bits 4-2

This bit field is reserved or not implemented. It is read as 1 and cannot be modified by writing.

#### 5.5.16.6 Reserved—Bits 1-0

This bit field is reserved or not implemented. It is read as 0 and cannot be modified by writing.

#### 5.6 Resets

#### 5.6.1 General

**Table 5-4 Reset Summary** 

Reset	Priority	Source	Characteristics
Core Reset		RST	Core reset from the SIM

## 5.6.2 Description of Reset Operation

#### 5.6.2.1 Reset Handshake Timing

The ITCN provides the 56800E core with a reset vector address on the VAB pins whenever  $\overline{\text{RESET}}$  is asserted from the SIM. The reset vector will be presented until the second rising clock edge after  $\overline{\text{RESET}}$  is released. The general timing is shown in **Figure 5-19**.

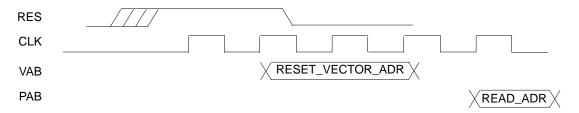


Figure 5-19 Reset Interface

#### 5.6.3 ITCN After Reset

After reset, all of the ITCN registers are in their default states. This means all interrupts are disabled, except the core IRQs with fixed priorities:

- Illegal Instruction
- SW Interrupt 3
- HW Stack Overflow
- Misaligned Long Word Access
- SW Interrupt 2
- SW Interrupt 1



- SW Interrupt 0
- SW Interrupt LP

These interrupts are enabled at their fixed priority levels.

## Part 6 System Integration Module (SIM)

#### 6.1 Introduction

The SIM module is a system catchall for the glue logic that ties together the system-on-chip. It controls distribution of resets and clocks and provides a number of control features. The System Integration Module is responsible for the following functions:

- Reset sequencing
- Clock control & distribution
- Stop/Wait control
- System status registers
- Registers for software access to the JTAG ID of the chip
- Test registers
- Power control
- I/O pad multiplexing

These are discussed in more detail in the sections that follow.

### 6.2 Features

The SIM has the following features:

- Reset sequencing
  - Core and Peripheral Clock control & distribution
  - Stop/Wait mode control
  - System status
  - Power control
  - Control I/O multiplexing
- System bus clocks with pipeline hold-off support
- System clocks for non-pipelined interfaces
- Peripheral clocks for Quad Timer and PWM with high-speed (3X) option
- Power-saving clock gating for peripherals
- Three power modes (Run, Wait, Stop) to control power utilization
  - Stop mode shuts down the 56800E core, system clock, and peripheral clock
  - Wait mode shuts down the 56800E core and unnecessary system clock operation
  - Run mode supports full part operation
- Controls, with write protection, the enable/disable of 56800E core WAIT and STOP instructions



- Controls, with write protection, the enable/disable of Large Regulator Standby mode
- Controls to route functional signals to selected peripherals and I/O pads
- Controls deassertion sequence of internal resets
- Software-initiated reset
- Four 16-bit registers reset only by a Power-On Reset usable for general-purpose software control
- Timer channel Stop mode clocking controls
- SCI Stop mode clocking control to support LIN Sleep mode stop recovery
- Short addressing location control
- Registers for containing the JTAG ID of the chip
- Controls output to CLKO pin

56F8014 Technical Data, Rev. 11 Freescale Semiconductor 63



## **6.3 Register Descriptions**

Table 6-1 SIM Registers (SIM\_BASE = \$00 F140)

Address Offset	Address Acronym	Register Name	Section Location
Base + \$0	SIM_CTRL	Control Register	6.3.1
Base + \$1	SIM_RSTAT	Reset Status Register	6.3.2
Base + \$2	SIM_SWC0	Software Control Register 0	6.3.3
Base + \$3	SIM_SWC1	Software Control Register 1	6.3.3
Base + \$4	SIM_SWC2	Software Control Register 2	6.3.3
Base + \$5	SIM_SWC3	Software Control Register 3	6.3.3
Base + \$6	SIM_MSHID	Most Significant Half of JTAG ID	6.3.4
Base + \$7	SIM_LSHID	Least Significant Half of JTAG ID	6.3.5
Base + \$8	SIM_PWR	Power Control Register	6.3.6
		Reserved	
Base + \$A	SIM_CLKOUT	CLKO Select Register	6.3.7
Base + \$B	SIM_GPS	GPIO Peripheral Select Register	6.3.8
Base + \$C	SIM_PCE	Peripheral Clock Enable Register	6.3.9
Base + \$D	SIM_IOSAHI	I/O Short Address Location High Register	6.3.10
Base + \$E	SIM_IOSALO	I/O Short Address Location Low Register	6.3.10



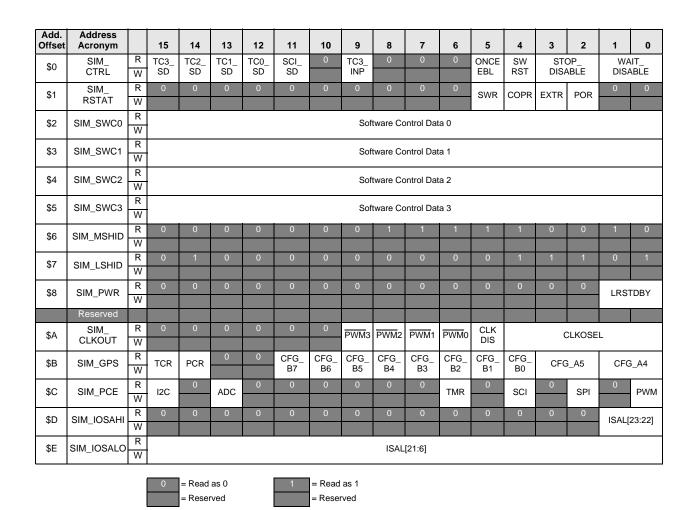


Figure 6-1 SIM Register Map Summary

## 6.3.1 SIM Control Register (SIM\_CTRL)

Base + \$0	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
Read	TC3_	TC2_	TC1_		SCI_	0	TC3_	0	0	0	ONCE	SW	STO	_	WA	
Write	SD	SD	SD	SD	SD		INP				EBL	RST	DISA	BLE	DISA	ABLE
RESET	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0

Figure 6-2 SIM Control Register (SIM\_CTRL)

### 6.3.1.1 Timer Channel 3 Stop Disable (TC3\_SD)—Bit 15

This bit enables the operation of the Timer Channel 3 peripheral clock in Stop mode.

• 0 = Timer Channel 3 disabled in Stop mode



• 1 = Timer Channel 3 enabled in Stop mode

#### 6.3.1.2 Timer Channel 2 Stop Disable (TC2\_SD)—Bit 14

This bit enables the operation of the Timer Channel 2 peripheral clock in Stop mode.

- 0 = Timer Channel 2 disabled in Stop mode
- 1 = Timer Channel 2 enabled in Stop mode

#### 6.3.1.3 Timer Channel 1 Stop Disable (TC1\_SD)—Bit 13

This bit enables the operation of the Timer Channel 1 peripheral clock in Stop mode.

- 0 = Timer Channel 1 disabled in Stop mode
- 1 = Timer Channel 1 enabled in Stop mode

#### 6.3.1.4 Timer Channel 0 Stop Disable (TC0\_SD)—Bit 12

This bit enables the operation of the Timer Channel 0 peripheral clock in Stop mode.

- 0 = Timer Channel 0 disabled in Stop mode
- 1 = Timer Channel 0 enabled in Stop mode

#### 6.3.1.5 SCI Stop Disable (SCI\_SD)—Bit 11

This bit enables the operation of the SCI peripheral clock in Stop mode. This is recommended for use in LIN mode so that the SCI can generate interrupts and recover from Stop mode while the LIN interface is in Sleep mode and using Stop mode to reduce power consumption.

- 0 = SCI disabled in Stop mode
- 1 = SCI enabled in Stop mode

#### 6.3.1.6 Reserved—Bit 10

This bit field is reserved or not implemented. It is read as 0 and cannot be modified by writing.

## 6.3.1.7 Timer Channel 3 Input (TC3\_INP)—Bit 9

This bit selects the input of Timer Channel 3 to be from the PWM sync signal or GPIO pin.

- 1 = Timer Channel 3 Input from PWM sync signal
- 0 = Timer Channel 3 Input controlled by SIM GPS register CFG B3 and CFG A5 fields

#### 6.3.1.8 Reserved—Bits 8–6

This bit field is reserved or not implemented. It is read as 0 and cannot be modified by writing.

#### 6.3.1.9 OnCE Enable (ONCEEBL)—Bit 5

- 0 = OnCE clock to 56800E core enabled when core TAP is enabled
- 1 = OnCE clock to 56800E core is always enabled

## 6.3.1.10 Software Reset (SWRST)—Bit 4

Writing 1 to this field will cause the part to reset.

67



#### 6.3.1.11 Stop Disable (STOP\_DISABLE[1:0])—Bits 3–2

- 00 = Stop mode will be entered when the 56800E core executes a STOP instruction
- 01 = The 56800E STOP instruction will not cause entry into Stop mode
- 10 = Stop mode will be entered when the 56800E core executes a STOP instruction and the STOP\_DISABLE field is write-protected until the next reset
- 11 = The 56800E STOP instruction will not cause entry into Stop mode and the STOP\_DISABLE field is write-protected until the next reset

### 6.3.1.12 Wait Disable (WAIT\_DISABLE[1:0])—Bits 1–0

- 00 = Wait mode will be entered when the 56800E core executes a WAIT instruction
- 01 = The 56800E WAIT instruction will not cause entry into Wait mode
- 10 = Wait mode will be entered when the 56800E core executes a WAIT instruction and the WAIT\_DISABLE field is write-protected until the next reset
- 11 = The 56800E WAIT instruction will not cause entry into Wait mode and the WAIT\_DISABLE field is write-protected until the next reset

### 6.3.2 SIM Reset Status Register (SIM\_RSTAT)

This register is updated upon any system reset and indicates the cause of the most recent reset. It also controls whether the COP reset vector or regular reset vector in the vector table is used. This register is asynchronously reset during Power-On Reset (see power supervisor module) and subsequently is synchronously updated based on the level of the external reset, software reset, or cop reset inputs. Only one source will ever be indicated. In the event that multiple reset sources assert simultaneously, the highest-precedence source will be indicated. The precedence from highest to lowest is POR, EXTR, COPR, and SWR. While POR is always set during a Power-On Reset, EXTR will become set if the external reset pin is asserted or remains asserted after the Power-On Reset (POR) has deasserted.

Base + \$1	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
Read	0	0	0	0	0	0	0	0	0	0	SWR	COPR	EXTR	POR	0	0
Write											OVVIC	00110	LXIIX	1 010		
RESET	0	0	0	0	0	0	0	0	0	0					0	0

Figure 6-3 SIM Reset Status Register (SIM\_RSTAT)

#### 6.3.2.1 Reserved—Bits 15–6

This bit field is reserved or not implemented. It is read as zero and cannot be modified by writing.

## 6.3.2.2 Software Reset (SWR)—Bit 5

When set, this bit indicates that the previous system reset occurred as a result of a software reset (written 1 to SW RST bit in the SIM\_CTRL register). It will not be set if a COP, external, or POR reset also occurred.

## 6.3.2.3 COP Reset (COPR)—Bit 4

When set, this bit indicates that the previous system reset was caused by the Computer Operating Properly

56F8014 Technical Data, Rev. 11



(COP) timer. It will not be set if an external or POR reset also occurred. If COPR is set as code starts executing, the COP reset vector in the vector table will be used. Otherwise, the normal reset vector is used.

#### 6.3.2.4 External Reset (EXTR)—Bit 3

When set, this bit indicates that the previous system reset was caused by an external reset. It will only be set if the external reset pin was asserted or remained asserted after the Power-On Reset deasserted.

#### Power-On Reset (POR)—Bit 2 6.3.2.5

This bit is set during a Power-On Reset.

#### 6.3.2.6 Reserved—Bits 1–0

This bit field is reserved or not implemented. It is read as 0 and cannot be modified by writing.

#### SIM Software Control Registers (SIM\_SWC0, SIM\_SWC1, 6.3.3 SIM\_SWC2, and SIM\_SWC3)

Only SIM SWC0 is shown in this section. SIM SWC1, SIM SWC2, and SIM SWC3 are identical in functionality.

Base + \$2	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
Read							Softw	are Con	trol Data	. 0						
Write		Software Control Data 0														
RESET	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0

Figure 6-4 SIM Software Control Register 0 (SIM SWC0)

#### 6.3.3.1 Software Control Data 0 (FIELD)—Bits 15–0

This register is reset only by the Power-On Reset (POR). It has no part-specific functionality and is intended for use by a software developer to contain data that will be unaffected by the other reset sources (RESET pin, software reset, and COP reset).

#### 6.3.4 Most Significant Half of JTAG ID (SIM MSHID)

This read-only register displays the most significant half of the JTAG ID for the chip. This register reads \$01F2.

Base + \$6	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
Read	0	0	0	0	0	0	0	1	1	1	1	1	0	0	1	0
Write																
RESET	0	0	0	0	0	0	0	1	1	1	1	1	0	0	1	0

Figure 6-5 Most Significant Half of JTAG ID (SIM\_MSHID)

69



## 6.3.5 Least Significant Half of JTAG ID (SIM\_LSHID)

This read-only register displays the least significant half of the JTAG ID for the chip. This register reads \$401D.

Base + \$7	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
Read	0	1	0	0	0	0	0	0	0	0	0	1	1	1	0	1
Write																
RESET	0	1	0	0	0	0	0	0	0	0	0	1	1	1	0	1

Figure 6-6 Least Significant Half of JTAG ID (SIM\_LSHID)

#### 6.3.6 SIM Power Control Register (SIM\_PWR)

This register controls the Standby mode of the large regulator. The large regulator derives the core digital logic power supply from the IO power supply. In some circumstances, the large regulator may be put in a reduced-power Standby mode without interfering with part operation. Refer to the overview of power-down modes and the overview of clock generation for more information on the use of large regulator standby.

Base + \$8	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
Read	0	0	0	0	0	0	0	0	0	0	0	0	0	0	LRSTDBY	
Write															Litto	
RESET	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0

Figure 6-7 SIM Power Control Register (SIM\_PWR)

#### 6.3.6.1 Reserved—Bits 15-2

This bit field is reserved or not implemented. It is read as 0 and cannot be modified by writing.

## 6.3.6.2 Large Regulator Standby Mode[1:0] (LRSTDBY)—Bits 1–0

This bit controls the pull-up resistors on the  $\overline{IRQA}$  pin.

- 00 = Large regulator is in Normal mode
- 01 = Large regulator is in Standby (reduced-power) mode
- 10 = Large regulator is in Normal mode and the LRSTDBY field is write-protected until the next reset
- 11 = Large regulator is in Standby mode and the LRSTDBY field is write-protected until the next reset

**Note:** Standby mode can be used when the device operates below 200 kHz if the PLL is shut down.

## 6.3.7 CLKO Select Register (SIM\_CLKOUT)

The CLKO select register can be used to multiplex out selected clocks generated inside the clock generation and SIM modules. All functionality is for test purposes only and is subject to unspecified latencies. Glitches may be produced when the clock is enabled or switched.

56F8014 Technical Data, Rev. 11



The lower four bits of the GPIO A register can function as GPIO, PWM, or as additional clock output signals. GPIO has priority and is enabled/disabled via the GPIOA\_PEREN. If GPIOA[3:0] are programmed to operate as peripheral outputs, then the choice between PWM and additional clock outputs is done here in the CLKOUT. The default state is for the peripheral function of GPIOA[3:0] to be programmed as PWM. This can be changed by altering PWM3 through PWM0.

Base + \$A	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
Read	0	0	0	0	0	0	PWM	PWM	PWM1	PWM0	CLK		C	LKOSE	1	
Write							3	2		1 ********	DIS	CERCOLE				
RESET	0	0	0	0	0	0	0	0	0	0	1	0	0	0	0	0

Figure 6-8 CLKO Select Register (SIM\_CLKOUT)

#### 6.3.7.1 Reserved—Bits 15-10

This bit field is reserved or not implemented. It is read as 0 and cannot be modified by writing.

#### 6.3.7.2 PWM3—Bit 9

- 0 = Peripheral output function of GPIOA[3] is defined to be  $\overline{\text{PWM}3}$
- 1 = Peripheral output function of GPIOA[3] is defined to be the Relaxation Oscillator Clock

#### 6.3.7.3 PWM2—Bit 8

- 0 = Peripheral output function of GPIOA[2] is defined to be  $\overline{\text{PWM}2}$
- 1 = Peripheral output function of GPIOA[2] is defined to be the system clock

### 6.3.7.4 **PWM**1—Bit 7

- 0 = Peripheral output function of GPIOA[1] is defined to be  $\overline{\text{PWM}}$ 1
- 1 = Peripheral output function of GPIOA[1] is defined to be two times the rate of the system clock

## 6.3.7.5 **PWM**0—Bit 6

- $0 = \text{Peripheral output function of GPIOA}[0] \text{ is defined to be } \overline{\text{PWM}}0$
- 1 = Peripheral output function of GPIOA[0] is defined to be three times the rate of the system clock

## 6.3.7.6 Clockout Disable (CLKDIS)—Bit 5

- 0 = CLKOUT output is enabled and will output the signal indicated by CLKOSEL
- 1 = CLKOUT is 0

## 6.3.7.7 Clockout Select (CLKOSEL)—Bits 4–0

Selects clock to be muxed out on the CLKO pin.

- 00000 = Reserved for factory test—Continuous system clock
- 01001 = Reserved for factory test—OCCS MSTR OSC clock
- 01011 = Reserved for factory test—ADC clock
- 01100 = Reserved for factory test—JTAG TCLK

71



- 01101 = Reserved for factory test—Continuous peripheral clock
- 01110 = Reserved for factory test—Continuous inverted peripheral clock
- 01111 = Reserved for factory test—Continuous high-speed peripheral clock

### 6.3.8 SIM GPIO Peripheral Select Register (SIM\_GPS)

All of the peripheral pins on the 56F8014 share their Input/Output (I/O) with GPIO ports. To select peripheral or GPIO control, program the corresponding bit in the GPIOx\_PEREN register in the GPIO module. (See *MC56F8000RM*, the 56F801x Peripheral Reference Manual, for details.) In some cases, there are two possible peripherals as well as the GPIO functionality available for control of the I/O. In these cases, the SIM\_GPS register is used to determine which peripheral has control when the corresponding I/O pin is configured in peripheral mode.

As shown in **Figure 6-9**, the GPIO Peripheral Enable Register (PEREN) has the final control over which pin controls the I/O. SIM\_GPS simply decides which peripheral will be routed to the I/O when PEREN = 1.

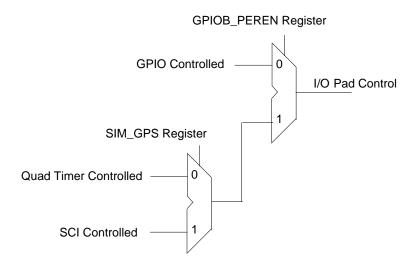


Figure 6-9 Overall Control of Pads Using SIM\_GPS Control

Base + \$B	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
Read	TCR	PCR	0	0	CFG_		CFG_	CFG_		CFG_		CFG_	CFG	Δ5	CEG	6_A4
Write	TOR	I OK			B7	B6	B5	B4	В3	B2	B1	В0	0.0	,1 O_A3		
RESET	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0

Figure 6-10 GPIO Peripheral Select Register (SIM\_GPS)

## 6.3.8.1 Quad Timer Clock Rate (TCR)—Bit 15

This bit selects the clock speed for the Quad Timer module.

- 0 = Quad Timer module clock rate equals system clock rate, to a maximum 32 MHz (default)
- 1 = Quad Timer module clock rate equals three times system clock rate, to a maximum 96 MHz



**Note:** This bit should only be changed while the Quad Timer module's clock is disabled. See **Section 6.3.9**.

**Note:** High-speed clocking is only available when the PLL is being used.

**Note:** If the PWM sync signal is used as input to Timer 3 (See SIM\_CTRL: TC3\_INP, Section 6.3.1.7), then the clocks of the Quad Timer and PWM must be related, as shown in Table 6-2.

#### 6.3.8.2 PWM Clock Rate (PCR)—Bit 14

This bit selects the clock speed for the PWM module.

- 0 = PWM module clock rate equals system clock rate, to a maximum 32 MHz (default)
- 1 = PWM module clock rate equals three times system clock rate, to a maximum 96 MHz

**Note:** This bit should only be changed while the PWM module's clock is disabled. See Section 6.3.9.

**Note:** High-speed clocking is only available when the PLL is being used.

**Note:** If the PWM sync signal is used as input to Timer 3 (See SIM\_CTRL: TC3\_INP, Section 6.3.1.7), then the clocks of the Quad Timer and PWM must be related, as shown in Table 6-2.

Table 6-2 Allowable Quad Timer and PWM Clock Rates when Using PWM Reload Pulse

		Quad Timer					
	Clock Speed	1X	3X				
PWM	1X	ок	ок				
F VVIVI	3X	NO	ок				

#### 6.3.8.3 Reserved—Bits 13-12

This bit field is reserved or not implemented. It is read as 0 and cannot be modified by writing.

#### 6.3.8.4 Configure GPIOB7 (CFG\_B7)—Bit 11

This bit selects the alternate function for GPIOB7.

- 0 = TXD SCI Transmit Data (default)
- $1 = SCL I^2C$  Serial Clock

### 6.3.8.5 Configure GPIOB6 (CFG\_B6)—Bit 10

This bit selects the alternate function for GPIOB6.

- 0 = RXD SCI Receive Data (default)
- $1 = SDA I^2C$  Serial Data

**Note:** The PRECS bit in the OCCS Oscillator Control register can enable this pin as the



source clock to the chip. In this mode, make sure that no on-chip peripheral (including the GPIO) is driving this pin.

## 6.3.8.6 Configure GPIOB5 (CFG\_B5)—Bit 9

This bit selects the alternate function for GPIOB5.

- 0 = T1 Timer channel 1 input/output (default)
- 1 = FAULT3 PWM FAULT3 input

#### 6.3.8.7 Configure GPIOB4 (CFG B4)—Bit 8

This bit selects the alternate function for GPIOB4.

- 0 = T0 Timer channel 0 input/output (default)
- 1 = CLKO Clock output

#### 6.3.8.8 Configure GPIOB3 (CFG\_B3)—Bit 7

This bit selects the alternate function for GPIOB3.

- 0 = MOSI SPI master out/slave in (default)
- 1 = T3 Timer channel 3 input/output

#### 6.3.8.9 Configure GPIOB2 (CFG B2)—Bit 6

This bit selects the alternate function for GPIOB2.

- 0 = MISO SPI master in/slave out (default)
- 1 = T2 Timer channel 2 input/output

## 6.3.8.10 Configure GPIOB1 (CFG\_B1)—Bit 5

This bit selects the alternate function for GPIOB1.

- 0 = SS SPI Slave Select (default)
- $1 = SDA I^2C$  Serial Data

#### 6.3.8.11 Configure GPIOB0 (CFG\_B0)—Bit 4

This bit selects the alternate function for GPIOB0.

- 0 = SCLK SPI Serial Clock (default)
- 1 = SCL I2C Serial Clock

## 6.3.8.12 Configure GPIOA5[1:0] (CFG\_A5)—Bits 3-2

These bits select the alternate function for GPIOA5.

- 00 = PWM5 PWM5 output (default)
- 01 = PWM5 PWM5 output
- 10 = FAULT2 PWM FAULT2 input



• 11 = T3 — Timer Channel 3 input/output

#### 6.3.8.13 Configure GPIOA4[1:0] (CFG\_A4)—Bits 1–0

These bits select the alternate function for GPIOA4.

- 00 = PWM4 PWM4 output
- 01 = PWM4 PWM4 output
- 10 = FAULT1 PWM FAULT1 input
- 11 = T2 Timer Channel 2 input/output

Note:

When programming the CFG\_\* signals be careful so as not to connect two different I/O pins to the same peripheral input. For example, do not set CFG\_B7 to select SCL and also set CFG\_B0 to select SCL. If this occurs for an output signal, then the signal will be routed to two I/O pins. For input signals, the values on the two I/O pins will be ORed together before reaching the peripheral.

### 6.3.9 Peripheral Clock Enable Register (SIM\_PCE)

The Peripheral Clock Enable register is used to enable or disable clocks to the peripherals as a power savings feature. The clocks can be individually controlled for each peripheral on the chip. The corresponding peripheral should itself be disabled while its clock is shut off.

Base + \$C	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
Read	I2C	0	ADC	0	0	0	0	0	0	TMR	0	SCI	0	SPI	0	PWM
Write	120		, NDO							TIVITY		001		011		1 00101
RESET	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0

Figure 6-11 Peripheral Clock Enable Register (SIM\_PCE)

## 6.3.9.1 I<sup>2</sup>C Clock Enable (I2C)—Bit 15

- $0 = \text{The clock is not provided to the } I^2C \text{ module (the } I^2C \text{ module is disabled)}$
- $1 = \text{Clocks to the } I^2C \text{ module are enabled}$

#### 6.3.9.2 Reserved—Bit 14

This bit field is reserved or not implemented. It is read as 0 and cannot be modified by writing.

## 6.3.9.3 Analog-to-Digital Converter IPBus Clock Enable (ADC)—Bit 13

- 0 =The clock is not provided to the ADC module (the ADC module is disabled)
- 1 = Clocks to the ADC module are enabled

#### 6.3.9.4 Reserved—Bits 12–7

This bit field is reserved or not implemented. It is read as 0 and cannot be modified by writing.

#### 6.3.9.5 Timer Clock Enable (TMR)—Bit 6

• 0 = The clock is not provided to the Quad Timer module (the Quad Timer module is disabled)



• 1 = Clocks to the Quad Timer module are enabled

#### 6.3.9.6 Reserved—Bit 5

This bit field is reserved or not implemented. It is read as 0 and cannot be modified by writing.

#### 6.3.9.7 SCI IPBus Clock Enable (SCI)—Bit 4

- 0 =The clock is not provided to the SCI module (the SCI module is disabled)
- 1 = Clocks to the SCI module are enabled

#### 6.3.9.8 Reserved—Bit 3

This bit field is reserved or not implemented. It is read as 0 and cannot be modified by writing.

#### 6.3.9.9 SPI Clock Enable (SPI)—Bit 2

- 0 = The clock is not provided to the SPI module (the SPI module is disabled)
- 1 = Clocks to the SPI module are enabled

#### 6.3.9.10 Reserved—Bit 1

This bit field is reserved or not implemented. It is read as 0 and cannot be modified by writing.

#### 6.3.9.11 PWM Clock Enable (PWM)—Bit 0

- 0 =The clock is not provided to the PWM module (the PWM module is disabled)
- 1 = Clocks to the PWM module are enabled

# 6.3.10 I/O Short Address Location Register (SIM\_IOSAHI and SIM\_IOSALO)

The I/O Short Address Location registers are used to specify the memory referenced via the I/O short address mode. The I/O short address mode allows the instruction to specify the lower six bits of address; the upper address bits are not directly controllable. This register set allows limited control of the full address, as shown in **Figure 6-12**.



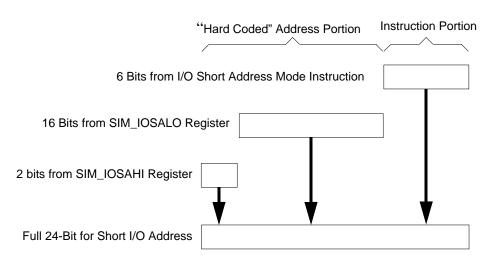


Figure 6-12 I/O Short Address Determination

With this register set, an interrupt driver can set the SIM\_IOSALO register pair to point to its peripheral registers and then use the I/O Short addressing mode to reference them. The ISR should restore this register to its previous contents prior to returning from interrupt.

**Note:** The default value of this register set points to the EOnCE registers.

**Note:** The pipeline delay between setting this register set and using short I/O addressing with the new value

is five instruction cycles.

Base + \$D	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
Read	0	0	0	0	0	0	0	0	0	0	0	0	0	0	ISAL[	23.221
Write															IO/ (L[/	20.22]
RESET	0	0	0	0	0	0	0	0	0	0	0	0	0	0	1	1

Figure 6-13 I/O Short Address Location High Register (SIM\_IOSAHI)

#### 6.3.10.1 Reserved—Bits 15—2

This bit field is reserved or not implemented. It is read as 0 and cannot be modified by writing.

#### 6.3.10.2 Input/Output Short Address Location (ISAL[23:22])—Bit 1–0

This field represents the upper two address bits of the "hard coded" I/O short address.



Base + \$E	15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
Read								ISAI	[21:6]							
Write								IOAL	-[21.0]							
RESET	1	1	1	1	1	1	1	1	1	1	1	1	1	1	1	1

Figure 6-14 I/O Short Address Location Low Register (SIM\_IOSALO)

#### 6.3.10.3 Input/Output Short Address Location (ISAL[21:6])—Bit 15-0

This field represents the lower 16 address bits of the "hard coded" I/O short address.

#### 6.4 Clock Generation Overview

The SIM uses master clocks, 2X system clock at a maximum of 64 MHz, from the OCCS module to produce the peripheral and system (core and memory) clocks at a maximum of 32 MHz. It divides the master clock by two and gates it with appropriate power mode and clock gating controls. The high speed peripheral clock input from OCCS operates at three times the system clock for PWM and Quad Timer module at a maximum of 96 MHz.

The OCCS configuration controls the operating frequency of the SIM's master clocks. In the OCCS, either an external clock or the relaxation oscillator can be selected as the master clock source (MSTR\_OSC). When selected, the relaxation oscillator can be operated at full speed (8 MHz), standby speed (200 kHz), or powered down. An 8 MHz clock can be multiplied to 192 MHz using the PLL and postscaled to provide a variety of high speed clock rates. Either the postscaled PLL output or the input clock of the PLL signal can be selected to produce the master clocks to the SIM. When the PLL is not selected, the high speed peripheral clock is disabled and the 2x system clock is the input clock from either the internal relaxation oscillator or from an external clock source.

In combination with the OCCS module, the SIM provides power modes (see Section 6.5), clock enables (SIM\_PCE register, CLK\_DIS, ONCE\_EBL), and clock rate controls (TCR, PCR) to provide flexible control of clocking and power utilization. The SIM's clock enable controls can be used to disable individual clocks when not needed. The clock rate controls enable the high speed clocking option for the Timer channels and PWM but require the PLL to be on and selected. Refer to the 56F801X Peripheral Reference Manual for further details.

## 6.5 Power-Down Modes

The 56F8014 operates in one of five Power-Down modes, as shown in **Table 6-3**.

**Table 6-3 Clock Operation in Power-Down Modes** 

Mode	Core Clocks	Peripheral Clocks	Description
Run	Core and memory clocks disabled	Peripheral clocks enabled	Device is fully functional



**Table 6-3 Clock Operation in Power-Down Modes (Continued)** 

Mode	Core Clocks	Peripheral Clocks	Description
Wait	Core and memory clocks disabled	Peripheral clocks enabled	Core executes WAIT instruction to enter this mode.  Typically used for power-conscious applications. Possible recoveries from Wait mode to Run mode are:  1. Any interrupt 2. Executing a Debug mode entry command during the 56800E core JTAG interface 2. Any reset (POR, external, software, COP)
Stop	Master clock general remains operational, the generation of systems clocks.	but the SIM disables	Core executes STOP instruction to enter this mode. Possible recoveries from Stop mode to Run mode are:  1. Interrupt from Timer channels that have been configured to operate in Stop mode (TCx_SD)  2. Interrupt for SCI configured to operate in Stop mode (SCI_SD)  3. Low-voltage interrupt  4. Executing a Debug mode entry command using the 56800E core JTAG interface  5. Any reset (POR, external, software, COP)
Standby		h-speed peripheral e. System and	The user configures the OCCS and SIM to select the relaxation oscillator clock source (PRECS), shut down the PLL (PLLPD), put the relaxation oscillator in Standby mode (ROSB), and put the large regulator in Standby (LRSTDBY). The part is fully operational, but operating at a minimum frequency and power configuration. Recovery requires reversing the sequence used to enter this mode (allowing for PLL lock time).
Power-Down	Master clock genera completely shut dow peripheral clocks are	n. All system and	The user configures the OCCS and SIM to enter Standby mode as shown in the previous description, followed by powering down the oscillator (ROPD). The only possible recoveries from this mode are:  1. External reset  2. Power-on reset

The power modes provide additional means to disable clock domains, configure the voltage regulator, and configure clock generation to manage power utilization, as shown in **Table 6-3**. Run, Wait, and Stop modes provide means of enabling/disabling the peripheral and/or core clocking as a group. Stop disable controls are provided for selected peripherals in the control register so that these peripheral clocks can optionally continue to operate in Stop mode and generate interrupts which will return the part from Stop to Run mode. Standby mode provides normal operation but at very low speed and power utilization. It is possible to invoke Stop or Wait mode while in Standby mode for even greater levels of power reduction. A 200 kHz clock external clock can optionally be used in Standby mode to produce the required Standby 100 kHz system bus rate. Power-down mode, which selects the ROSC clock source but shuts it off, fully disables the part and minimizes its power utilization but is only recoverable via reset.

When the PLL is not selected and the system bus is operating at around 100 kHz, the large regulator can



be put into its Standby mode (LRSTDBY) to reduce the power utilization of that regulator.

All peripherals, except the COP/watchdog timer, run at the system clock (peripheral bus) frequency<sup>1</sup>, which is the same as the main processor frequency in this architecture. The COP timer runs at MSTR\_OSC / 1024. The maximum frequency of operation is SYS\_CLK = 32MHz. The only exception is the Quad Timer and PWM, which can be configured to operate at three times the system bus rate using TCR and PCR controls, provided the PLL is active and selected.

#### 6.6 Resets

The SIM supports four sources of reset, as shown in **Figure 6-15**. The two asynchronous sources are the external reset pin and the Power-On Reset (POR). The two synchronous sources are the software reset, which is generated within the SIM itself by writing the SIM\_CTRL register in **Section 6.3.1**, and the COP reset. The SIM uses these to generate resets for the internal logic. These are outlined in **Table 6-4**. The first column lists the four primary resets which are calculated. The JTAG circuitry is reset by the Power-On Reset. Columns two through five indicate which reset sources trigger these reset signals. The last column provides additional detail.

		Reset S	Sources		
Reset Signal	POR	External	Software	СОР	Comments
EXTENDED_POR	Х				Stretched version of POR. Relevant 64 Relaxation Oscillator Clock cycles after POR deasserts.
CLKGEN_RST	Х	Х	Х	Х	Released 32 Relaxation Oscillator Clock cycles after all reset sources have released.
PERIP_RST	Х	Х	Х	Х	Releases 32 Relaxation Oscillator Clock cycles after the CLKGEN_RST is released.
CORE_RST	Х	Х	Х	Х	Releases 32 SYS_CLK periods after PERIP_RST is released.

**Table 6-4 Primary System Resets** 

**Figure 6-15** provides a graphic illustration of the details in **Table 6-4**. Note that the POR\_Delay blocks use the Relaxation Oscillator Clock as their time base since other system clocks are inactive during this phase of reset.

<sup>1.</sup> The Quad Timer and PWM modules can be operated at three times the IPBus clock frequency.



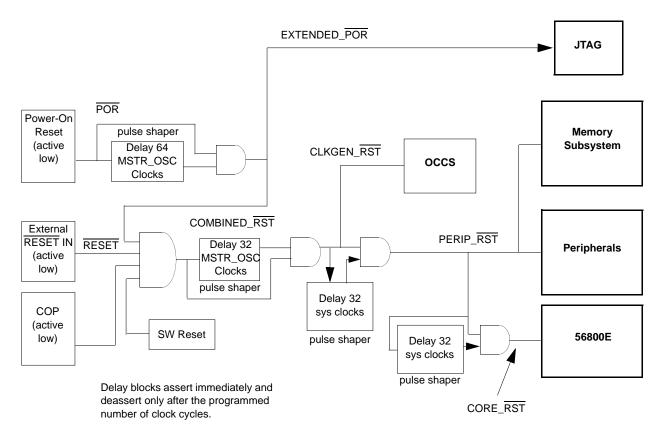


Figure 6-15 Sources of RESET Functional Diagram (Test modes not included)

POR resets are extended 64 MSTR\_OSC clocks to stabilize the power supply. All resets are subsequently extended for an additional 32 MSTR\_OSC clocks and 64 system clocks as the various internal reset controls are released. Given the normal relaxation oscillator rate of 8MHz, the duration of a POR reset from when power comes on to when code is running is  $28\mu S$ . An external reset generation chip may also be used. Resets may be asserted asynchronously, but they are always released internally on a rising edge of the system clock.

56F8014 Technical Data, Rev. 11



#### 6.7 Clocks

The memory, peripheral and core clocks all operate at the same frequency (32MHz max) with the exception of the TMR and PWM peripheral clocks, which have the option (using TCR and PCR) to operate three times faster. The SIM is responsible for stalling individual clocks as a response to various hold-off requests, low power modes, and other configuration parameters. The SIM has access to the following signals from the OCCS module:

MSTR OSC This comes from the input clock source mux of the OCCS. It is the output of the relaxation

oscillator or the external clock source, depending on PRECS. It is not guaranteed to be at 50% duty cycle (+ or - 10% can probably be assumed for design purposes). This clock runs

continuously, even during reset and is used for reset generation.

HS\_PERF The PLL multiplies the MSTR\_OSC by 24, to a maximum of 192MHz. The ZSRC field in

OCCS selects the active source to be the PLL. This is divided by 2 and postscaled to produce this maximum 96MHz clock. It is used without further division to produce the high-speed (3x system bus rate) variants of the Quad Timer and PWM peripheral clocks.

This clock is disabled when ZSRC is selecting MSTR OSC.

SYS\_CLK\_x2 The PLL can multiply the MSTR\_OSC by 24, to a maximum of 192MHz. When the PLL is

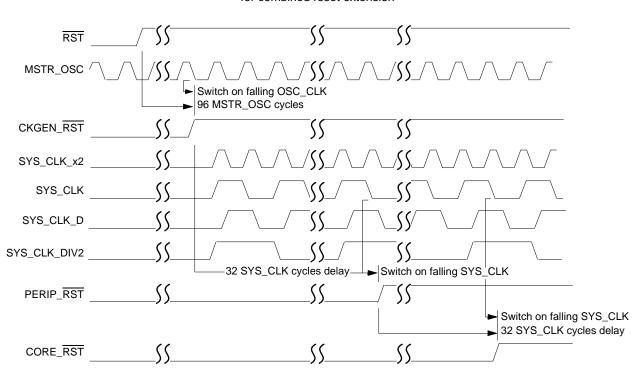
selected by the OCCS ZSRC field, the PLL is divided by three and postscaled to produce this maximum 64MHz clock. When MSTR\_OSC is selected by the OCCS ZSRC field, MSTR\_OSC feeds SYS\_CLK\_x2 directly. The SIM takes this clock and divides it by two to

generate all the normal (1x system bus rate) peripheral and system clocks.

While the SIM generates the ADC peripheral clock in the same way it generates all other peripheral clocks, the ADC standby and conversion clocks are generated by a direct interface between the ADC and the OCCS module.

Figure 6-16 illustrates clock relationships to one another and to the various resets as the device comes out of reset. RST is assumed to be the logical AND of all active-low system resets (for example, POR, external reset, COP and Software reset). In the 56F8014 architecture, this signal will be stretched by the SIM for a period of time (up to 96 MSTR\_OSC clock cycles, depending upon the status of the POR) to create the clock generation reset signal (CLKGEN\_RST). The SIM should deassert CLKGEN\_RST synchronously with the negative edge of OSC\_CLK in order to avoid skew problems. CLKGEN\_RST is delayed 32 SYS\_CLK cycles to create the peripheral reset signal (PERIP\_RST). PERIP\_RST is then delayed by 32 SYS\_CLK cycles to create CORE\_RST. Both PERIP\_RST and CORE\_RST should be released on the negative edge of SYS\_CLK\_D as shown. This phased releasing of system resets is necessary to give some peripherals (for example, the Flash interface unit) set-up time prior to the 56800E core becoming active.





Maximum Delay = 64 MSTR\_OSC cycles for POR reset extension and 32 MSTR\_OSC cycles for combined reset extension

Figure 6-16 Timing Relationships of Reset Signal to Clocks

## 6.8 Interrupts

The SIM generates no interrupts.

## Part 7 Security Features

The 56F8014 offers security features intended to prevent unauthorized users from reading the contents of the flash memory (FM) array. The 56F8014's flash security consists of several hardware interlocks that prevent unauthorized users from gaining access to the flash array.

After flash security is set, an authorized user is still able to access on-chip memory if the user purposely includes a subroutine to read and transfer the contents of internal memory via serial communication peripherals, as this code would defeat the purpose of security.

## 7.1 Operation with Security Enabled

After the user has programmed the flash with his application code, the 56F8014 can be secured by programming a security word (\$E70A) into program memory location \$00 1FF7. This nonvolatile word will keep the device secured through reset and through power-down of the device. Refer to the flash



memory chapter in MC56F8000RM, the 56F8000 Peripheral Reference Manual for details. When flash security mode is enabled, the 56F8014 will disable the core EOnCE debug capabilities. Normal program execution is otherwise unaffected.

#### 7.2 Flash Access Lock and Unlock Mechanisms

There are several methods that effectively lock or unlock the on-chip flash.

#### 7.2.1 Disabling EOnCE Access

On-chip flash can be read by issuing commands across the EOnCE port, which is the debug interface for the 56800E CPU. The TCK, TMS, TDO, and TDI pins comprise a JTAG interface onto which the EOnCE port functionality is mapped. When the device boots, the chip-level JTAG TAP (Test Access Port) is active and provides the chip's boundary scan capability and access to the ID register, but proper implementation of flash security will block any attempt to access the internal flash memory via the EOnCE port when security is enabled.

#### 7.2.2 Flash Lockout Recovery Using JTAG

If the device is secured, one lockout recovery mechanism is the complete erasure of the internal flash contents, including the configuration field, thus disabling security (the protection register is cleared). This does not compromise security, as the entire contents of the user's secured code stored in flash are erased before security is disabled on the device on the next reset or power-up sequence.

To start the lockout recovery sequence via JTAG, the JTAG public instruction (LOCKOUT\_RECOVERY) must first be shifted into the chip-level TAP controller's instruction register. Once the LOCKOUT RECOVERY instruction has been shifted into the instruction register, the clock divider value must be shifted into the corresponding 7-bit data register. After the data register has been updated, the user must transition the TAP controller into the RUN-TEST/IDLE state for the lockout sequence to commence. The controller must remain in this state until the erase sequence has completed. Refer to MC56F8000RM, the 56F8000 Peripheral Reference Manual, for more details, or contact Freescale.

Note:

Once the lockout recovery sequence has completed, the user must reset both the JTAG-TAP controller and the device to return to normal unsecured operation. Power-on reset will also reset both.

#### 7.2.3 Flash Lockout Recovery Using CodeWarrior

CodeWarrior can unlock a device by selecting the Debug menu, then selecting DSP56800E, followed by Unlock Flash. Another mechanism is also built into CodeWarrior using the device's memory configuration file. The command Unlock\_Flash\_on\_Connect1 in the .cfg file accomplishes the same task as using the Debug menu.

This lockout recovery mechanism also includes the complete erasure of the internal flash contents, including the configuration field, thus disabling security (the protection register is cleared).

#### Flash Lockout Recovery Without Mass Erase 7.2.4

The user can un-secure a secured device by programming the word \$0000 into program memory location \$00 1FF7. After completing the programming, both the JTAG TAP controller and the device must be reset

56F8014 Technical Data, Rev. 11



in order to return to normal unsecured operation. Power-on reset will also reset both.

The user is responsible for directing the device to invoke the flash programming subroutine to reprogram the word \$0000 into program memory location \$00 1FF7. This is done by, for example, toggling a specific pin, or by downloading a user-defined key through serial interfaces.

**Note:** Flash contents can only be programmed for 1s to 0s.

## 7.3 Product Analysis

The recommended method of unsecuring a secured device for product analysis of field failures is via the method suggested in section 7.2.4. The customer would need to supply Technical Support with the details of the protocol to access the subroutines in flash. An alternative method for performing analysis on a secured device would be to mass-erase and reprogram the flash with the original code, but also either modify the security word or else not program the security word.

# Part 8 General Purpose Input/Output (GPIO)

#### 8.1 Introduction

This section is intended to supplement the GPIO information found in the **56F801X Peripheral Reference** Manual and contains only chip-specific information. This information supercedes the generic information in the **56F801X Peripheral Reference Manual**.

## 8.2 Configuration

There are four GPIO ports defined on the 56F8014. The width of each port, the associated peripheral and reset functions are shown in **Table 8-1**. The specific mapping of GPIO port pins is shown in **Table 8-2**.

GPIO Port	Available Pins in 56F8014	Peripheral Function	Reset Function
А	6	PWM, Reset	GPIO, except GPIOA7
В	8	SPI, SCI, Timer	GPIO
С	8	ADC	Analog
D	4	JTAG	JTAG

**Table 8-1 GPIO Ports Configuration** 



## Table 8-2 GPIO External Signals Map Pins in shaded rows are not available in 56F8014

GPIO Function	Peripheral Function	LQFP Package Pin	Notes
GPIOA0	PWM0	28	Defaults to A0
GPIOA1	PWM1	27	Defaults toA1
GPIOA2	PWM2	23	Defaults to A2
GPIOA3	PWM3		Not bonded out in 56F8014 Defaults to A3
GPIOA4	PWM4 / FAULT1 / T2	22	SIM register SIM_GPS is used to select between PWM4, FAULT1, and T2 Defaults to A4
GPIOA5	PWM5 / FAULT2 / T3	20	SIM register SIM_GPS is used to select between PWM5, FAULT2, and T3 Defaults to A5
GPIOA6	FAULT0		Not bonded out in 56F8014 Defaults to A6
GPIOA7	RESET	16	Defaults to RESET
GPIOB0	SCLK / SCL	21	SIM register SIM_GPS is used to select between SCLK and SCL Defaults to B0
GPIOB1	SS / SDA	1	SIM register SIM_GPS is used to select between SS and SDA Defaults to B1
GPIOB2	MISO / T2	18	SIM register SIM_GPS is used to select between MISO and T2 Defaults to B2
GPIOB3	MOSI / T3	17	SIM register SIM_GPS is used to select between MOSI and T3 Defaults to B3
GPIOB4	T0 / CLKO	19	SIM register SIM_GPS is used to select between T0 and CLKO Defaults to B4
GPIOB5	T1 / FAULT3	3	SIM register SIM_GPS is used to select between T1 and FAULT3 Defaults to B5



# Table 8-2 GPIO External Signals Map (Continued) Pins in shaded rows are not available in 56F8014

GPIO Function	Peripheral Function	LQFP Package Pin	Notes
GPIOB6	RXD / SDA / CLKIN	32	SIM register SIM_GPS is used to select between RXD and SDA. CLKIN functionality is enabled using the PLL Control Register within the OCCS block. Defaults to B6
GPIOB7	TXD / SCL	2	SIM register SIM_GPS is used to select between TXD and SCL Defaults to B7
GPIOC0	ANA0	13	Defaults to ANA0
GPIOC1	ANA1	12	Defaults to ANA1
GPIOC2	ANA2 / V <sub>REFH</sub>	11	Defaults to ANA2
GPIOC3	ANA3	10	Defaults to ANA3
GPIOC4	ANB0	4	Defaults to ANB0
GPIOC5	ANB1	5	Defaults to ANB1
GPIOC6	ANB2 / V <sub>REFL</sub>	6	Defaults to ANB2
GPIOC7	ANB3	7	Defaults to ANB3
GPIOD0	TDI	29	Defaults to TDI
GPIOD1	TDO	31	Defaults to TDO
GPIOD2	тск	15	Defaults to TCK
GPIOD3	TMS	30	Defaults to TMS

## 8.3 Reset Values

Tables 4-16 through 4-19 detail registers for the 56F8014; Figures 8-1 through 8-4 summarize register maps and reset values.



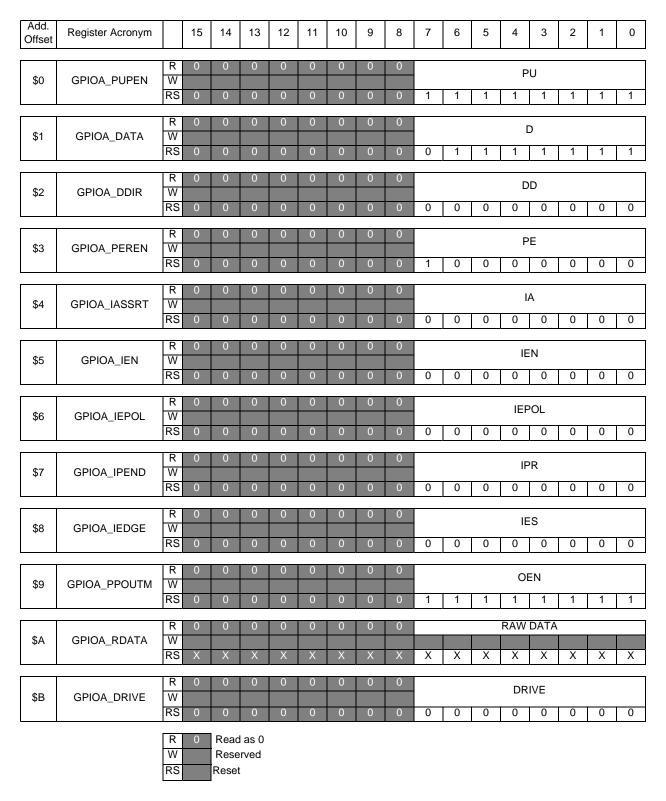


Figure 8-1 GPIOA Register Map Summary

56F8014 Technical Data, Rev. 11



Add. Offset	Register Acronym		15	14	13	12	11	10	9	8	7	6	5	4	3	2	1	0
\$0	GPIOB_PUPEN	R W	0	0	0	0	0	0	0	0				Р				
		RS	0	0	0	0	0	0	0	0	1	1	1	1	1	1	1	1
\$1	GPIOB_DATA	R W	0	0	0	0	0	0	0	0				[				
		RS	0	0	0	0	0	0	0	0	1	1	1	1	1	1	1	1
\$2	GPIOB_DDIR	R W	0	0	0	0	0	0	0	0				D				
		RS	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0
\$3	GPIOB_PEREN	R W	0	0	0	0	0	0	0	0				Р	E			
		RS	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0
\$4	GPIOB_IASSRT	R W	0	0	0	0	0	0	0	0				L	Ą			
<b>V</b> .		RS	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0
\$5	GPIOB_IEN	R	0	0	0	0	0	0	0	0				IE	:N			
φυ	GFIOD_ILIV	RS	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0
		R	0	0	0	0	0	0	0	0				155				
\$6	GPIOB_IEPOL	W RS	0	0	0	0	0	0	0	0	0	0	0	IEF 0	0	0	0	0
		11										Ŭ	Ŭ	Ŭ				
\$7	GPIOB_IPEND	R W	0	0	0	0	0	0	0	0				IF	rR			
		RS	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0
\$8	GPIOB_IEDGE	R W	0	0	0	0	0	0	0	0				IE	S			
фо	GFIOB_IEDGE	RS	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0
		R	0	0	0	0	0	0	0	0				0	-NI		•	
\$9	GPIOB_PPOUTM	W RS	0	0	0	0	0	0	0	0	1	1	1	OI 1	= IN 1	1	1	1
											'							
\$A	GPIOB_RDATA	R W	0	0	0	0	0	0	0	0				RAW				
		RS	Χ	Χ	Х	Х	Х	Χ	Χ	Χ	Х	Х	Χ	Х	Χ	Х	Х	Х
\$B	GPIOB_DRIVE	R W	0	0	0	0	0	0	0	0				DR	IVE			
		RS	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0	0
		R W RS	0	Read Reset	rved													

Figure 8-2 GPIOB Register Map Summary



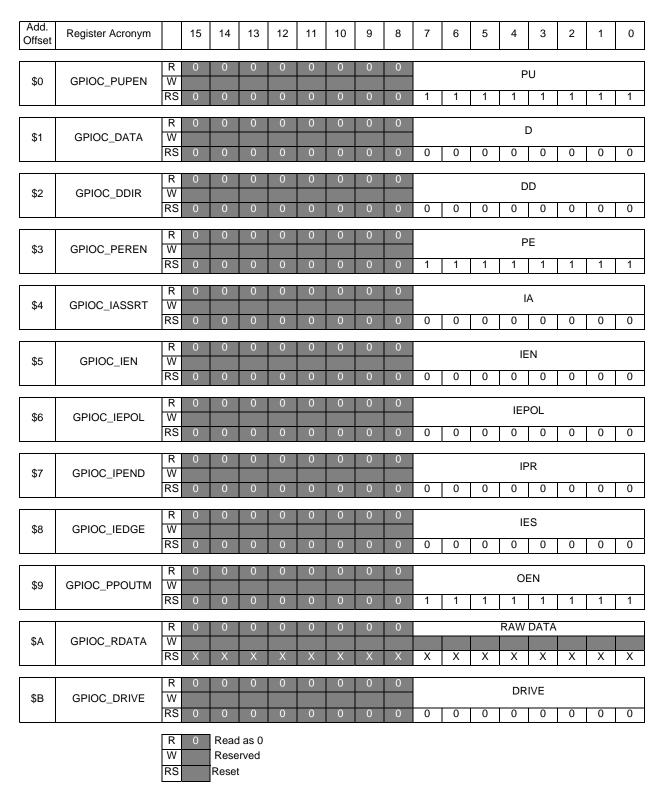


Figure 8-3 GPIOC Register Map Summary

56F8014 Technical Data, Rev. 11



Add. Offset	Register Acronym		15	14	13	12	11	10	9	8	7	6	5	4	3 2 1 0
\$0	GPIOD_PUPEN	R W RS	0	0	0	0	0	0	0	0	0	0	0	0	PU 1 1 1 1
\$1	GPIOD_DATA	R W RS	0	0	0	0	0	0	0	0	0	0	0	0	D 0 0 0 0
\$2	GPIOD_DDIR	R W RS	0	0	0	0	0	0	0	0	0	0	0	0	DD 0 0 0
\$3	GPIOD_PEREN	R W RS	0	0	0	0	0	0	0	0	0	0	0	0	PE 1 1 1 1
\$4	GPIOD_IASSRT	R W RS	0	0	0	0	0	0	0	0	0	0	0	0	IA 0 0 0 0
\$5	GPIOD_IEN	R W RS	0	0	0	0	0	0	0	0	0	0	0	0	IEN   0   0   0
\$6	GPIOD_IEPOL	R W RS	0	0	0	0	0	0	0	0	0	0	0	0	IEPOL 0 0 0 0
\$7	GPIOD_IPEND	R W RS	0	0	0	0	0	0	0	0	0	0	0	0	IPR 0 0 0 0
\$8	GPIOD_IEDGE	R W RS	0	0	0	0	0	0	0	0	0	0	0	0	IES 0 0 0 0
\$9	GPIOD_PPOUTM	R W RS	0	0	0	0	0	0	0	0	0	0	0	0	OEN 1 1 1 1
\$A	GPIOD_RDATA	R W RS	0 X	0 X	0 X	0 X	0 X	0 X	0 X	0 X	0 X	0 X	0 X	0 X	RAW DATA
\$B	GPIOD_DRIVE	R W RS	0	0	0	0	0	0	0	0	0	0	0	0	DRIVE 0 0 0 0
		R W	0	Read Rese											





#### Figure 8-4 GPIOD Register Map Summary

## Part 9 Joint Test Action Group (JTAG)

#### 9.1 56F8014 Information

Please contact your Freescale sales representative or authorized distributor for device/package-specific BSDL information.

The  $\overline{TRST}$  pin is not available in this package. The pin is tied to  $V_{DD}$  in the package.

The JTAG state machine is reset during POR and can also be reset via a soft reset by holding TMS high for five rising edges of TCK, as described in the **56F8000 Peripheral User Manual**.

## Part 10 Specifications

#### 10.1 General Characteristics

The 56F8014 is fabricated in high-density CMOS with 5V-tolerant TTL-compatible digital inputs. The term "5V-tolerant" refers to the capability of an I/O pin, built on a 3.3V-compatible process technology, to withstand a voltage up to 5.5V without damaging the device. Many systems have a mixture of devices designed for 3.3V and 5V power supplies. In such systems, a bus may carry both 3.3V- and 5V-compatible I/O voltage levels (a standard 3.3V I/O is designed to receive a maximum voltage of 3.3V  $\pm$  10% during normal operation without causing damage). This 5V-tolerant capability therefore offers the power savings of 3.3V I/O levels, combined with the ability to receive 5V levels without damage.

Absolute maximum ratings in **Table 10-1** are stress ratings only, and functional operation at the maximum is not guaranteed. Stress beyond these ratings may affect device reliability or cause permanent damage to the device.

Unless otherwise stated, all specifications within this chapter apply over the temperature range of -40°C to 125°C ambient temperature over the following supply ranges:

$$V_{SS} = V_{SS}A = 0V$$
,  $V_{DD} = V_{DDA} = 3.0-3.6V$ ,  $CL \le 50pF$ ,  $f_{OP} = 32MHz$ 



#### **CAUTION**

This device contains protective circuitry to guard against damage due to high static voltage or electrical fields. However, normal precautions are advised to avoid application of any voltages higher than maximum-rated voltages to this high-impedance circuit. Reliability of operation is enhanced if unused inputs are tied to an appropriate voltage level.

**Table 10-1 Absolute Maximum Ratings** 

 $(V_{SS} = 0V, V_{SSA} = 0V)$ 

Characteristic	Symbol	Notes	Min	Max	Unit
Supply Voltage Range	V <sub>DD</sub>		-0.3	4.0	V
Analog Supply Voltage Range	V <sub>DDA</sub>		- 0.3	4.0	V
ADC High Voltage Reference	V <sub>REFH</sub>		- 0.3	4.0	V
Voltage difference V <sub>DD_IO</sub> to V <sub>DDA</sub>	$\Delta V_{DD}$		- 0.3	0.3	V
Voltage difference V <sub>SS_IO</sub> to V <sub>SSA</sub>	$\Delta V_{SS}$		- 0.3	0.3	V
Input Voltage Range (Digital inputs)	V <sub>IN</sub>	Pin Groups 1, 2	- 0.3	6.0	V
Input Voltage Range (ADC inputs) <sup>1</sup>	V <sub>INA</sub>	Pin Group 3	- 0.3	4.0	V
Input clamp current, per pin $(V_{IN} < 0)^2$	V <sub>IC</sub>		-	-20	mA
Output clamp current, per pin $(V_O < 0)^2$	V <sub>OC</sub>		-	-20	mA
Output Voltage Range (Normal Push-Pull mode)	V <sub>OUT</sub>	Pin Group 1	-0.3	4.0	V
Output Voltage Range (Open Drain mode)	V <sub>OUTOD</sub>	Pin Groups 1, 2	-0.3	6.0	V
Ambient Temperature (Automotive)	T <sub>A</sub>		-40	125	°C
Ambient Temperature (Industrial)	T <sub>A</sub>		-40	105	°C
Junction Temperature (Automotive)	TJ		-40	150	°C
Junction Temperature (Industrial)	TJ		-40	125	°C
Storage Temperature (Automotive)	T <sub>STG</sub>		-55	150	°C
Storage Temperature (Industrial)	T <sub>STG</sub>		-55	150	°C



- 1. Pin Group 3 can tolerate 6V for less than 5 seconds when they are configured as ADC inputs or during reset. Pin Group 3 can tolerate 6V if they are configured as GPIO.
- 2. Continuous input current per pin is -2 mA

#### **Default Mode**

Pin Group 1: GPIO, TDI, TDO, TMS, TCK

Pin Group 2: RESET, GPIOA7
Pin Group 3: ADC analog inputs

## 10.1.1 ElectroStatic Discharge (ESD) Model

#### Table 10-2 56F8014 ESD Protection

Characteristic	Min	Тур	Max	Unit
ESD for Human Body Model (HBM)	2000	_	_	V
ESD for Machine Model (MM)	200	_	_	V
ESD for Charge Device Model (CDM)	750	_	_	V

## Table 10-3 LQFP Package Thermal Characteristics<sup>6</sup>

Characteristic	Comments	Symbol	Value (LQFP)	Unit	Notes
Junction to ambient Natural convection	Single layer board (1s)	$R_{ hetaJA}$	74	°C/W	1,2
Junction to ambient Natural convection	Four layer board (2s2p)	$R_{ hetaJMA}$	50	°C/W	1,3
Junction to ambient (@200 ft/min)	Single layer board (1s)	$R_{ hetaJMA}$	67	°C/W	1,3
Junction to ambient (@200 ft/min)	Four layer board (2s2p)	$R_{ hetaJMA}$	46	°C/W	1,3
Junction to board		$R_{ heta JB}$	23	°C/W	4
Junction to case		$R_{ heta JC}$	20	°C/W	5
Junction to package top	Natural Convection	$\Psi_{JT}$	4	°C/W	6

- 1. Junction temperature is a function of die size, on-chip power dissipation, package thermal resistance, mounting site (board) temperature, ambient temperature, air flow, power dissipation of other components on the board, and board thermal resistance.
- 2. Per SEMI G38-87 and JEDEC JESD51-2 with the single layer board horizontal.
- 3. Per JEDEC JESC51-6 with the board horizontal.
- 4. Thermal resistance between the die and the printed circuit board per JEDEC JESD51-8. Board temperature is measured on the top surface of the board near the package.



- 5. Thermal resistance between the die and the case top surface as measured by the cold plate method (MIL SPEC-883 Method 1012.1).
- 6. Thermal characterization parameter indicating the temperature difference between package top and the junction temperature per JEDEC JESD51-2. When Greek letters are not available, the thermal characterization parameter is written as Psi-JT.

7. See Section 12.1 for more details on thermal design considerations.

56F8014 Technical Data, Rev. 11

94

Freescale Semiconductor



# Table 10-4 Recommended Operating Conditions $(V_{REFL} = 0V, V_{SSA} = 0V, V_{SS} = 0V)$

Characteristic	Symbol	Notes	Min	Тур	Max	Unit
Supply voltage	V <sub>DD</sub>		3	3.3	3.6	V
ADC Supply voltage	$V_{DDA}$		3	3.3	3.6	V
ADC High Voltage Reference	$V_{REFH}$		3	_	$V_{DDA}$	V
Voltage difference V <sub>DD_IO</sub> to V <sub>DDA</sub>	$\Delta V_{DD}$		-0.1	0	0.1	V
Voltage difference V <sub>SS_IO</sub> to V <sub>SSA</sub>	$\Delta V_{SS}$		-0.1	0	0.1	V
Device Clock Frequency Using relaxation oscillator Using external clock source	FSYSCLK		8 0	_	32 32	MHz
Input Voltage High (digital inputs)	V <sub>IH</sub>	Pin Groups 1, 2	2	_	5.5	V
Input Voltage Low (digital inputs)	V <sub>IL</sub>	Pin Groups 1, 2	-0.3	_	0.8	V
Output Source Current High (at V <sub>OH</sub> min.) When programmed for low drive strength When programmed for high drive strength	I <sub>OH</sub>	Pin Group 1 Pin Group 1		_	-4 -8	mA
Output Source Current Low (at V <sub>OL</sub> max.) When programmed for low drive strength When programmed for high drive strength	I <sub>OL</sub>	Pin Groups 1, 2 Pin Groups 1, 2		_	4 8	mA
Ambient Operating Temperature (Automotive)	T <sub>A</sub>		-40	_	125	°C
Ambient Operating Temperature (Industrial)	T <sub>A</sub>		-40	_	105	°C
Flash Endurance (Automotive) (Program Erase Cycles)	N <sub>F</sub>	T <sub>A</sub> = -40°C to 125°C	10,000	_	_	Cycles
Flash Endurance (Industrial) (Program Erase Cycles)	N <sub>F</sub>	T <sub>A</sub> = -40°C to 105°C	10,000	_	_	Cycles
Flash Data Retention	T <sub>R</sub>	T <sub>J</sub> <= 85°C avg	15	_	_	Years
Flash Data Retention with <100 Program/Erase Cycles	t <sub>FLRET</sub>	T <sub>J</sub> <= 85°C avg	20	_	_	Years

Note: Total chip source or sink current cannot exceed 50mA

**Default Mode** 

Pin Group 1: GPIO, TDI, TDO, TMS, TCK

Pin Group 2: RESET, GPIOA7 Pin Group 3: ADC analog inputs



## 10.2 DC Electrical Characteristics

#### **Table 10-5 DC Electrical Characteristics**

At Recommended Operating Conditions

Characteristic	Symbol	Notes	Min	Тур	Max	Unit	Test Conditions
Output Voltage High	V <sub>OH</sub>	Pin Group 1	2.4	_	_	V	$I_{OH} = I_{OHmax}$
Output Voltage Low	V <sub>OL</sub>	Pin Groups 1, 2	_	_	0.4	V	$I_{OL} = I_{OLmax}$
Digital Input Current High pull-up enabled or disabled <sup>1</sup>	I <sub>IH</sub>	Pin Groups 1, 2	_	0	+/- 2.5	μА	V <sub>IN</sub> = 2.4V to 5.5V
Digital Input Current Low pull-up enabled pull-up disabled <sup>1</sup>	I <sub>IL</sub>	Pin Groups 1, 2	-15 —	-30 0	-60 +/- 2.5	μА	V <sub>IN</sub> = 0V
Output Current High Impedance State <sup>1</sup>	l <sub>OZ</sub>	Pin Groups 1, 2	_	0	+/- 2.5	μΑ	V <sub>OUT</sub> = 2.4V to 5.5V or 0V
Schmitt Trigger Input Hysteresis	V <sub>HYS</sub>	Pin Groups 1, 2	_	0.35	_	V	_
Input Capacitance	C <sub>IN</sub>		_	10	_	pF	_
Output Capacitance	C <sub>OUT</sub>		_	10	_	pF	_

<sup>1.</sup> See **Figure 10-1** 

#### **Default Mode**

Pin Group 1: GPIO, TDI, TDO, TMS, TCK

Pin Group 2: RESET, GPIOA7
Pin Group 3: ADC analog inputs

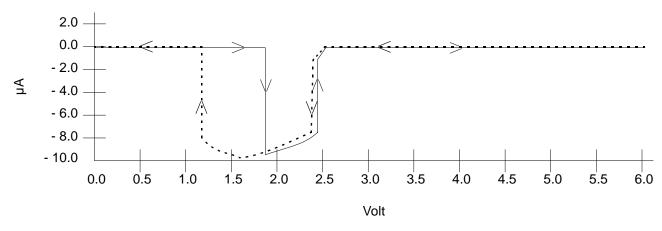


Figure 10-1  $I_{IN}/I_{OZ}$  vs.  $V_{IN}$  (Typical; Pull-Up Disabled)



## **Table 10-6 Current Consumption per Power Supply Pin (Typical)**

NA - 1-	O and Hittering	Typical @	3.3V, 25°C	Maximum@ 3.6V, 25°C		
Mode	Conditions	I <sub>DD</sub> <sup>1</sup>	I <sub>DDA</sub>	I <sub>DD</sub> <sup>1</sup>	I <sub>DDA</sub>	
RUN	32MHz Device Clock Relaxation Oscillator on PLL powered on Continuous MAC instructions with fetches from Program Flash All peripheral modules enabled. Quad Timer and PWM using 1x Clock ADC powered on and clocked	42mA	13.5mA	_	_	
WAIT	32MHz Device Clock Relaxation Oscillator on PLL powered on Processor Core in WAIT state All Peripheral modules enabled. Quad Timer and PWM using 1x Clock ADC powered off	17mA	0µА	_	_	
STOP	4MHz Device Clock Relaxation Oscillator on PLL powered off Processor Core in STOP state All peripheral module and core clocks are off ADC powered off	5mA	0μΑ	_	_	
STANDBY > STOP	100KHz Device Clock Relaxation Oscillator in Standby mode PLL powered off Processor Core in STOP state All peripheral module and core clocks are off ADC powered off Voltage regulator in Standby mode	430μΑ	0μΑ	550μΑ	1μΑ	
POWERDOWN	Device Clock is off Relaxation Oscillator powered off PLL powered off Processor Core in STOP state All peripheral module and core clocks are off ADC powered off Voltage Regulator in Standby mode	300μΑ	0µА	400μΑ	1μΑ	

No Output Switching
 All ports configured as inputs
 All inputs Low
 No DC Loads



Table 10-7 Power-On	Reset Low-Vol	Itage Parameters
---------------------	---------------	------------------

Characteristic	Symbol	Min	Тур	Max	Unit
Low-Voltage Interrupt for 3.3V supply <sup>1</sup>	V <sub>EI3.3</sub>	2.60	2.7	_	V
Low-Voltage Interrupt for 2.5V supply <sup>2</sup>	V <sub>E12.5</sub>	2.05	2.15	_	V
Low-Voltage Interrupt Recovery Hysteresis	V <sub>EIH</sub>	_	50	_	mV
Power-On Reset <sup>3</sup>	POR	_	1.8	1.9	V

<sup>1.</sup> When  $V_{DD}$  drops below  $V_{El3.3}$ , an interrupt is generated.

## 10.2.1 Voltage Regulator Specifications

The 56F8014 has two on-chip regulators. One supplies the PLL and relaxation oscillator. It has no external pins and therefore has no external characteristics which must be guaranteed (other than proper operation of the device). The second regulator supplies approximately 2.5 V to the 56F8014's core logic. This regulator requires an external 2.2  $\mu$ F, or greater, capacitor for proper operation. Ceramic and tantalum capacitors tend to provide better performance tolerances. The output voltage can be measured directly on the  $V_{CAP}$  pin. The specifications for this regulator are shown in **Table 10-8**.

**Table 10-8. Regulator Parameters** 

Characteristic	Symbol	Min	Typical	Max	Unit
Input Voltage	V <sub>IN</sub>	3.0	_	3.6	V
Output Voltage	V <sub>OUT</sub>	2.25	2.5	2.75	V
Short Circuit Current	I <sub>SS</sub>	_	450	650	mA
Short Circuit Tolerance (output shorted to ground)	T <sub>RSC</sub>	_	_	30	Minutes

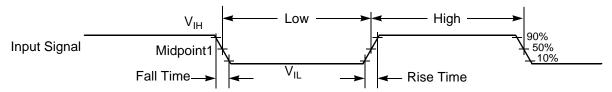
## 10.3 AC Electrical Characteristics

Tests are conducted using the input levels specified in **Table 10-5**. Unless otherwise specified, propagation delays are measured from the 50% to the 50% point, and rise and fall times are measured between the 10% and 90% points, as shown in **Figure 10-2**.

<sup>2.</sup> When  $V_{DD}$  drops below  $V_{El32.5}$ , an interrupt is generated.

<sup>3.</sup> Power-On Reset occurs whenever the internally regulated 2.5V digital supply drops below 1.8V. While power is ramping up, this signal remains active for as long as the internal 2.5V is below 2.15V or the 3.3V 1/O voltage is below 2.7V, no matter how long the ramp-up rate is. The internally regulated voltage is typically 100mV less than V<sub>DD</sub> during ramp-up until 2.5V is reached, at which time it self-regulates.





Note: The midpoint is  $V_{IL} + (V_{IH} - V_{IL})/2$ .

#### Figure 10-2 Input Signal Measurement References

Figure 10-3 shows the definitions of the following signal states:

- Active state, when a bus or signal is driven, and enters a low impedance state
- Tri-stated, when a bus or signal is placed in a high impedance state
- Data Valid state, when a signal level has reached  $V_{OL}$  or  $V_{OH}$
- Data Invalid state, when a signal level is in transition between  $V_{OL}$  and  $V_{OH}$

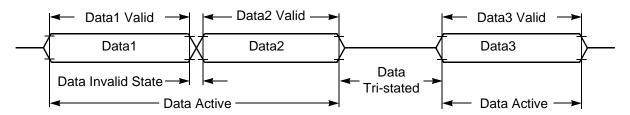


Figure 10-3 Signal States

## 10.4 Flash Memory Characteristics

**Table 10-9 Flash Timing Parameters** 

Characteristic	Symbol	Min	Тур	Max	Unit
Program time <sup>1</sup>	Tprog	20	_	40	μS
Erase time <sup>2</sup>	Terase	20	_	_	ms
Mass erase time	Tme	100	_	_	ms

<sup>1.</sup> There is additional overhead which is part of the programming sequence. See the 56F801X Peripheral Reference Manual for details.

56F8014 Technical Data, Rev. 11

<sup>2.</sup> Specifies page erase time. There are 512 bytes per page in the Program Flash memory.

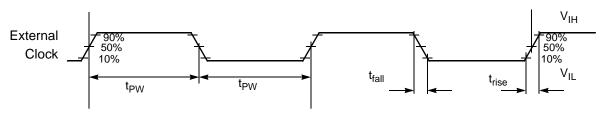


## 10.5 External Clock Operation Timing

Table 10-10 External Clock Operation Timing Requirements<sup>1</sup>

Characteristic	Symbol	Min	Тур	Max	Unit
Frequency of operation (external clock driver) <sup>2</sup>	f <sub>osc</sub>	4	8	8	MHz
Clock Pulse Width <sup>3</sup>	t <sub>PW</sub>	6.25	_	_	ns
External Clock Input Rise Time <sup>4</sup>	t <sub>rise</sub>	_	_	3	ns
External Clock Input Fall Time <sup>5</sup>	t <sub>fall</sub>	_	_	3	ns

- 1. Parameters listed are guaranteed by design.
- 2. See Figure 10-4 for details on using the recommended connection of an external clock driver.
- 3. The high or low pulse width must be no smaller than 6.25ns or the chip may not function.
- 4. External clock input rise time is measured from 10% to 90%.
- 5. External clock input fall time is measured from 90% to 10%.



Note: The midpoint is  $V_{IL} + (V_{IH} - V_{IL})/2$ .

**Figure 10-4 External Clock Timing** 

## 10.6 Phase Locked Loop Timing

Table 10-11 PLL Timing

Characteristic	Symbol	Min	Тур	Max	Unit
Internal reference relaxation oscillator frequency for the PLL	f <sub>rosc</sub>	_	8	_	MHz
PLL output frequency <sup>1</sup> (24 x reference frequency)	f <sub>op</sub>	_	192	_	MHz
PLL lock time <sup>2</sup>	t <sub>lock</sub>	_	40	100	μs
Cycle to cycle jitter	t <sub>jitterpll</sub>		350		ps

<sup>1.</sup> The core system clock will operate at 1/6 of the PLL output frequency.

<sup>2.</sup> This is the time required after the PLL is enabled to ensure reliable operation.



# 10.7 Relaxation Oscillator Timing

**Table 10-12 Relaxation Oscillator Timing** 

Characteristic	Symbol	Minimum	Typical	Maximum	Unit
Relaxation Oscillator output frequency Normal Mode <sup>1</sup> Standby Mode	f <sub>op</sub>	_	8.05 200	_	MHz kHz
Relaxation Oscillator stabilization time <sup>2</sup>	t <sub>roscs</sub>	_	1	3	μs
Cycle-to-cycle jitter. This is measured on the CLKO signal (programmed prescaler_clock) over 264 clocks <sup>3</sup>	t <sub>jitterrosc</sub>	_	400		ps
Minimum tuning step size			.08		%
Maximum tuning step size			40		%
Variation over temperature -40°C to 150°C <sup>4</sup>			+1.0 to -1.5	+3.0 to -3.0	%
Variation over temperature 0°C to 105°C <sup>4</sup>			0 to +1	+2.0 to -2.0	%

<sup>1.</sup> Output frequency after factory trim.

<sup>4.</sup> See Figure 10-5.

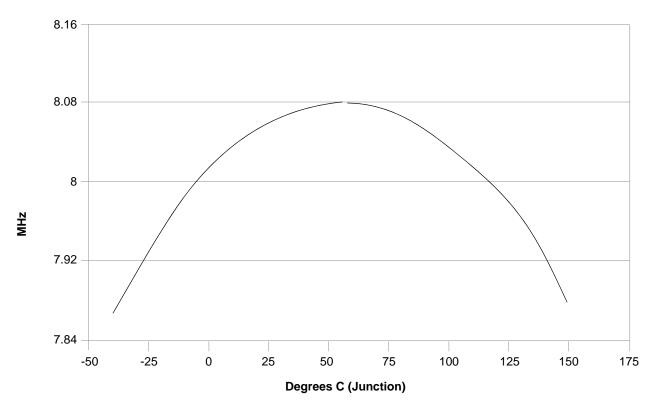


Figure 10-5 Relaxation Oscillator Temperature Variation (Typical) After Trim

56F8014 Technical Data, Rev. 11

<sup>2.</sup> This is the time required from standby to normal mode transition.

<sup>3.</sup>  $J_A$  is required to meet SCI requirements.



## 10.8 Reset, Stop, Wait, Mode Select, and Interrupt Timing

Note: All the address and data buses described here are internal.

Table 10-13 Reset, Stop, Wait, Mode Select, and Interrupt Timing 1,2

Characteristic	Symbol	Typical Min	Typical Max	Unit	See Figure
Minimum RESET Assertion Duration	t <sub>RA</sub>	4T	_	ns	
Minimum GPIO pin Assertion for Interrupt	t <sub>IW</sub>	2T	_	ns	10-6
RESET deassertion to First Address Fetch <sup>3</sup>	t <sub>RDA</sub>	96T <sub>OSC</sub> + 64T	97T <sub>OSC</sub> + 65T	ns	
Delay from Interrupt Assertion to Fetch of first instruction (exiting Stop)	t <sub>IF</sub>	_	6T	ns	

<sup>1.</sup> In the formulas, T = clock cycle and T<sub>osc</sub> = oscillator clock cycle. For an operating frequency of 32MHz, T = 31.25ns. At 8MHz (used during Reset and Stop modes), T = 125ns.

<sup>3.</sup> During Power-On Reset, it is possible to use the 56F8014 internal reset stretching circuitry to extend this period to 2^21T.



Figure 10-6 GPIO Interrupt Timing (Negative Edge-Sensitive)

<sup>2.</sup> Parameters listed are guaranteed by design.



# 10.9 Serial Peripheral Interface (SPI) Timing

# Table 10-14 SPI Timing<sup>1</sup>

Characteristic	Symbol	Min	Max	Unit	See Figure
Cycle time Master Slave	t <sub>C</sub>	125 62.5	_	ns ns	10-7, 10-8, 10-9, 10-10
Enable lead time Master Slave	t <sub>ELD</sub>	_ 31	_	ns ns	10-10
Enable lag time Master Slave	t <sub>ELG</sub>	 125	_	ns ns	10-10
Clock (SCK) high time Master Slave	<sup>t</sup> CH	50 31	_	ns ns	10-7, 10-8, 10-9, 10-10
Clock (SCK) low time Master Slave	t <sub>CL</sub>	50 31	_	ns ns	10-10
Data set-up time required for inputs Master Slave	t <sub>DS</sub>	20 0	_	ns ns	10-7, 10-8, 10-9, 10-10
Data hold time required for inputs Master Slave	t <sub>DH</sub>	0 2	_	ns ns	10-7, 10-8, 10-9, 10-10
Access time (time to data active from high-impedance state) Slave	t <sub>A</sub>	4.8	15	ns	10-10
Disable time (hold time to high-impedance state) Slave	t <sub>D</sub>	3.7	15.2	ns	10-10
Data Valid for outputs Master Slave (after enable edge)	t <sub>DV</sub>	_	4.5 20.4	ns ns	10-7, 10-8, 10-9, 10-10
Data invalid Master Slave	t <sub>DI</sub>	0 0	_	ns ns	10-7, 10-8, 10-9, 10-10
Rise time Master Slave	t <sub>R</sub>	_	11.5 10.0	ns ns	10-7, 10-8, 10-9, 10-10
Fall time Master Slave	t <sub>F</sub>	_	9.7 9.0	ns ns	10-7, 10-8, 10-9, 10-10



1. Parameters listed are guaranteed by design.

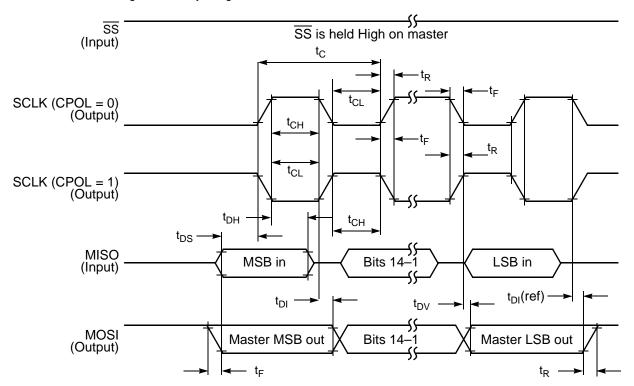


Figure 10-7 SPI Master Timing (CPHA = 0)



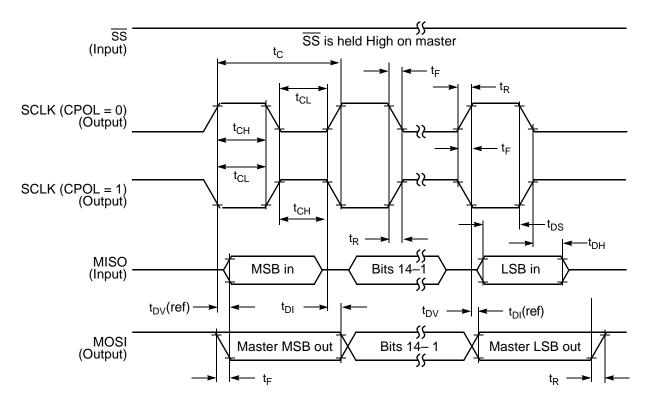


Figure 10-8 SPI Master Timing (CPHA = 1)

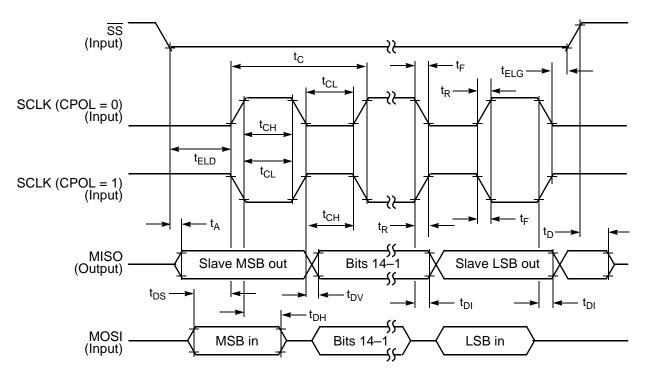


Figure 10-9 SPI Slave Timing (CPHA = 0)



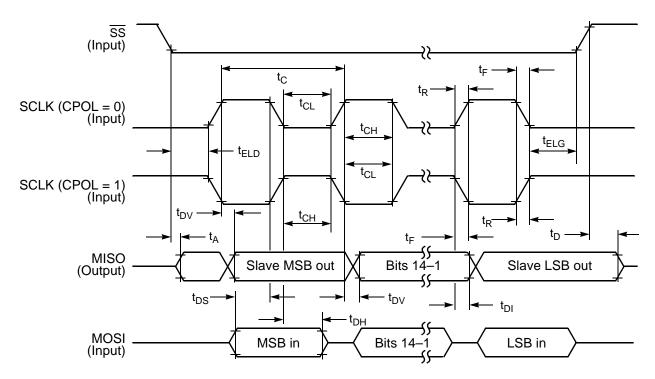


Figure 10-10 SPI Slave Timing (CPHA = 1)

# 10.10 Quad Timer Timing

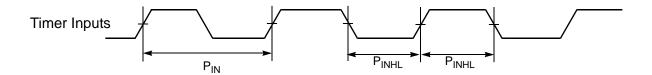
Table 10-15 Timer Timing<sup>1, 2</sup>

Characteristic	Symbol	Min	Max	Unit	See Figure
Timer input period	P <sub>IN</sub>	2T + 6	_	ns	10-11
Timer input high / low period	P <sub>INHL</sub>	1T + 3	_	ns	10-11
Timer output period	P <sub>OUT</sub>	125	_	ns	10-11
Timer output high / low period	P <sub>OUTHL</sub>	50	_	ns	10-11

<sup>1.</sup> In the formulas listed, T = the clock cycle. For 32MHz operation, T = 31.25ns.

<sup>2.</sup> Parameters listed are guaranteed by design.





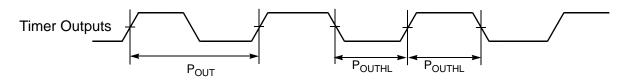


Figure 10-11 Timer Timing



# 10.11 Serial Communication Interface (SCI) Timing

Table 10-16 SCI Timing<sup>1</sup>

Characteristic	Symbol	Min	Max	Unit	See Figure
Baud Rate <sup>2</sup>	BR	_	(f <sub>MAX</sub> /16)	Mbps	_
RXD <sup>3</sup> Pulse Width	RXD <sub>PW</sub>	0.965/BR	1.04/BR	ns	10-12
TXD <sup>4</sup> Pulse Width	TXD <sub>PW</sub>	0.965/BR	1.04/BR	ns	10-13
	LIN S	Slave Mode		I	
Deviation of slave node clock from nominal clock rate before synchronization	F <sub>TOL_UNSYN</sub> CH	-14	14	%	
Deviation of slave node clock relative to the master node clock after synchronization	F <sub>TOL_SYNCH</sub>	-2	2	%	
Minimum break character length	T <sub>BREAK</sub>	13		Master node bit periods	
		11		Slave node bit periods	

- 1. Parameters listed are guaranteed by design.
- 2.  $f_{MAX}$  is the frequency of operation of the system clock in MHz, which is 32MHz for the 56F8014 device.
- 3. The RXD pin in SCI0 is named RXD0 and the RXD pin in SCI1 is named RXD1.
- 4. The TXD pin in SCI0 is named TXD0 and the TXD pin in SCI1 is named TXD1.

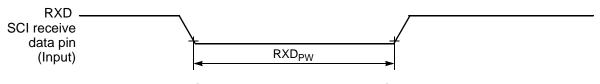


Figure 10-12 RXD Pulse Width



Figure 10-13 TXD Pulse Width

56F8014 Technical Data, Rev. 11 108 Freescale Semiconductor



# 10.12 Inter-Integrated Circuit Interface (I<sup>2</sup>C) Timing

## Table 10-17 I<sup>2</sup>C Timing

Observatoriation	0	Standa	rd Mode	Fast	112	
Characteristic	Symbol	Minimum	Maximum	Minimum	Maximum	Unit
SCL Clock Frequency	f <sub>SCL</sub>	0	100	0	400	kHz
Hold time (repeated ) START condition. After this period, the first clock pulse is generated.	t <sub>HD;</sub> STA	4.0		0.6		μ\$
LOW period of the SCL clock	t <sub>LOW</sub>	4.7		1.25		μS
HIGH period of the SCL clock	t <sub>HIGH</sub>	4.0		0.6		μS
Set-up time for a repeated START condition	t <sub>SU; STA</sub>	4.7		0.6		μS
Data hold time for I <sup>2</sup> C bus devices	t <sub>HD; DAT</sub>	01	3.45 <sup>2</sup>	01	0.9 <sup>2</sup>	μS
Data set-up time	t <sub>SU; DAT</sub>	250		100 <sup>3</sup>		ns
Rise time of both SDA and SCL signals	t <sub>r</sub>		1000	2 +0.1C <sub>b</sub> <sup>4</sup>	300	ns
Fall time of both SDA and SCL signals	t <sub>f</sub>		300	2 +0.1C <sub>b</sub> <sup>4</sup>	300	ns
Set-up time for STOP condition	t <sub>SU; STO</sub>	4.0		0.6		μS
Bus free time between STOP and START condition	t <sub>BUF</sub>	4.7		1.3		μs
Pulse width of spikes that must be suppressed by the input filter	t <sub>SP</sub>	N/A	N/A	0.0	50	ns

<sup>1.</sup> A device must internally provide a hold time of at least 300ns for the SDA signal (referred to the VIH min of the SCL signal) to bridge the undefined region of the falling edge of SCL.

<sup>2.</sup> The maximum  $t_{HD;\;DAT}$  has only to be met if the device does not stretch the LOW period  $(t_{LOW})$  of the SCL signal.

<sup>3.</sup> A Fast mode  $I^2C$  bus device can be used in a Standard mode  $I^2C$  bus system, but the requirement  $t_{SU; DAT} > = 250$ ns must then be met. This will automatically be the case if the device does not stretch the LOW period of the SCL signal. If such a device does stretch the LOW period of the SCL signal, it must output the next data bit to the SDA line

t<sub>rmax</sub> + t<sub>SU; DAT</sub> = 1000 + 250 = 1250ns (according to the Standard mode I<sup>2</sup>C bus specification) before the SCL line is released.

<sup>4.</sup>  $C_b$  = total capacitance of the one bus line in pF.



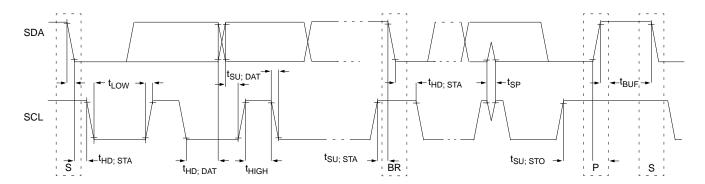


Figure 10-14 Timing Definition for Fast and Standard Mode Devices on the I<sup>2</sup>C Bus

# 10.13 JTAG Timing

**Table 10-18 JTAG Timing** 

Characteristic	Symbol	Min	Max	Unit	See Figure
TCK frequency of operation <sup>1</sup>	f <sub>OP</sub>	DC	SYS_CLK/8	MHz	10-15
TCK clock pulse width	t <sub>PW</sub>	50	_	ns	10-15
TMS, TDI data set-up time	t <sub>DS</sub>	5	_	ns	10-16
TMS, TDI data hold time	t <sub>DH</sub>	5	_	ns	10-16
TCK low to TDO data valid	t <sub>DV</sub>	_	30	ns	10-16
TCK low to TDO tri-state	t <sub>TS</sub>	_	30	ns	10-16

<sup>1.</sup> TCK frequency of operation must be less than 1/8 the processor rate.

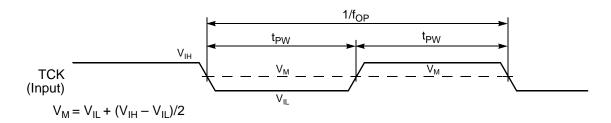


Figure 10-15 Test Clock Input Timing Diagram



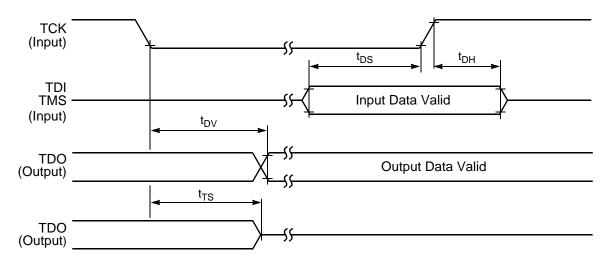


Figure 10-16 Test Access Port Timing Diagram



# 10.14 Analog-to-Digital Converter (ADC) Parameters

### Table 10-19 ADC Parameters<sup>1</sup>

Parameter	Symbol	Min	Тур	Max	Unit
DC Specifications					1
Resolution	R <sub>ES</sub>	12	_	12	Bits
ADC internal clock	f <sub>ADIC</sub>	0.1		5.33	MHz
Conversion range	R <sub>AD</sub>	V <sub>REFL</sub>	_	V <sub>REFH</sub>	V
ADC power-up time <sup>2</sup>	t <sub>ADPU</sub>	_	6	13	t <sub>AIC</sub> cycles <sup>3</sup>
Recovery from auto standby	t <sub>REC</sub>	_	0	1	t <sub>AIC</sub> cycles <sup>3</sup>
Conversion time	t <sub>ADC</sub>	_	6	_	t <sub>AIC</sub> cycles <sup>3</sup>
Sample time	t <sub>ADS</sub>	_	1	_	t <sub>AIC</sub> cycles <sup>3</sup>
Accuracy		1		1	
Integral non-linearity <sup>4</sup> (Full input signal range)	INL	_	+/- 3	+/- 5	LSB <sup>5</sup>
Differential non-linearity	DNL	_	+/6	+/- 1	LSB <sup>5</sup>
Monotonicity			GUARANTEED	1	
Offset Voltage Internal Ref	V <sub>OFFSET</sub>	_	+/- 4	+/- 9	mV
Offset Voltage External Ref	V <sub>OFFSET</sub>	_	+/- 6	+/- 12	mV
Gain Error (transfer gain)	E <sub>GAIN</sub>	_	.998 to 1.002	1.01 to .99	_
ADC Inputs <sup>6</sup> (Pin Group 3)	-			1	1
Input voltage (external reference)	$V_{ADIN}$	V <sub>REFL</sub>	_	V <sub>REFH</sub>	V
Input voltage (internal reference)	$V_{ADIN}$	V <sub>SSA</sub>		$V_{DDA}$	V
Input leakage	I <sub>IA</sub>	_	0	+/- 2	μΑ
V <sub>REFH</sub> current	I <sub>VREFH</sub>	_	0	_	μΑ
Input injection current <sup>7</sup> , per pin	I <sub>ADI</sub>	_	_	3	mA
Input capacitance	C <sub>ADI</sub>	_	See Figure 10-17	_	pF
Input impedance	X <sub>IN</sub>	_	See Figure 10-17	_	Ohms
AC Specifications				1	ı
Signal-to-noise ratio	SNR	60	65		dB
Total Harmonic Distortion	THD	60	64		dB
Spurious Free Dynamic Range	SFDR	61	66		dB
Signal-to-noise plus distortion	SINAD	58	62		dB
Effective Number Of Bits	ENOB	_	10.0		Bits

<sup>1.</sup> All measurements were made at  $V_{DD} = 3.3V$ ,  $V_{REFH} = 3.3V$ , and  $V_{REFL} = ground$ 

<sup>2.</sup> Includes power-up of ADC and  $\,V_{REF}\,$ 

<sup>3.</sup> ADC clock cycles

<sup>4.</sup> INL measured from  $V_{IN} = V_{REFL}$  to  $V_{IN} = V_{REFH}$ 



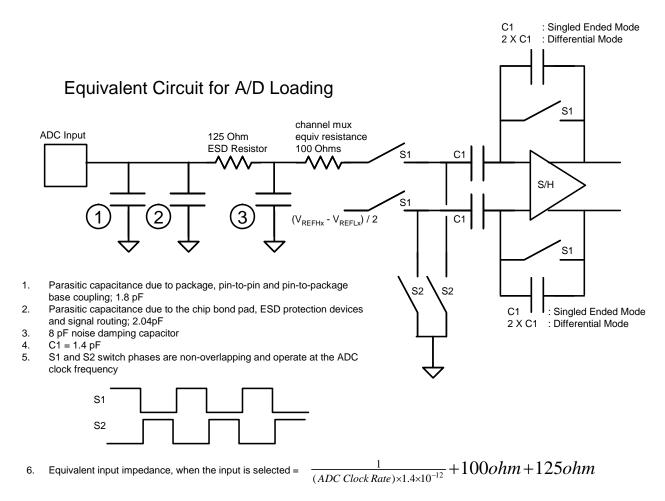
- 5. LSB = Least Significant Bit = 0.806mV
- 6. Pin groups are detailed following Table 10-1.
- The current that can be injected or sourced from an unselected ADC signal input without impacting the performance of the ADC.

## 10.15 Equivalent Circuit for ADC Inputs

**Figure 10-17** illustrates the ADC input circuit during sample and hold. S1 and S2 are always open/closed at the same time that S3 is closed/open. When S1/S2 are closed & S3 is open, one input of the sample and hold circuit moves to (V<sub>REFH</sub>-V<sub>REFL</sub>)/2, while the other charges to the analog input voltage. When the switches are flipped, the charge on C1 and C2 are averaged via S3, with the result that a single-ended analog input is switched to a differential voltage centered about (V<sub>REFH</sub>-V<sub>REFL</sub>)/2. The switches switch on every cycle of the ADC clock (open one-half ADC clock, closed one-half ADC clock). Note that there are additional capacitances associated with the analog input pad, routing, etc., but these do not filter into the S/H output voltage, as S1 provides isolation during the charge-sharing phase.

One aspect of this circuit is that there is an on-going input current, which is a function of the analog input voltage,  $V_{REF}$  and the ADC clock frequency.





- 1. Parasitic capacitance due to package, pin-to-pin and pin-to-package base coupling; 1.8pF
- 2. Parasitic capacitance due to the chip bond pad, ESD protection devices and signal routing; 2.04pF
- 3. Equivalent resistance for the channel select mux; 100 ohms
- 4. Sampling capacitor at the sample and hold circuit. Capacitor C1 is normally disconnected from the input and is only connected to it at sampling time; 1.4pf
- 5. Equivalent input impedance, when the the input is selected =  $\frac{1}{\text{(ADC Clock Rate)} \times 1.4 \times 10^{-12}}$

Figure 10-17 Equivalent Circuit for A/D Loading

### 10.16 Power Consumption

See Section 10.1 for a list of IDD requirements for the 56F8014. This section provides additional detail which can be used to optimize power consumption for a given application.

Power consumption is given by the following equation:

Total power = A: internal [static component]

+B: internal [state-dependent component]
Please see http://www.freescale.com for the most current mechanical drawing.



+C: internal [dynamic component]

+D: external [dynamic component]

+E: external [static]

A, the internal [static component], is comprised of the DC bias currents for the oscillator, leakage currents, PLL, and voltage references. These sources operate independently of processor state or operating frequency.

B, the internal [state-dependent component], reflects the supply current required by certain on-chip resources only when those resources are in use. These include RAM, Flash memory and the ADCs.

C, the internal [dynamic component], is classic C\*V<sup>2</sup>\*F CMOS power dissipation corresponding to the 56800E core and standard cell logic.

D, the external [dynamic component], reflects power dissipated on-chip as a result of capacitive loading on the external pins of the chip. This is also commonly described as  $C*V^2*F$ , although simulations on two of the I/O cell types used on the 56800E reveal that the power-versus-load curve does have a non-zero Y-intercept.

 Intercept
 Slope

 8mA drive
 1.3
 0.11mW / pF

1.15mW

0.11mW/pF

Table 10-20 I/O Loading Coefficients at 10MHz

Power due to capacitive loading on output pins is (first order) a function of the capacitive load and frequency at which the outputs change. **Table 10-20** provides coefficients for calculating power dissipated in the I/O cells as a function of capacitive load. In these cases:

 $TotalPower = \Sigma((Intercept + Slope*Cload)*frequency/10MHz)$ 

### where:

• Summation is performed over all output pins with capacitive loads

4mA drive

- TotalPower is expressed in mW
- Cload is expressed in pF

Because of the low duty cycle on most device pins, power dissipation due to capacitive loads was found to be fairly low when averaged over a period of time.

E, the external [static component], reflects the effects of placing resistive loads on the outputs of the device. Sum the total of all  $V^2/R$  or IV to arrive at the resistive load contribution to power. Assume V=0.5 for the purposes of these rough calculations. For instance, if there is a total of eight PWM outputs driving 10mA into LEDs, then P=8\*.5\*.01=40mW.



In previous discussions, power consumption due to parasitics associated with pure input pins is ignored, as it is assumed to be negligible.



## Part 11 Packaging

## 11.1 56F8014 Package and Pin-Out Information

This section contains package and pin-out information for the 56F8014. This device comes in a 32-pin Low-profile Quad Flat Pack (LQFP). **Figure 11-1** shows the package outline for the 32-pin LQFP, **Figure 11-2** shows the mechanical parameters for this package, and **Table 11-1** lists the pin-out for the 32-pin LQFP.

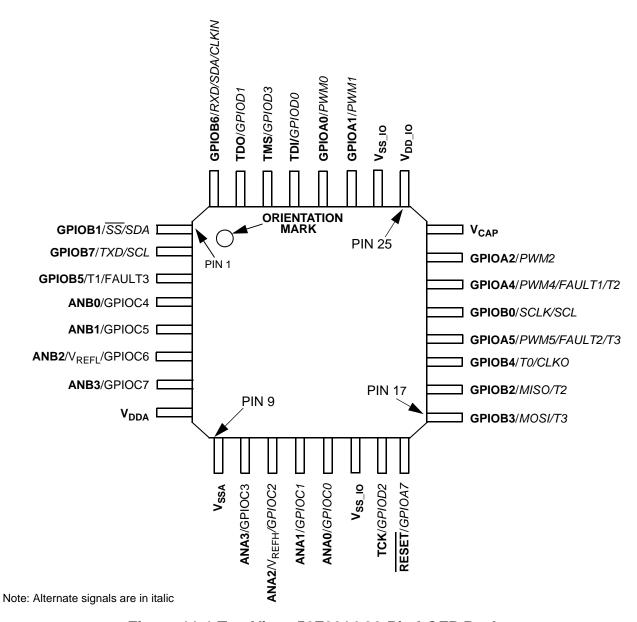


Figure 11-1 Top View, 56F8014 32-Pin LQFP Package

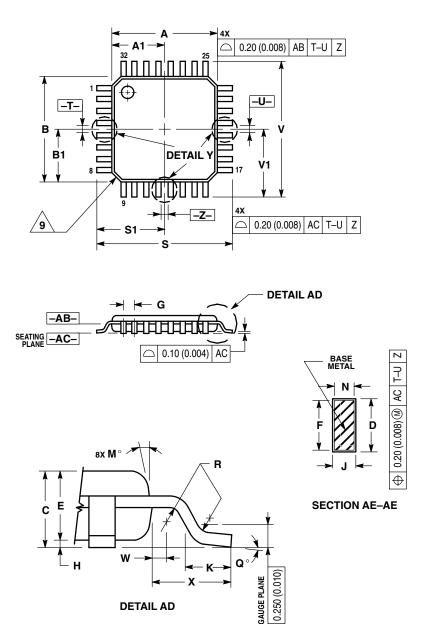


## Table 11-1 56F8014 32-Pin LQFP Package Identification by Pin Number<sup>1</sup>

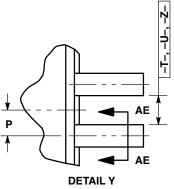
Pin No.	Signal Name	Pin No.	Signal Name	Pin No.	Signal Name	Pin No.	Signal Name
1	GPIOB1 SS,SDA	9	V <sub>SSA</sub>	17	GPIOB3 MOSI,T3	25	$V_{\mathrm{DD\_IO}}$
2	GPIOB7 TXD,SCL	10	ANA3 GPIOC3	18	GPIOB2 MISO,T2	26	V <sub>SS_IO</sub>
3	GPIOB5 T1,FAULT3	11	ANA2 V <sub>REFH</sub> ,GPIOC2	19	<b>GPIOB4</b> T0,CLKO	27	GPIOA1 PWM1
4	ANB0 GPIOC4	12	ANA1 GPIOC1	20	<b>GPIOA5</b> <i>PWM5,FAULT2,T3</i>	28	GPIOA0 PWM0
5	ANB1 GPIOC5	13	ANA0 GPIOC0	21	GPIOB0 SCLK/,CL	29	<b>TDI</b> GPIOD0
6	ANB2 V <sub>REFL</sub> ,GPIOC6	14	V <sub>SS_IO</sub>	22	<b>GPIOA4</b> <i>PWM4/FAULT1/T</i> 2	30	TMS GPIOD3
7	ANB3 GPIOC7	15	TCK GPIOD2	23	GPIOA2 PWM2	31	TDO GPIOD1
8	V <sub>DDA</sub>	16	RESET GPIOA7	24	V <sub>CAP</sub>	32	GPIOB6 RXD,SDA,CLKIN

<sup>1.</sup>Alternate signals are in iltalic





**DETAIL AD** 



#### NOTES:

- DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
- 114-3M, 1902.

  CONTROLLING DIMENSION: MILLIMETER.

  DATUM PLANE -AB- IS LOCATED AT BOTTOM
  OF LEAD AND IS COINCIDENT WITH THE LEAD
  WHERE THE LEAD EXTIS THE PLASTIC BODY AT THE BOTTOM OF THE PARTING LINE.
- 4. DATUMS –T–, –U–, AND –Z– TO BE DETERMINED AT DATUM PLANE –AB–.
- AT DATOM PLANE AD-.

  5 DIMENSIONS S AND V TO BE DETERMINED AT SEATING PLANE AC-.

  6. DIMENSIONS A AND B DO NOT INCLUDE MOLD PROTRUSION. ALLOWABLE PROTRUSION IS 0.250 (0.010) PER SIDE. DIMENSIONS A AND B DO INCLUDE MOLD MISMATCH AND ARE DETERMINED AT DATUM PLANE -AB-.
  DIMENSION D DOES NOT INCLUDE DAMBAR
- PROTRUSION. DAMBAR PROTRUSION SHALL NOT CAUSE THE D DIMENSION TO EXCEED 0.520 (0.020).

  8. MINIMUM SOLDER PLATE THICKNESS SHALL BE
- 0.0076 (0.0003).

  9. EXACT SHAPE OF EACH CORNER MAY VARY
- FROM DEPICTION.

	MILLIN	IETERS	INC	HES	
DIM	MIN	MAX	MIN	MAX	
Α	7.000	BSC	0.276	BSC	
A1	3.500	BSC	0.138	BSC	
В	7.000	BSC	0.276	BSC	
B1	3.500	BSC	0.138 BSC		
С	1.400	1.600	0.055	0.063	
D	0.300	0.450	0.012	0.018	
E	1.350	1.450	0.053	0.057	
F	0.300	0.400	0.012	0.016	
G	0.800 BSC		0.031	BSC	
Н	0.050	0.150	0.002	0.006	
J	0.090	0.200	0.004	0.008	
K	0.500	0.700	0.020	0.028	
M	12°	REF	12°	REF	
N	0.090	0.160	0.004	0.006	
Р	0.400		0.016		
Q	1°	5°	1°	5°	
R	0.150	0.250	0.006	0.010	
S	9.000	BSC	0.354	BSC	
S1	4.500	BSC	0.177 BSC		
٧	9.000	BSC	0.354	BSC	
V1	4.500	BSC	0.177	BSC	
W	0.200	REF	0.008	REF	
X	1.000	REF	0.039	REF	

Figure 11-2 56F8014 32-Pin LQFP Mechanical Information



## Part 12 Design Considerations

## 12.1 Thermal Design Considerations

An estimation of the chip junction temperature, T<sub>I</sub>, can be obtained from the equation:

$$T_J = T_A + (R_{\theta JA} \times P_D)$$

where

 $T_A$  = Ambient temperature for the package ( ${}^{0}C$ )

 $R_{\theta,JA}$  = Junction-to-ambient thermal resistance ( ${}^{\circ}C/W$ )

 $P_D$  = Power dissipation in the package (W)

The junction-to-ambient thermal resistance is an industry-standard value that provides a quick and easy estimation of thermal performance. Unfortunately, there are two values in common usage: the value determined on a single-layer board and the value obtained on a board with two planes. For packages such as the PBGA, these values can be different by a factor of two. Which value is closer to the application depends on the power dissipated by other components on the board. The value obtained on a single layer board is appropriate for the tightly packed printed circuit board. The value obtained on the board with the internal planes is usually appropriate if the board has low-power dissipation and the components are well separated.

When a heat sink is used, the thermal resistance is expressed as the sum of a junction-to-case thermal resistance and a case-to-ambient thermal resistance:

$$R_{\theta JA} = R_{\theta JC} + R_{\theta CA}$$
 where

 $R_{\theta JA} = Package junction-to-ambient thermal resistance (°C/W)$   $R_{\theta JC} = Package junction-to-case thermal resistance (°C/W)$   $R_{\theta CA} = Package case-to-ambient thermal resistance (°C/W)$ 

 $R_{\theta JC}$  is device related and cannot be influenced by the user. The user controls the thermal environment to change the case to ambient thermal resistance,  $R_{\theta CA}$ . For instance, the user can change the size of the heat sink, the air flow around the device, the interface material, the mounting arrangement on printed circuit board, or change the thermal dissipation on the printed circuit board surrounding the device.

To determine the junction temperature of the device in the application when heat sinks are not used, the Thermal Characterization Parameter ( $\Psi_{JT}$ ) can be used to determine the junction temperature with a measurement of the temperature at the top center of the package case using the following equation:

$$T_J = T_T + (\Psi_{JT} \times P_D)$$
 where

 $T_T$  = Thermocouple temperature on top of package ( $^{o}$ C)



 $\Psi_{IT}$  = Thermal characterization parameter ( ${}^{\circ}C/W$ )

 $P_D$  = Power dissipation in package (W)

The thermal characterization parameter is measured per JESD51-2 specification using a 40-gauge type T thermocouple epoxied to the top center of the package case. The thermocouple should be positioned so that the thermocouple junction rests on the package. A small amount of epoxy is placed over the thermocouple junction and over about 1mm of wire extending from the junction. The thermocouple wire is placed flat against the package case to avoid measurement errors caused by cooling effects of the thermocouple wire.

When heat sink is used, the junction temperature is determined from a thermocouple inserted at the interface between the case of the package and the interface material. A clearance slot or hole is normally required in the heat sink. Minimizing the size of the clearance is important to minimize the change in thermal performance caused by removing part of the thermal interface to the heat sink. Because of the experimental difficulties with this technique, many engineers measure the heat sink temperature and then back-calculate the case temperature using a separate measurement of the thermal resistance of the interface. From this case temperature, the junction temperature is determined from the junction-to-case thermal resistance.

## 12.2 Electrical Design Considerations

### **CAUTION**

This device contains protective circuitry to guard against damage due to high static voltage or electrical fields. However, normal precautions are advised to avoid application of any voltages higher than maximum-rated voltages to this high-impedance circuit. Reliability of operation is enhanced if unused inputs are tied to an appropriate voltage level.

Use the following list of considerations to assure correct operation of the 56F8014:

- Provide a low-impedance path from the board power supply to each  $V_{DD}$  pin on the 56F8014 and from the board ground to each  $V_{SS}$  (GND) pin
- The minimum bypass requirement is to place  $0.01-0.1\mu F$  capacitors positioned as close as possible to the package supply pins. The recommended bypass configuration is to place one bypass capacitor on each of the  $V_{DD}/V_{SS}$  pairs, including  $V_{DDA}/V_{SSA}$ . Ceramic and tantalum capacitors tend to provide better tolerances
- Ensure that capacitor leads and associated printed circuit traces that connect to the chip V<sub>DD</sub> and V<sub>SS</sub> (GND)
  pins are as short as possible
- Bypass the  $V_{DD}$  and  $V_{SS}$  with approximately 100 $\mu$ F, plus the number of 0.1 $\mu$ F ceramic capacitors



- PCB trace lengths should be minimal for high-frequency signals
- Consider all device loads as well as parasitic capacitance due to PCB traces when calculating capacitance.
   This is especially critical in systems with higher capacitive loads that could create higher transient currents in the V<sub>DD</sub> and V<sub>SS</sub> circuits.
- Take special care to minimize noise levels on the V<sub>REF</sub>, V<sub>DDA</sub> and V<sub>SSA</sub> pins
- Using separate power planes for  $V_{DD}$  and  $V_{DDA}$  and separate ground planes for  $V_{SS}$  and  $V_{SSA}$  is recommended. Connect the separate analog and digital power and ground planes as close as possible to power supply outputs. If both analog circuit and digital circuit are powered by the same power supply, it is advisable to connect a small inductor or ferrite bead in serial with both  $V_{DDA}$  and  $V_{SSA}$  traces.
- It is highly desirable to physically separate analog components from noisy digital components by ground planes. Do not place an analog trace in parallel with digital traces. It is also desirable to place an analog ground trace around an analog signal trace to isolate it from digital traces.
- Because the Flash memory is programmed through the JTAG/EOnCE port, SPI, SCI or I<sup>2</sup>C, the designer should provide an interface to this port if in-circuit Flash programming is desired.



# **Part 13 Ordering Information**

**Table 13-1** lists the pertinent information needed to place an order. Consult a Freescale Semiconductor sales office or authorized distributor to determine availability and to order parts.

Table 13-1 56F8014 Ordering Information

Part	Supply Voltage	Package Type	Pin Count	Frequency (MHz)	Abient Temperature Range	Order Number
MC56F8014	3.0–3.6 V	Low-Profile Quad Flat Pack (LQFP)	32	32	-40° to + 105° C	MC56F8014VFAE*
MC56F8014	3.0–3.6 V	Low-Profile Quad Flat Pack (LQFP)	32	32	−40° to +125 °C	MC56F8014MFAE*

<sup>\*</sup>This package is RoHS compliant.

# Part 14 Appendix

Register acronyms are revised from previous device data sheets to provide a cleaner register description. A cross reference to legacy and revised acronyms are provided in the following table.

	Register Name	Peripheral Re	Peripheral Reference Manual		Sheet	Processor	Memory	Memory Address	
Module		New Acronym	Legacy Acronym	New Acronym	Legacy Acronym	Expert Acronym	Start	End	
ADC	Control Register 1	CTRL1	ADCR1	ADC_CTRL1	ADC_ADCR1	ADC_ADCR1	0xF	0xF080	
	Control Register 2	CTRL2	ADCR2	ADC_CTRL2	ADC_ADCR2	ADC_ADCR2	0xF	0xF081	
	Zero Crossing Control Register	ZXCTRL	ADZCC	ADC_ZXCTRL	ADC_ADZCC	ADC_ADZCC	0xF	082	
	Channel List Register 1	CLIST1	ADLST1	ADC_CLIST1	ADC_ADLST1	ADC_ADLST1	0xF	-083	
	Channel List Register 2	CLIST2	ADLST2	ADC_CLIST2	ADC_ADLST2	ADC_ADLST2	0xF	-084	
	Sample Disable Register	SDIS	ADSDIS	ADC_SDIS	ADC_ADSDIS	ADC_ADSDIS	0xF	0xF085	
	Status Register	STAT	ADSTAT	ADC_STAT	ADC_ADSTAT	ADC_ADSTAT	0xF	0xF086	
	Limit Status Register	LIMSTAT	ADLSTAT	ADC_LIMSTAT	ADC_ADLSTAT	ADC_ADLSTAT	0xF	0xF087	
	Zero Crossing Status Register	ZXSTAT	ADZCSTAT	ADC_ZXSTAT	ADC_ADZCSTAT	ADC_ADZCSTAT	0xF088		
	Result Registers 0-7	RSLT0-7	ADRSLT0-7	ADC_RSLT0-7	ADC_ADRSLT0-7	ADC_ADRSLT0-7	0xF089	0XF090	
	Low Limit Registers 0-7	LOLIM0-7	ADLLMT0-7	ADC_LOLIM0-7	ADC_ADLLMT0-7	ADC_ADLLMT0-7	0XF091	0XF098	
	High Limit Registers 0-7	HILIM0-7	ADHLMT0-7	ADC_HILIM0-7	ADC_ADHLMT0-7	ADC_ADHLMT0-7	0XF099	0XF0A0	
	Offset Registers 0-7	OFFST0-7	ADOFS0-7	ADC_OFFST0-7	ADC_ADOFS0-7	ADC_ADOFS0-7	0XF0A1	0XF0A8	
	Power Control Register	PWR	ADPOWER	ADC_PWR	ADC_ADPOWER	ADC_ADPOWER	0XF	-0A9	
	Voltage Reference Register	CAL	ADCAL	ADC_VREF	ADC_ADCAL	ADC_CAL	0XF	OAA	
							•		
COP	Control Register	CTRL	COPCTL	COP_CTRL	COPCTL	COPCTL	0XF	-0E0	
	Time-Out Register	TOUT	COPTO	COP_TOUT	COPTO	COPTO	0XF0E1		
	Counter Register	CNTR	COPCTR	COP_CNTR	COPCTR	COPCTR	0XF0E2		



### How to Reach Us:

### Home Page:

www.freescale.com

#### E-mail:

support@freescale.com

### **USA/Europe or Locations Not Listed:**

Freescale Semiconductor Technical Information Center, CH370 1300 N. Alma School Road Chandler, Arizona 85224 +1-800-521-6274 or +1-480-768-2130 support@freescale.com

### Europe, Middle East, and Africa:

Freescale Halbleiter Deutschland GmbH Technical Information Center Schatzbogen 7 81829 Muenchen, Germany +44 1296 380 456 (English) +46 8 52200080 (English) +49 89 92103 559 (German) +33 1 69 35 48 48 (French) support@freescale.com

#### Japan:

Freescale Semiconductor Japan Ltd. Headquarters ARCO Tower 15F 1-8-1, Shimo-Meguro, Meguro-ku, Tokyo 153-0064, Japan 0120 191014 or +81 3 5437 9125 support.japan@freescale.com

#### Asia/Pacific:

Freescale Semiconductor Hong Kong Ltd.
Technical Information Center
2 Dai King Street
Tai Po Industrial Estate
Tai Po, N.T., Hong Kong
+800 2666 8080
support.asia@freescale.com

### For Literature Requests Only:

Freescale Semiconductor Literature Distribution Center P.O. Box 5405
Denver, Colorado 80217
1-800-441-2447 or 303-675-2140
Fax: 303-675-2150
LDCForFreescaleSemiconductor@hibbertgroup.com

RoHS-compliant and/or Pb-free versions of Freescale products have the functionality and electrical characteristics of their non-RoHS-compliant and/or non-Pb-free counterparts. For further information, see <a href="http://www.freescale.com">http://www.freescale.com</a> or contact your Freescale sales representative.

For information on Freescale's Environmental Products program, go to <a href="http://www.freescale.com/epp.">http://www.freescale.com/epp.</a>

Information in this document is provided solely to enable system and software implementers to use Freescale Semiconductor products. There are no express or implied copyright licenses granted hereunder to design or fabricate any integrated circuits or integrated circuits based on the information in this document.

Freescale Semiconductor reserves the right to make changes without further notice to any products herein. Freescale Semiconductor makes no warranty. representation or guarantee regarding the suitability of its products for any particular purpose, nor does Freescale Semiconductor assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation consequential or incidental damages. "Typical" parameters that may be provided in Freescale Semiconductor data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals", must be validated for each customer application by customer's technical experts. Freescale Semiconductor does not convey any license under its patent rights nor the rights of others. Freescale Semiconductor products are not designed, intended, or authorized for use as components in systems intended for surgical implant into the body, or other applications intended to support or sustain life, or for any other application in which the failure of the Freescale Semiconductor product could create a situation where personal injury or death may occur. Should Buyer purchase or use Freescale Semiconductor products for any such unintended or unauthorized application, Buyer shall indemnify and hold Freescale Semiconductor and its officers, employees, subsidiaries, affiliates, and distributors harmless against all claims, costs, damages, and expenses, and reasonable attorney fees arising out of, directly or indirectly, any claim of personal injury or death associated with such unintended or unauthorized use, even if such claim alleges that Freescale Semiconductor was negligent regarding the design or manufacture of the part.



Freescale™ and the Freescale logo are trademarks of Freescale Semiconductor, Inc. All other product or service names are the property of their respective owners. This product incorporates SuperFlash® technology licensed from SST.

© Freescale Semiconductor, Inc. 2005. All rights reserved.

MC56F8014 Rev. 11 05/2008

### **X-ON Electronics**

Largest Supplier of Electrical and Electronic Components

Click to view similar products for Digital Signal Processors & Controllers - DSP, DSC category:

Click to view products by NXP manufacturer:

Other Similar products are found below:

PIC33FJ32GP104-I/PT ADSP-2189NBCAZ-320 ADSP-BF703BBCZ-3 ADSP-2185MKCAZ-300 ADSP-BF701KBCZ-1 646890G ADSP-BF701KBCZ-2 ADSP-BF703BBCZ-4 0W888-002-XTP ADBF704WCCPZ311 AD21573WCBCZ402 ADSC572WCBCZ302 ADSC572WCBCZ402 ADSC572WCBCZ4202 ADSC572WCBCZ4200 ADSC572WCBCZ400 ADSC573WCBCZ300 ADSC573WCBCZ500 ADSC571WCSWZ300 ADSC571WCSWZ500 ADSC571WCSWZ400 ADSP-21567KBCZ6 ADSP-21567KBCZ8 ADSC570WCSWZ502 AD21488WBCPZ302 AD21488WBCPZ402 ADSC570WCSWZ402 ADSC570WCSWZ402 AD21488WBCPZ402 AD21488WBCPZ402 ADSP-21583KBCZ-4A ADSP-BF701BBCZ-2 ADSP-BF705BBCZ-4 ADSP-SC582BBCZ-4A ADSP-SC584KBCZ-4A ADSP-SC584BBCZ-3A TMS320VC5506ZHH DSPIC33FJ256GP510A-I/PT DSPIC33FJ32GS202-I/M6 DSPIC33FJ32GS202-I/M6 DSPIC33FJ32GS202-I/M6 DSPIC33FJ32GS202-I/M6 DSPIC33FJ32GS202-I/M6 DSPIC33FJ32GS202-I/M6 DSPIC33FJ32GS202-I/M7 DSPIC33FJ32GS2012-30I/ML